

Occupied Bandwidth

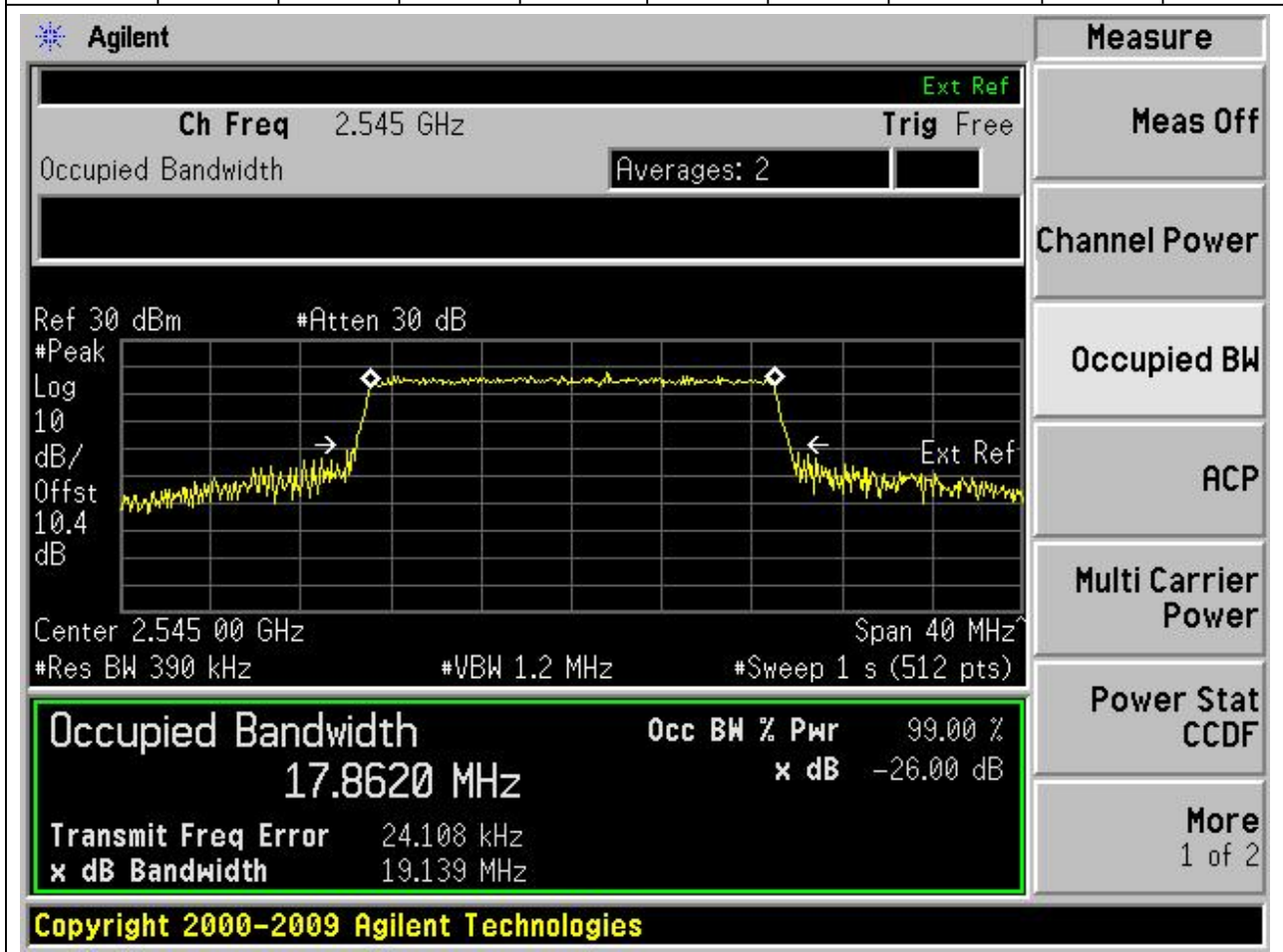
6.19. LTE Occupied Bandwidth_Part22-24-27(Channel:40140, Bandwidth:20, Modulation:QPSK, RB Number:100, RB Position:0)

Operator:

Test time: 2026-01-30

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2545	99	26	0.39	Peak	10.42	17.86	19.14	20	Pass



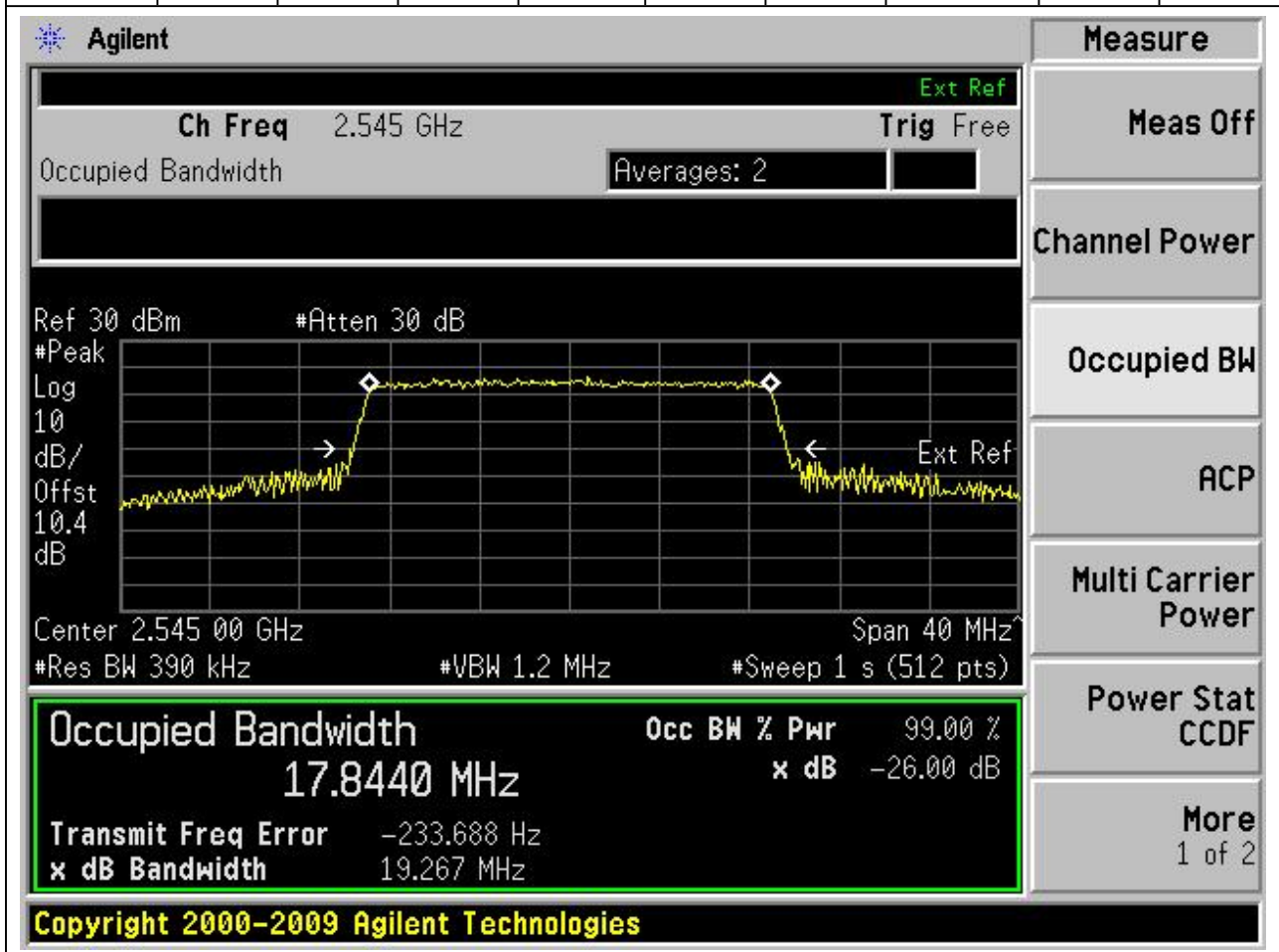
6.20. LTE Occupied Bandwidth_Part22-24-27(Channel:40140, Bandwidth:20, Modulation:16QAM, RB Number:100, RB Position:0)

Operator:

Test time: 2026-01-30

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2545	99	26	0.39	Peak	10.42	17.84	19.27	20	Pass



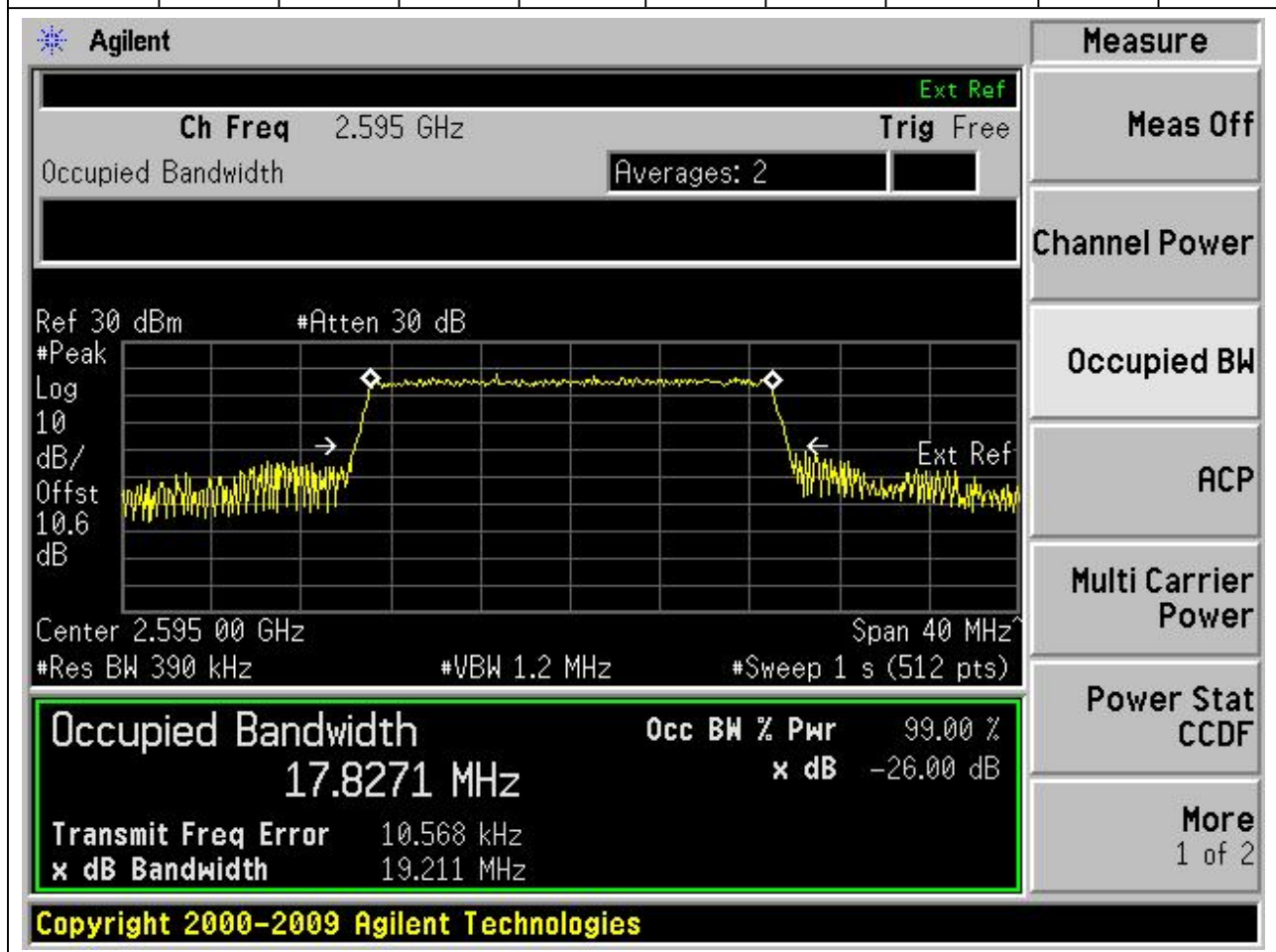
6.21. LTE Occupied Bandwidth_Part22-24-27(Channel:40640, Bandwidth:20, Modulation:QPSK, RB Number:100, RB Position:0)

Operator:

Test time: 2026-01-30

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2595	99	26	0.39	Peak	10.55	17.83	19.21	20	Pass



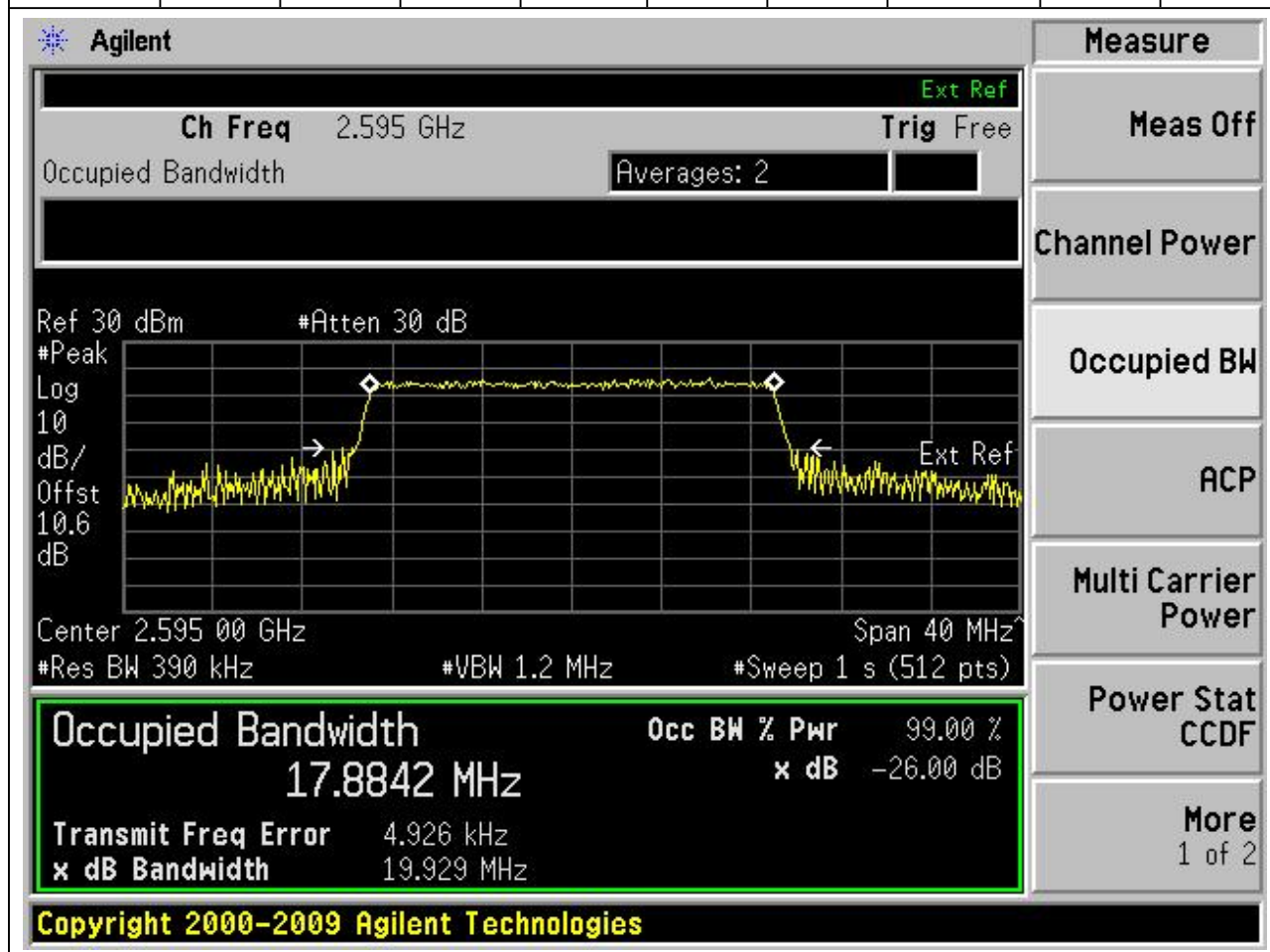
6.22. LTE Occupied Bandwidth_Part22-24-27(Channel:40640, Bandwidth:20, Modulation:16QAM, RB Number:100, RB Position:0)

Operator:

Test time: 2026-01-30

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2595	99	26	0.39	Peak	10.55	17.88	19.93	20	Pass



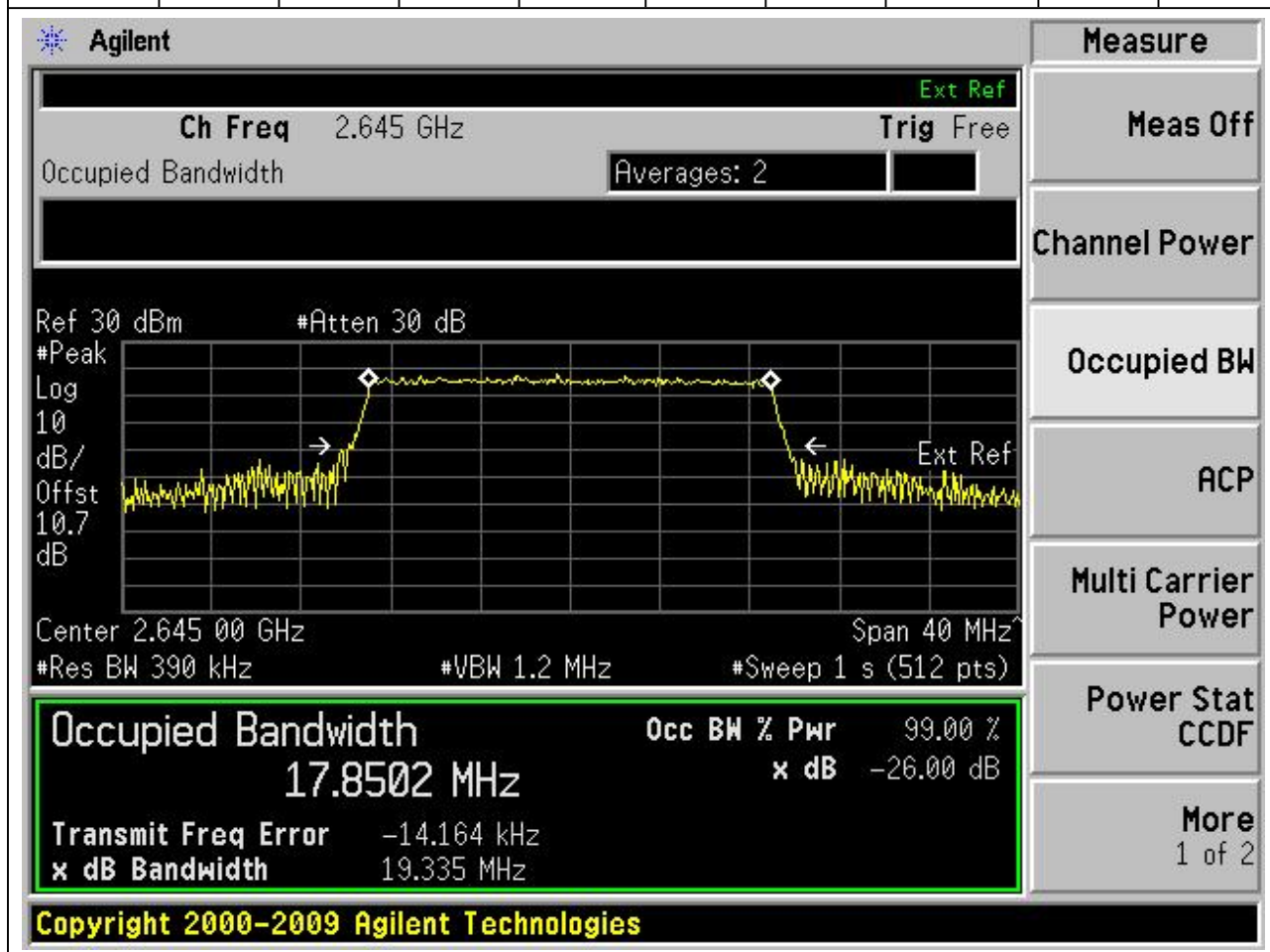
6.23. LTE Occupied Bandwidth_Part22-24-27(Channel:41140, Bandwidth:20, Modulation:QPSK, RB Number:100, RB Position:0)

Operator:

Test time: 2026-01-30

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2645	99	26	0.39	Peak	10.71	17.85	19.34	20	Pass



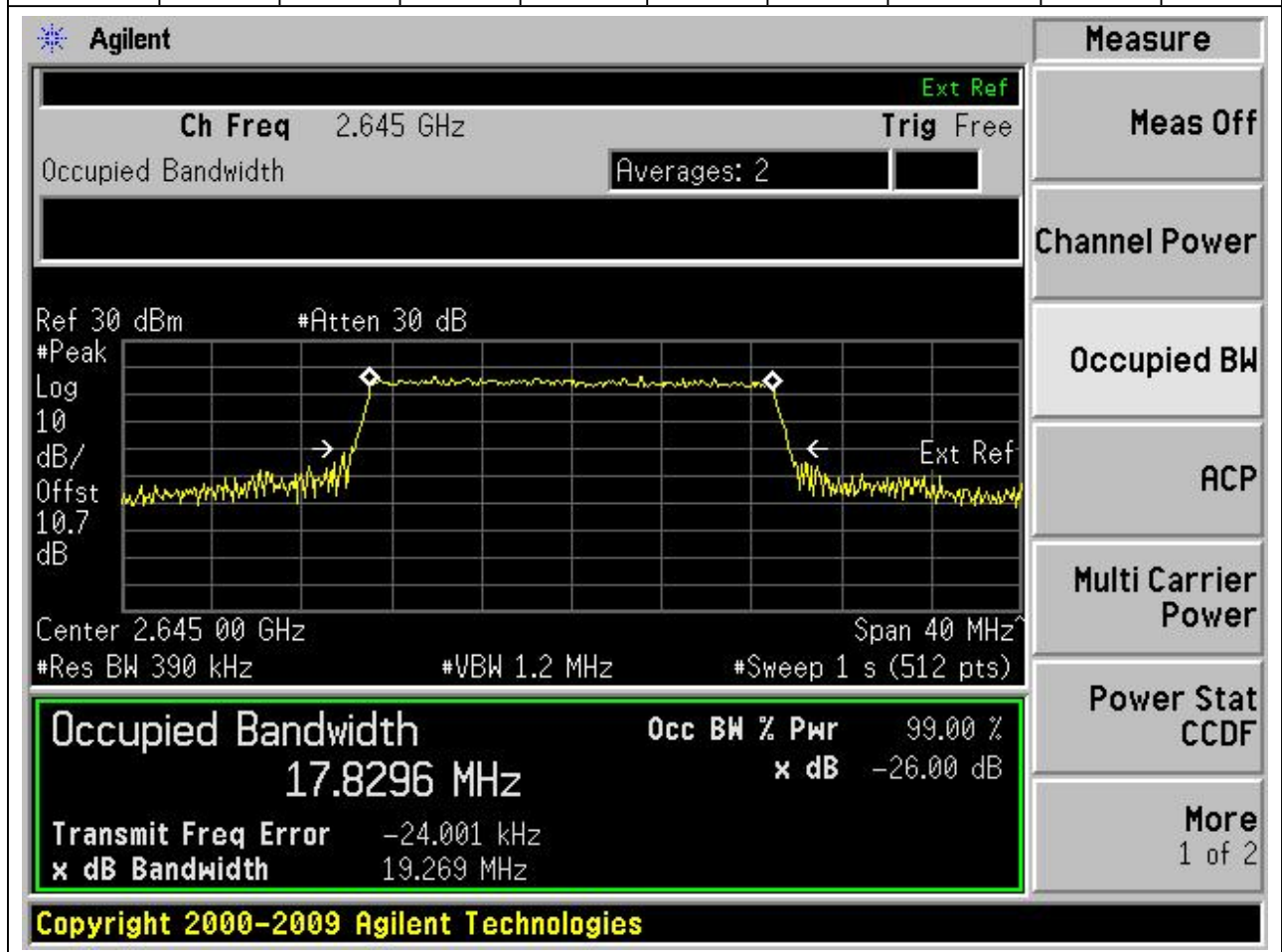
6.24. LTE Occupied Bandwidth_Part22-24-27(Channel:41140, Bandwidth:20, Modulation:16QAM, RB Number:100, RB Position:0)

Operator:

Test time: 2026-01-30

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2645	99	26	0.39	Peak	10.71	17.83	19.27	20	Pass



1. CA_38C

EUT Sample No.:	
EUT Name:	
EUT Manufacturer:	
EUT Model:	
EUT Serial Number:	
EUT Hardware Version:	
EUT Software Version:	
Low Temperature(LT):	-10 °C
Normal Temperature(NT):	+25 °C
High Temperature(HT):	+55 °C
Low Voltage(LV):	3.6 V
Normal Voltage(NV):	3.8 V
High Voltage(HV):	4.2 V

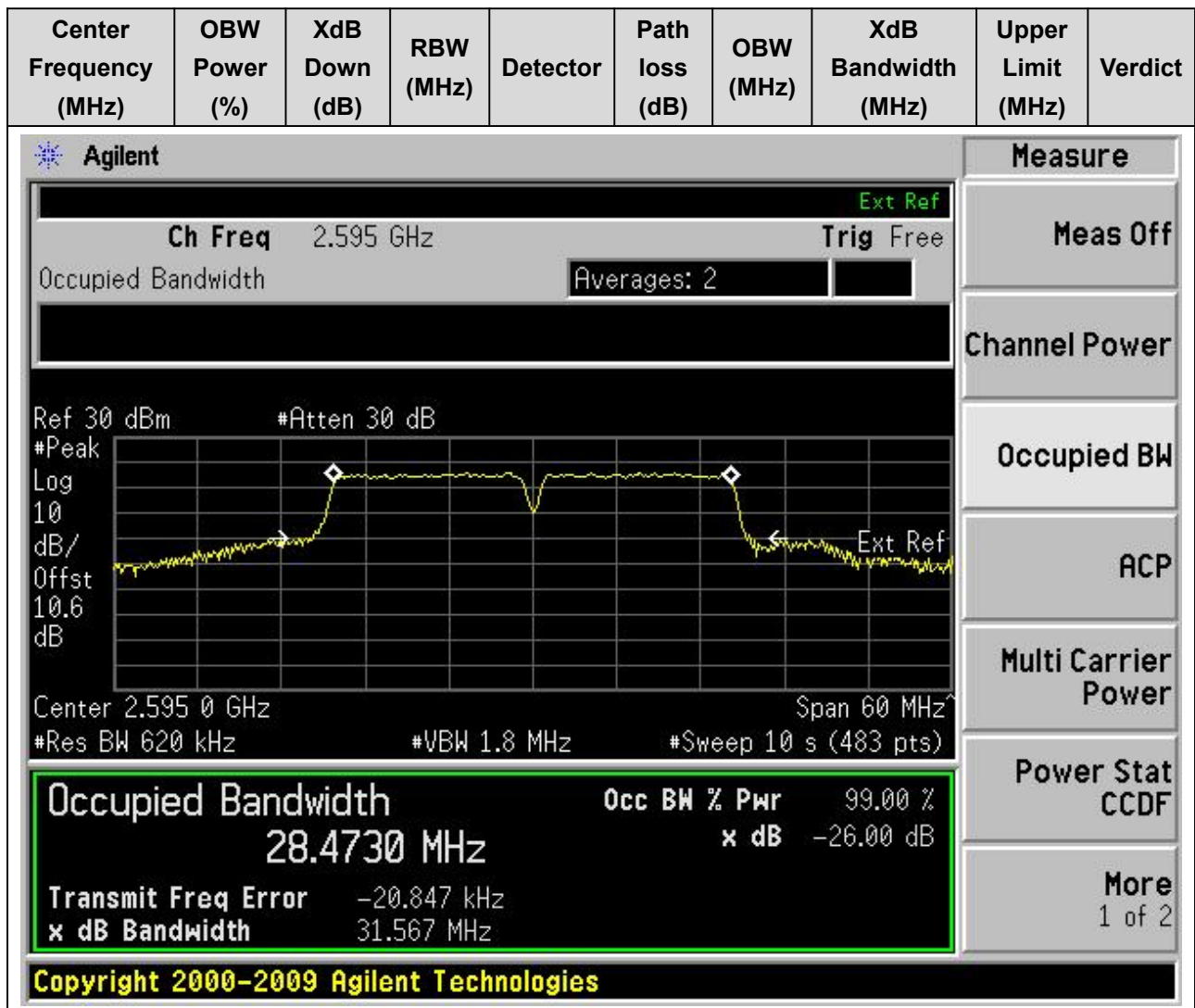
1.1. LTE-A Occupied Bandwidth_Part22-24-27(Channel:37925|38075, Bandwidth:15|15MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-04

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2595	99	26	0.62	Peak	10.55	28.47	31.57	30	Pass



Measure

Meas Off

Channel Power

Occupied BW

ACP

Multi Carrier Power

Power Stat CCDF

More

1 of 2

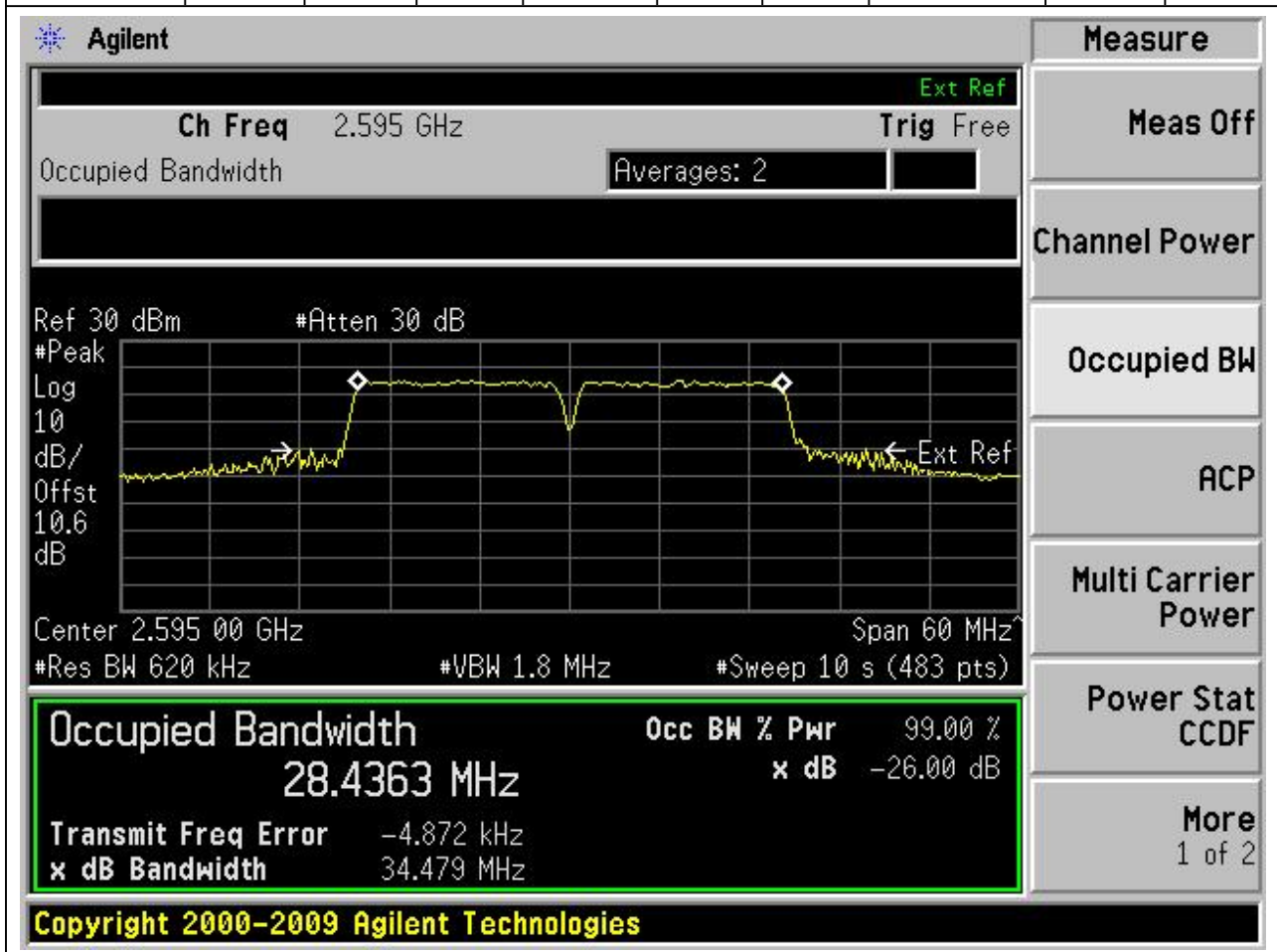
1.2. LTE-A Occupied Bandwidth_Part22-24-27(Channel:37925|38075, Bandwidth:15|15MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-04

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2595	99	26	0.62	Peak	10.55	28.44	34.48	30	Pass



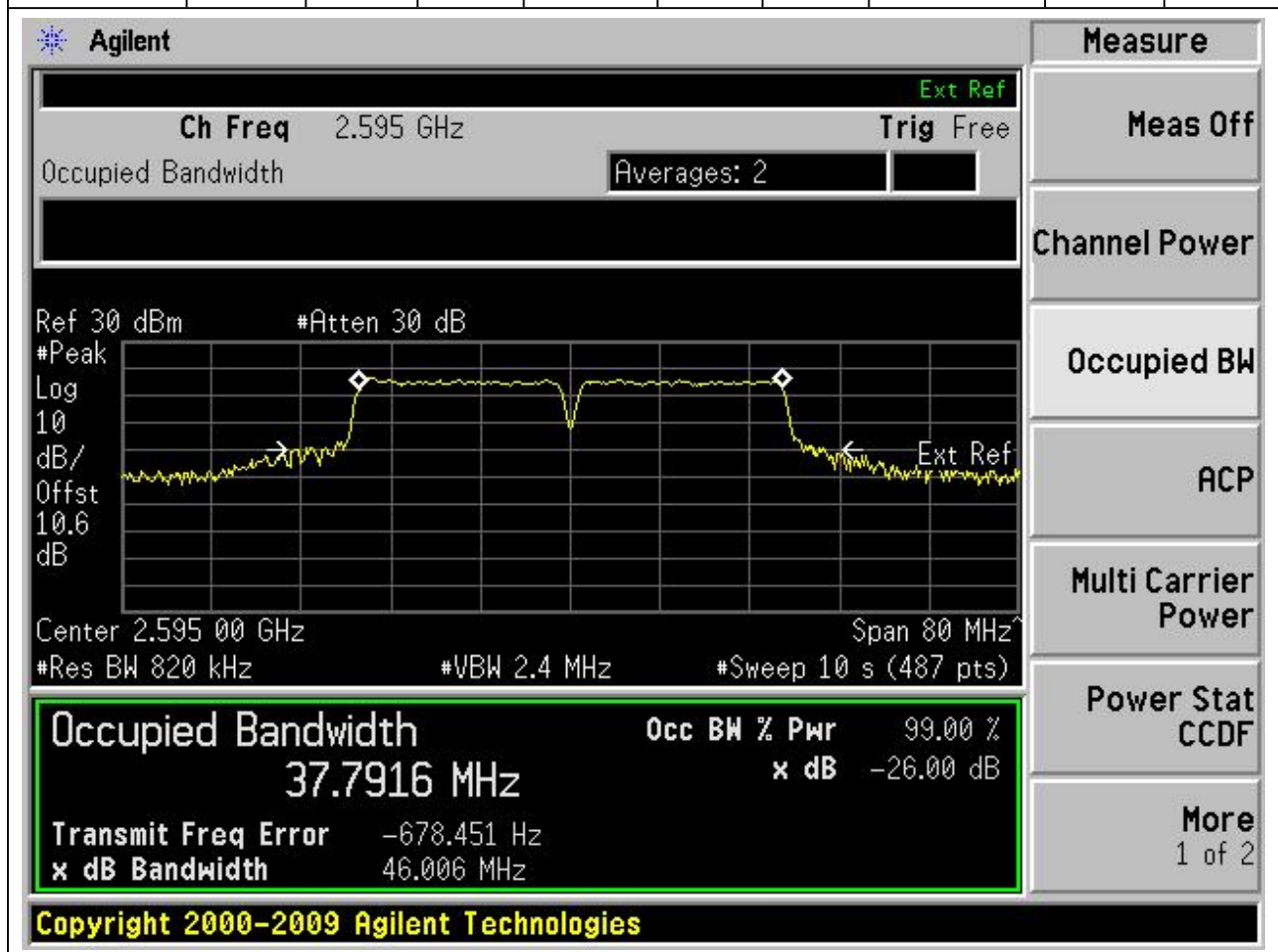
1.3. LTE-A Occupied Bandwidth_Part22-24-27(Channel:37901|38099, Bandwidth:20|20MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-04

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2595	99	26	0.82	Peak	10.55	37.79	46.01	40	Pass



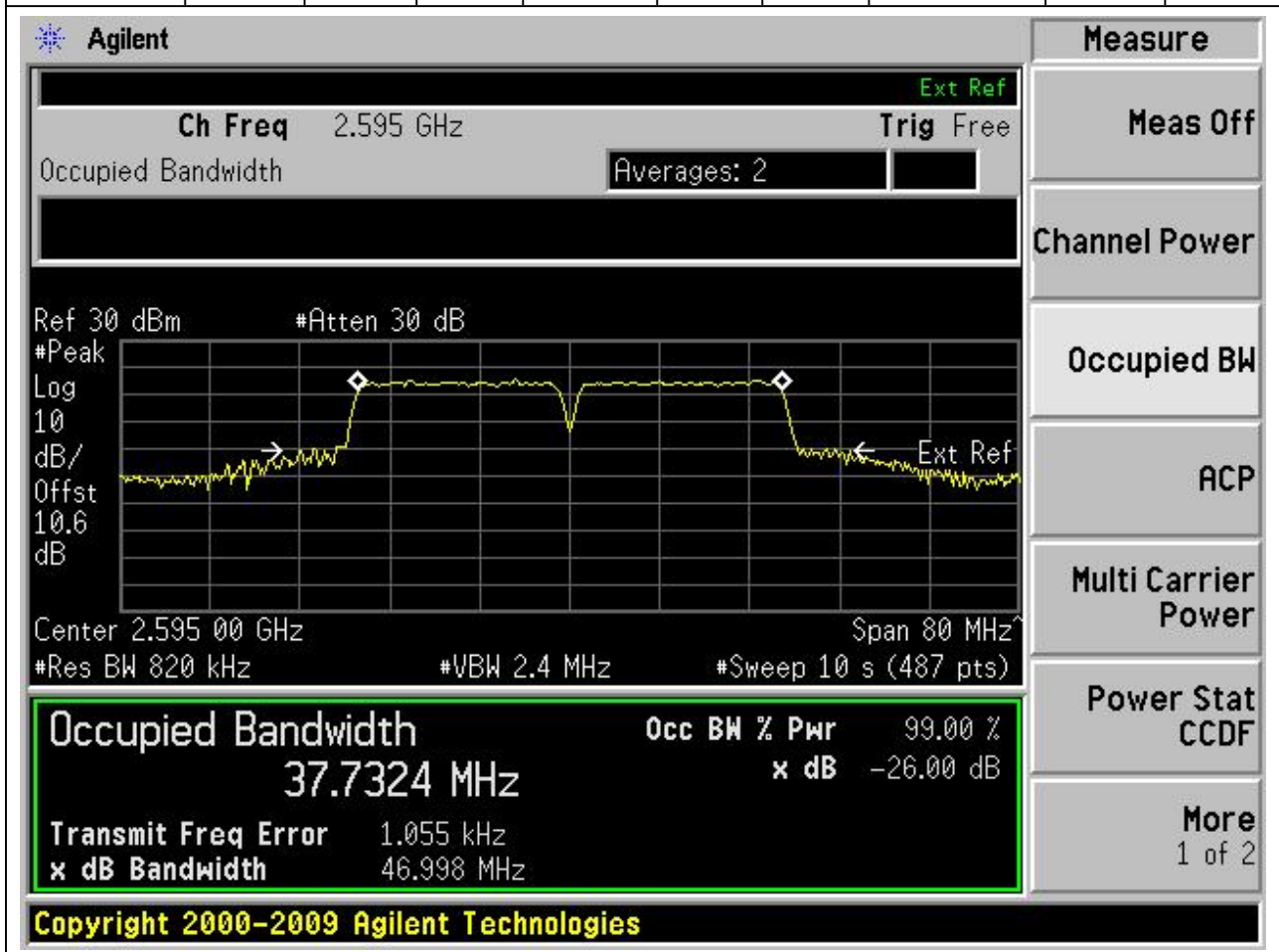
1.4. LTE-A Occupied Bandwidth_Part22-24-27(Channel:37901|38099, Bandwidth:20|20MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-04

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2595	99	26	0.82	Peak	10.55	37.73	47	40	Pass



2. CA_41C_2535-2655

EUT Sample No.:	
EUT Name:	
EUT Manufacturer:	
EUT Model:	
EUT Serial Number:	
EUT Hardware Version:	
EUT Software Version:	
Low Temperature(LT):	-10 °C
Normal Temperature(NT):	+25 °C
High Temperature(HT):	+55 °C
Low Voltage(LV):	3.6 V
Normal Voltage(NV):	3.8 V
High Voltage(HV):	4.2 V

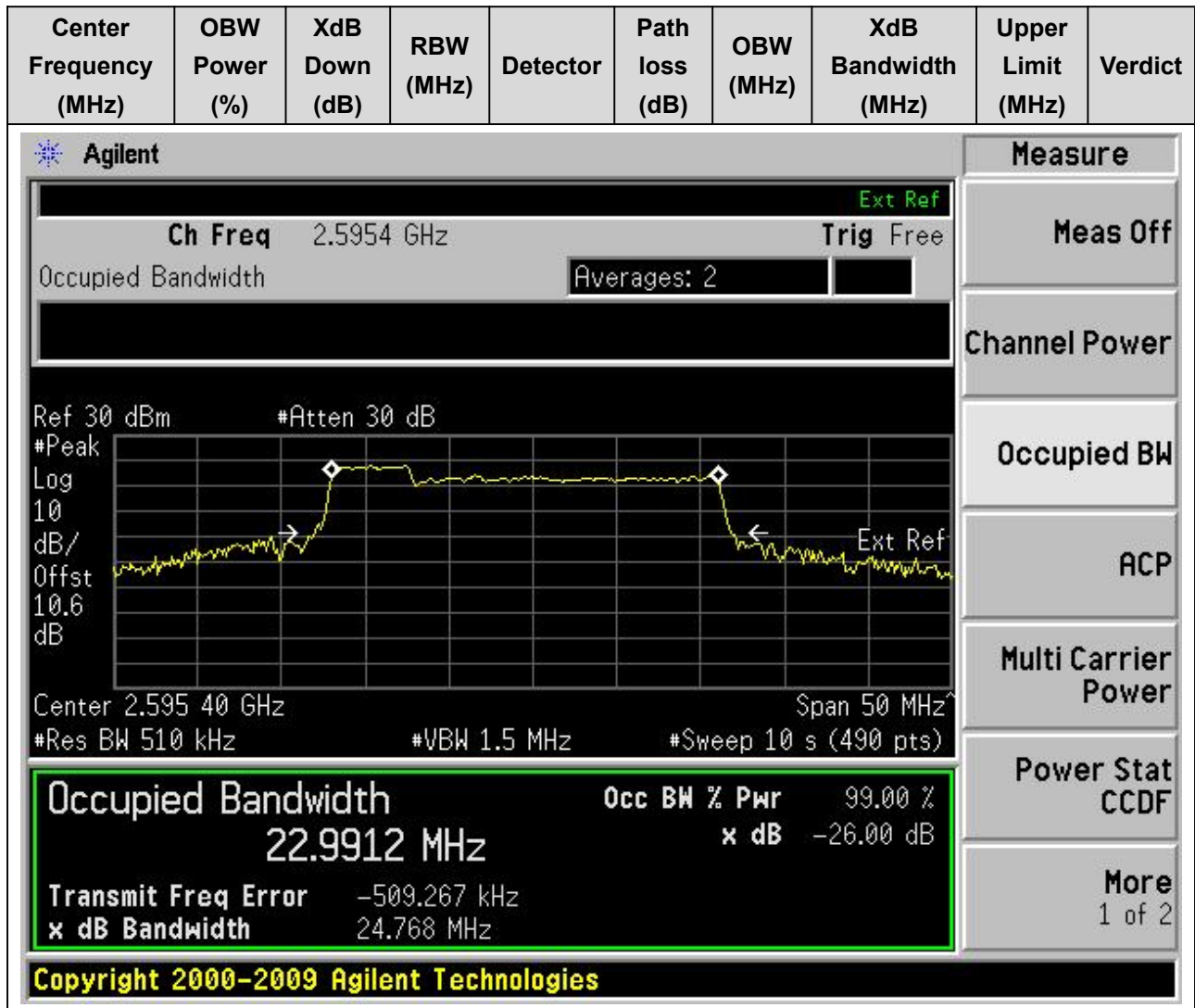
2.1. LTE-A Occupied Bandwidth_Part22-24-27(Channel:40548|40665, Bandwidth:5|20MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2595.4	99	26	0.51	Peak	10.56	22.99	24.77	25	Pass



Measure

Meas Off

Channel Power

Occupied BW

ACP

Multi Carrier Power

Power Stat CCDF

More

1 of 2

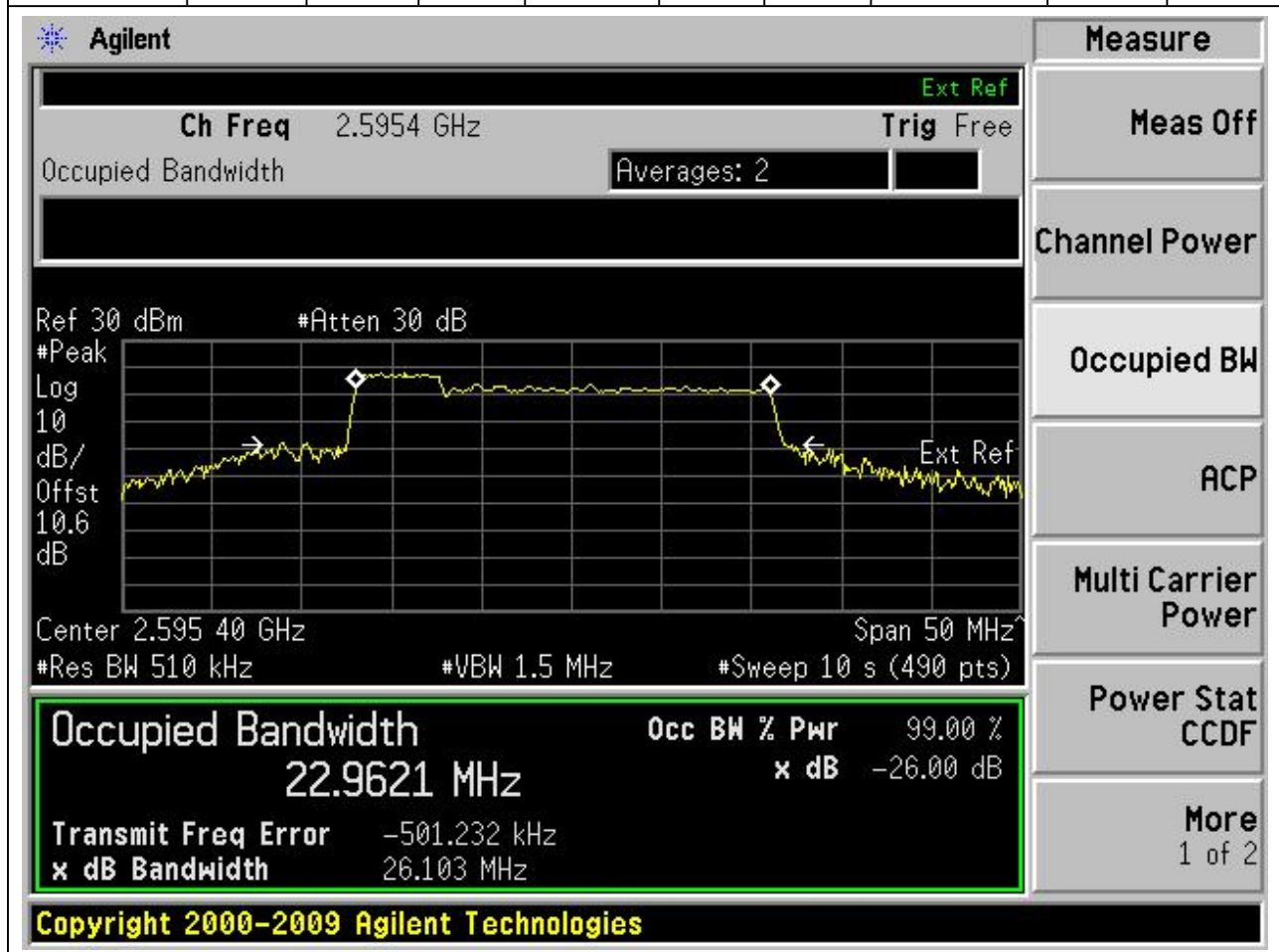
2.2. LTE-A Occupied Bandwidth_Part22-24-27(Channel:40548|40665, Bandwidth:5|20MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2595.4	99	26	0.51	Peak	10.56	22.96	26.1	25	Pass



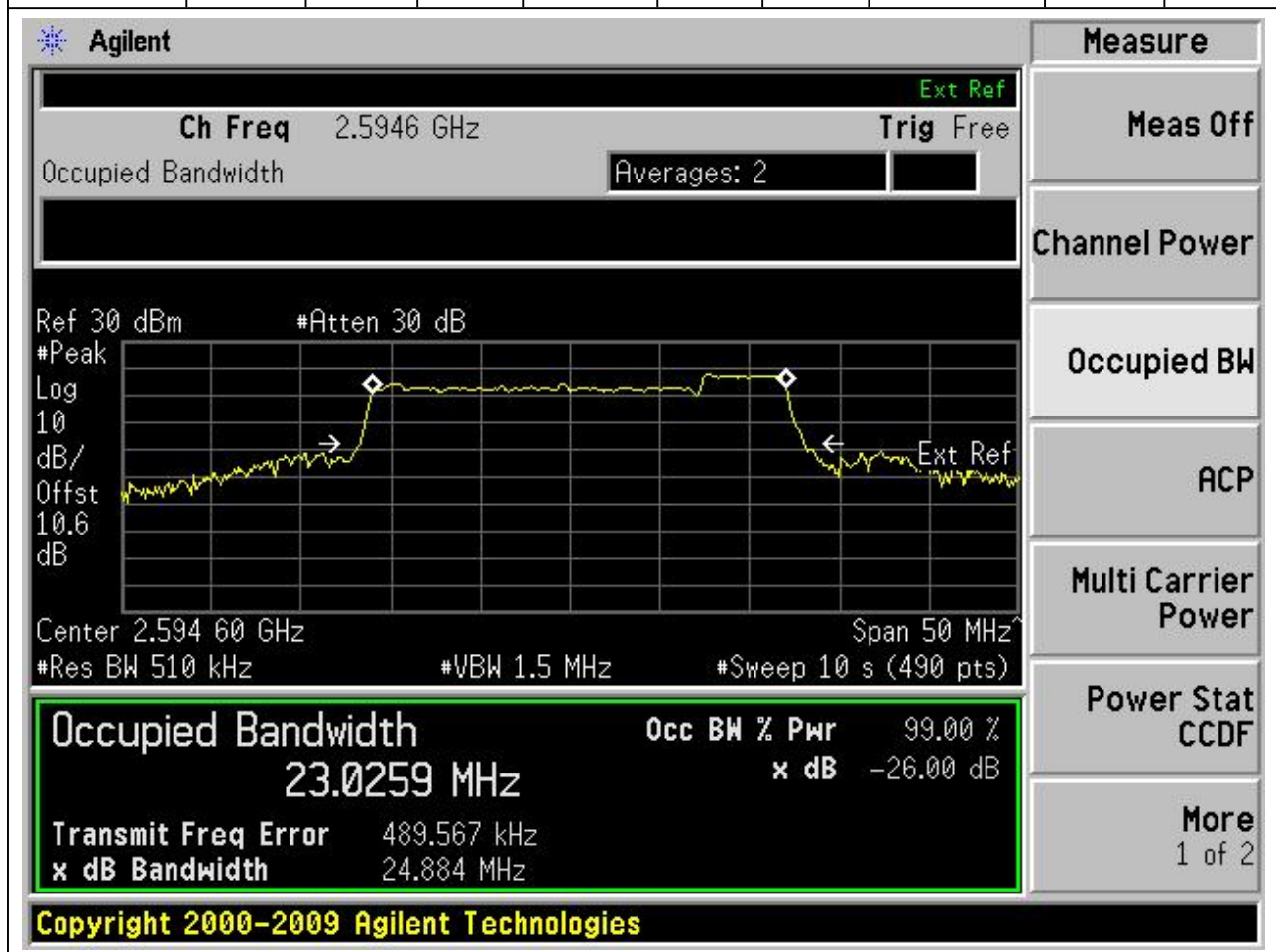
2.3. LTE-A Occupied Bandwidth_Part22-24-27(Channel:40615|40732, Bandwidth:20|5MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2594.6	99	26	0.51	Peak	10.55	23.03	24.88	25	Pass



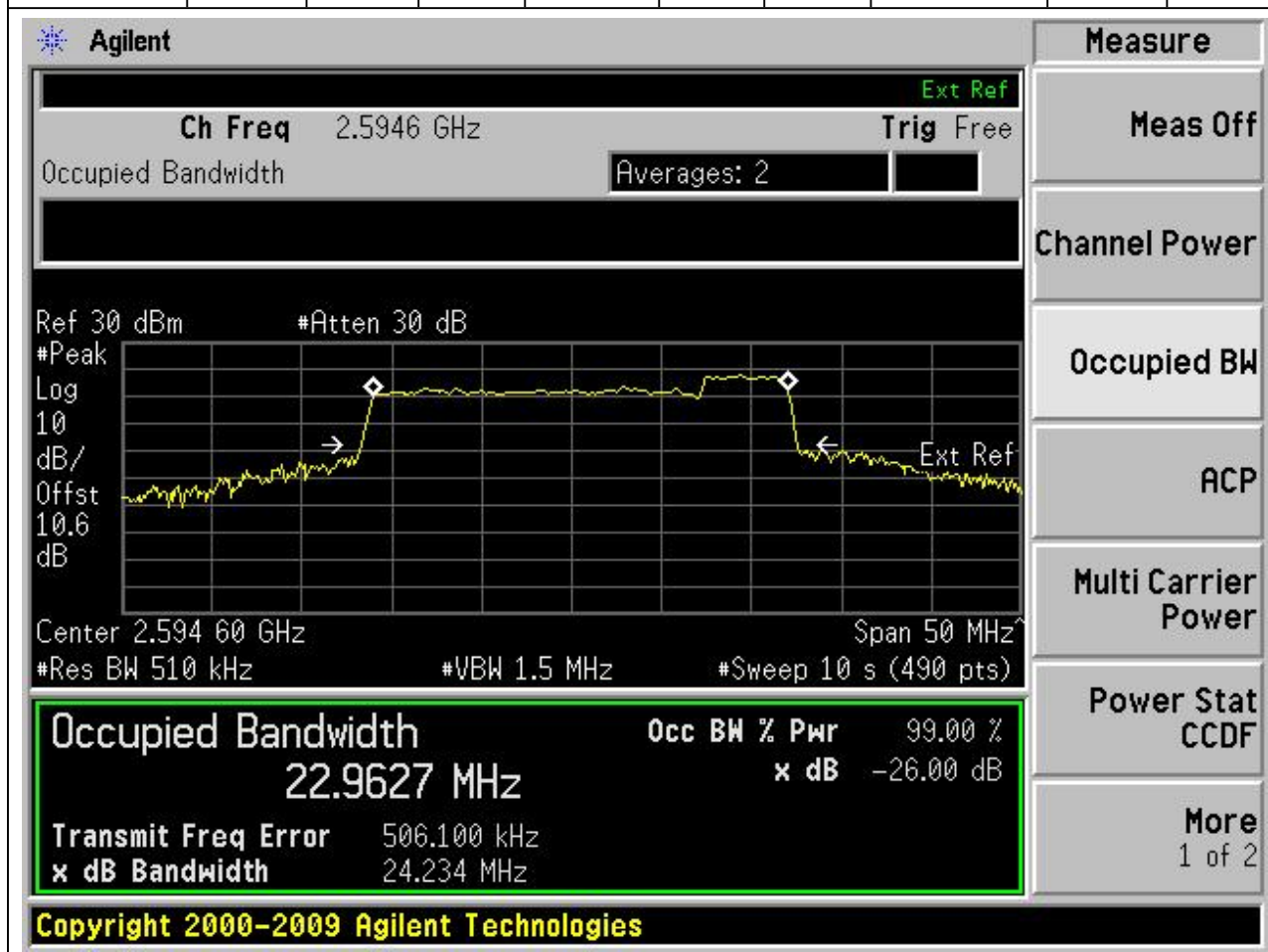
2.4. LTE-A Occupied Bandwidth_Part22-24-27(Channel:40615|40732, Bandwidth:20|5MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2594.6	99	26	0.51	Peak	10.55	22.96	24.23	25	Pass



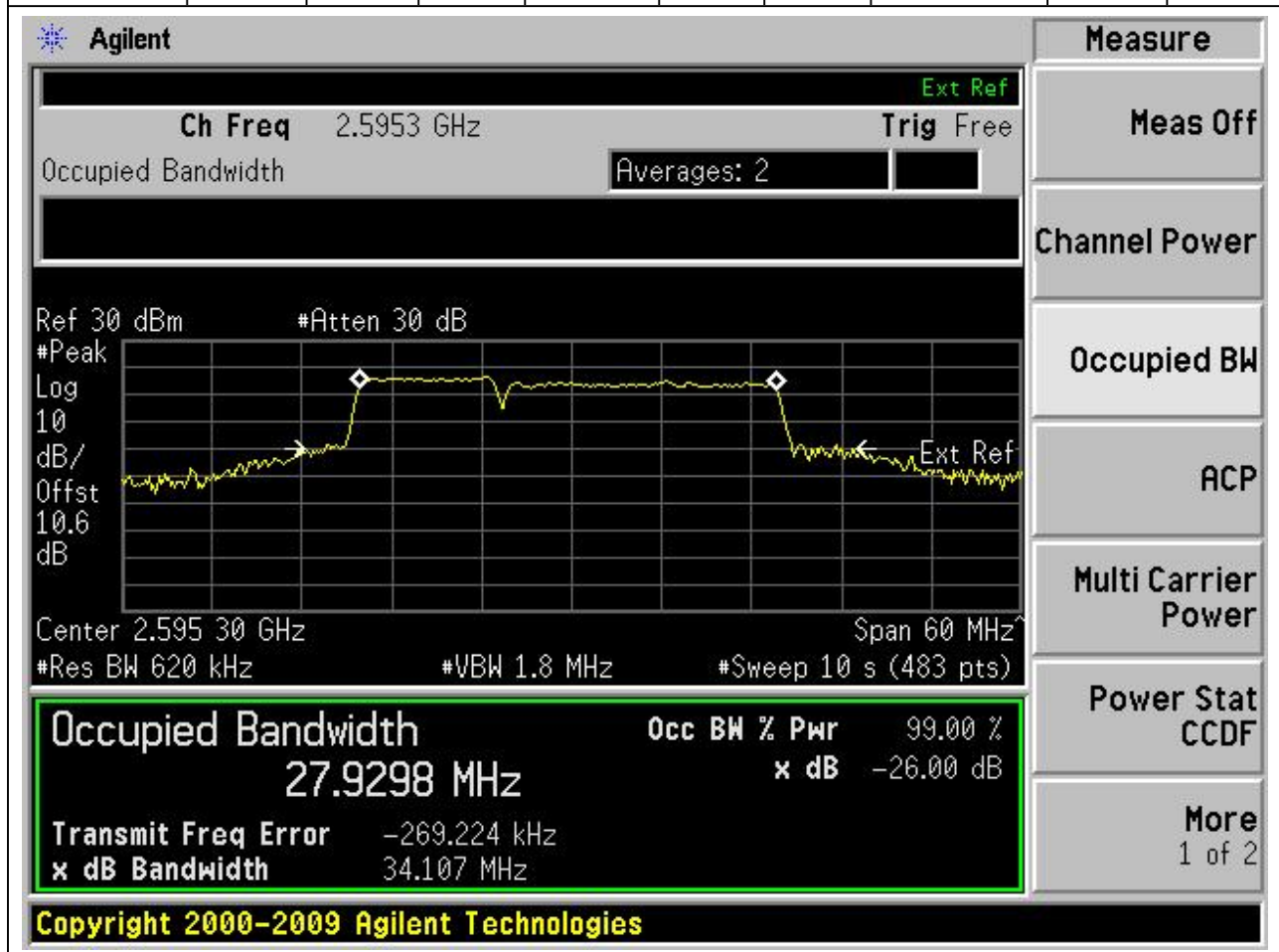
2.5. LTE-A Occupied Bandwidth_Part22-24-27(Channel:40546|40690, Bandwidth:10|20MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2595.3	99	26	0.62	Peak	10.56	27.93	34.11	30	Pass



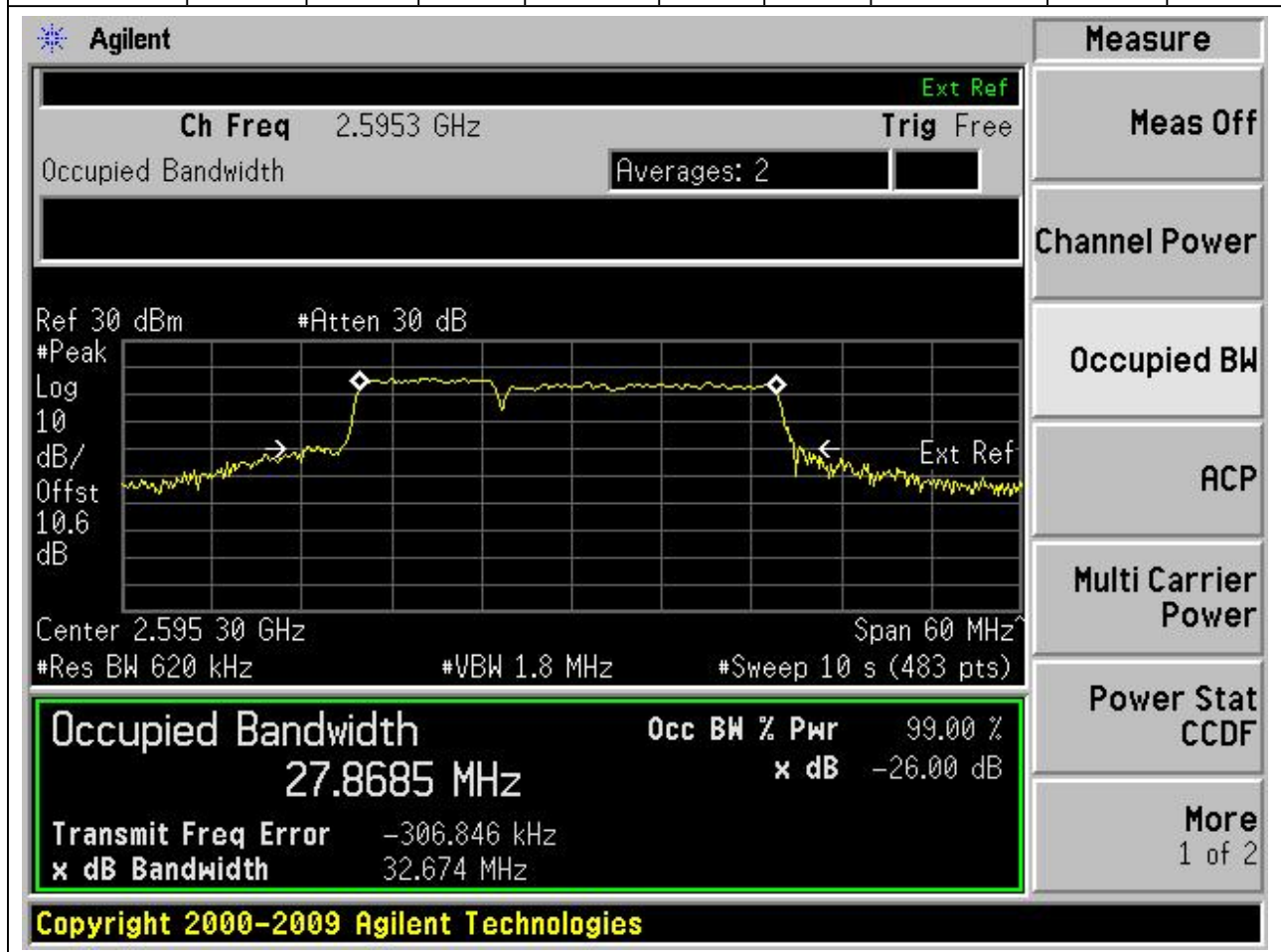
2.6. LTE-A Occupied Bandwidth_Part22-24-27(Channel:40546|40690, Bandwidth:10|20MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2595.3	99	26	0.62	Peak	10.56	27.87	32.67	30	Pass



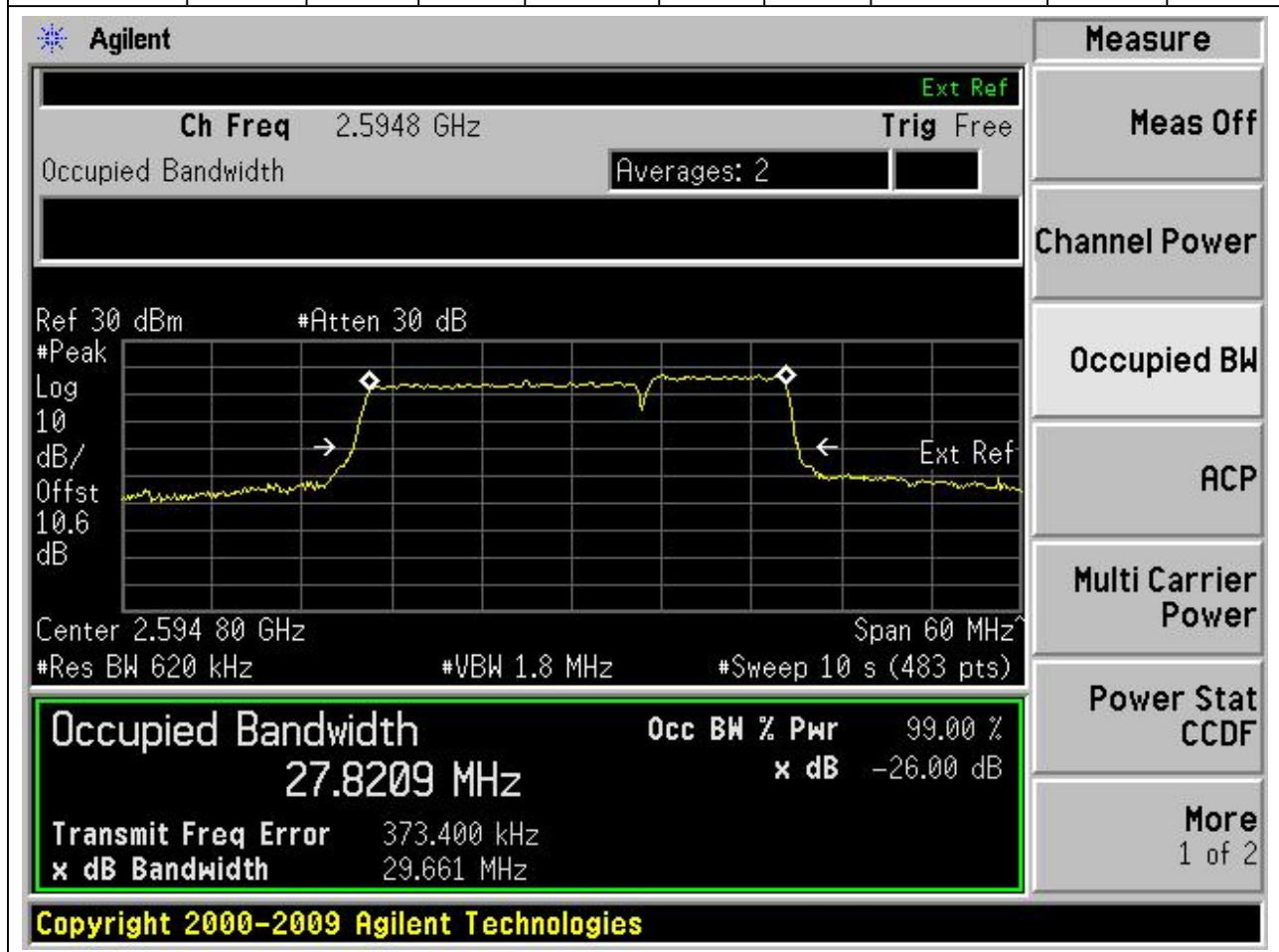
2.7. LTE-A Occupied Bandwidth_Part22-24-27(Channel:40591|40735, Bandwidth:20|10MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2594.8	99	26	0.62	Peak	10.55	27.82	29.66	30	Pass



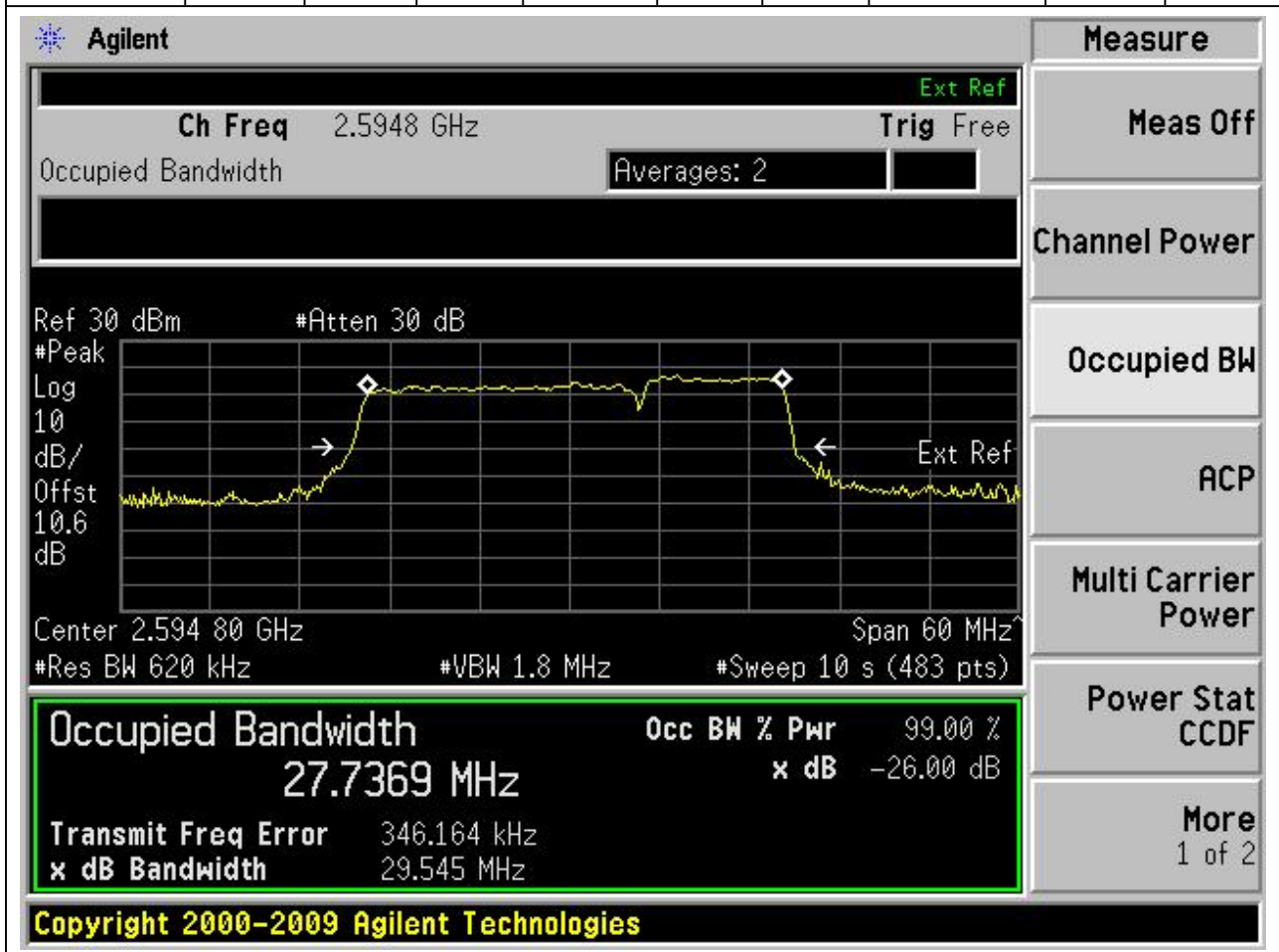
2.8. LTE-A Occupied Bandwidth_Part22-24-27(Channel:40591|40735, Bandwidth:20|10MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2594.8	99	26	0.62	Peak	10.55	27.74	29.54	30	Pass



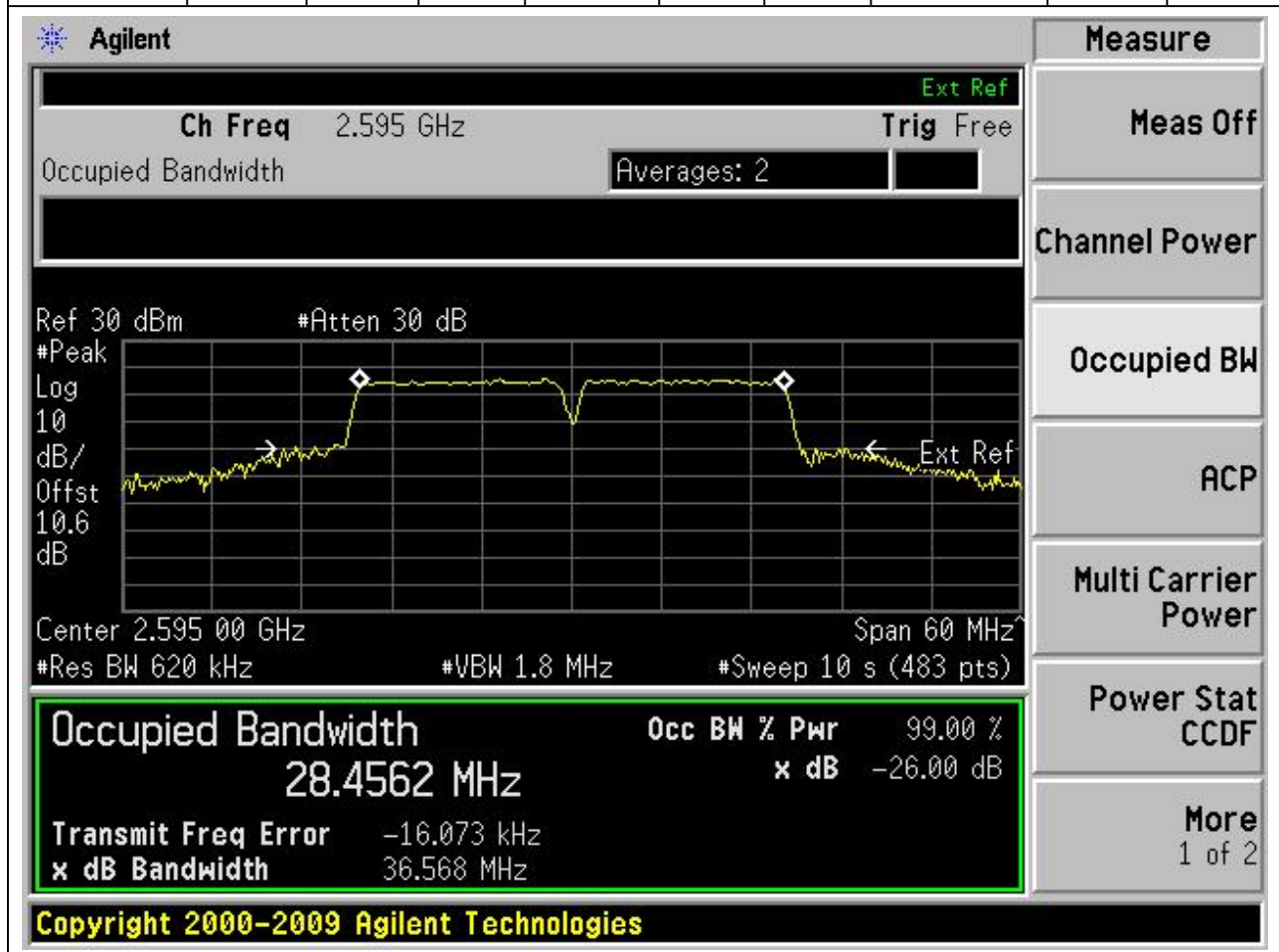
2.9. LTE-A Occupied Bandwidth_Part22-24-27(Channel:40565|40715, Bandwidth:15|15MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2595	99	26	0.62	Peak	10.55	28.46	36.57	30	Pass



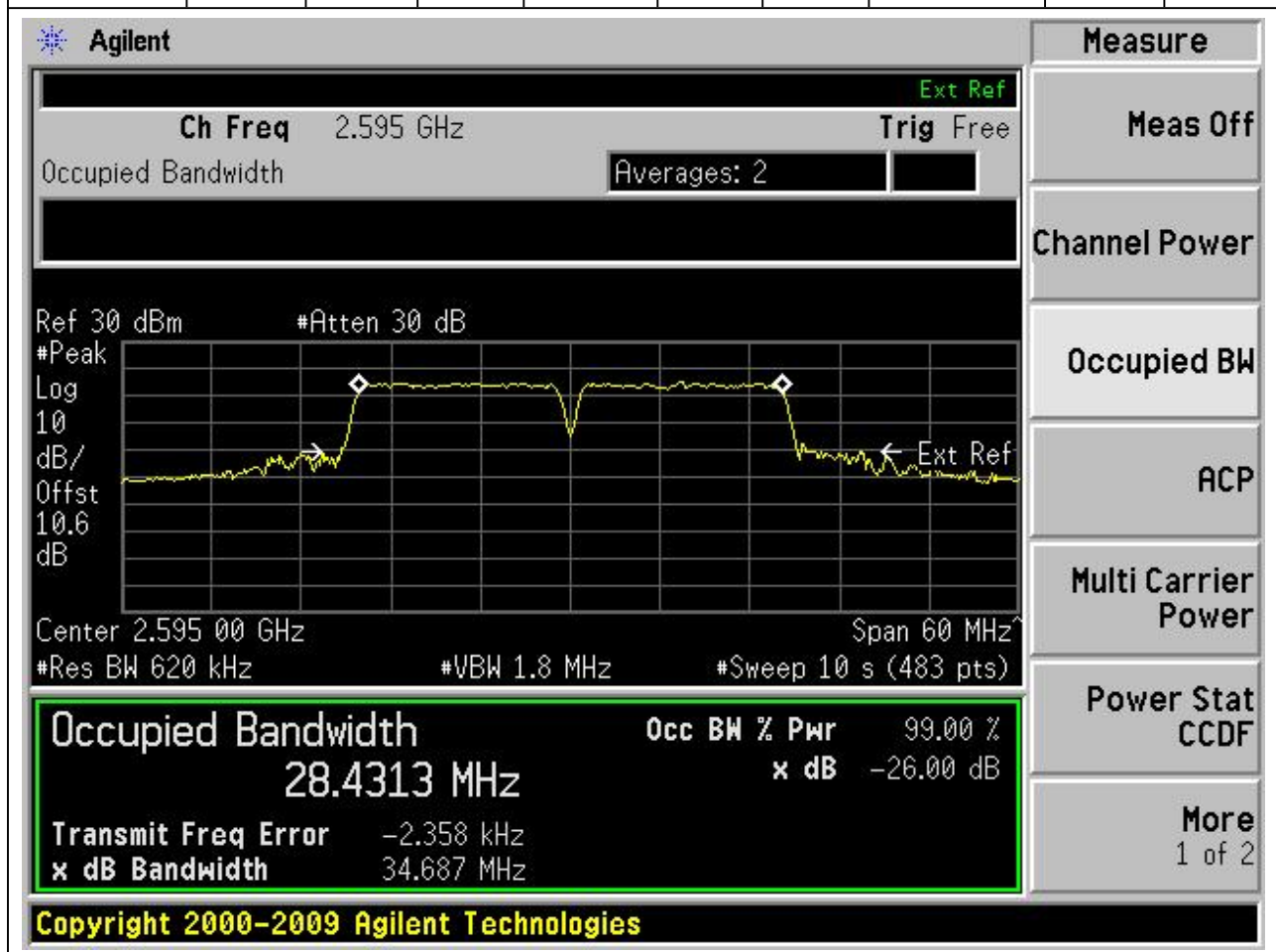
2.10. LTE-A Occupied Bandwidth_Part22-24-27(Channel:40565|40715, Bandwidth:15|15MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2595	99	26	0.62	Peak	10.55	28.43	34.69	30	Pass



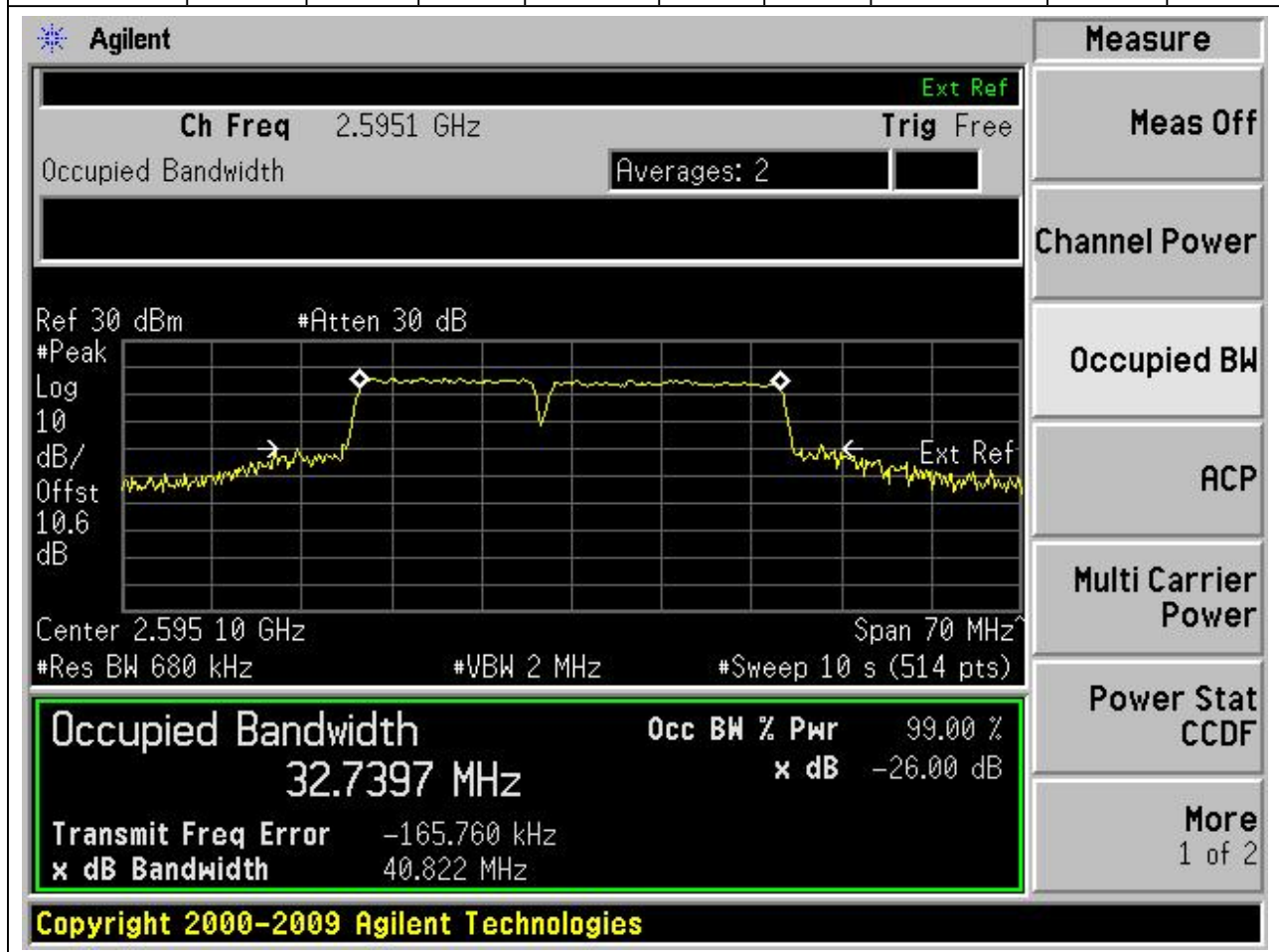
2.11. LTE-A Occupied Bandwidth_Part22-24-27(Channel:40543|40714, Bandwidth:15|20MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2595.1	99	26	0.68	Peak	10.55	32.74	40.82	35	Pass



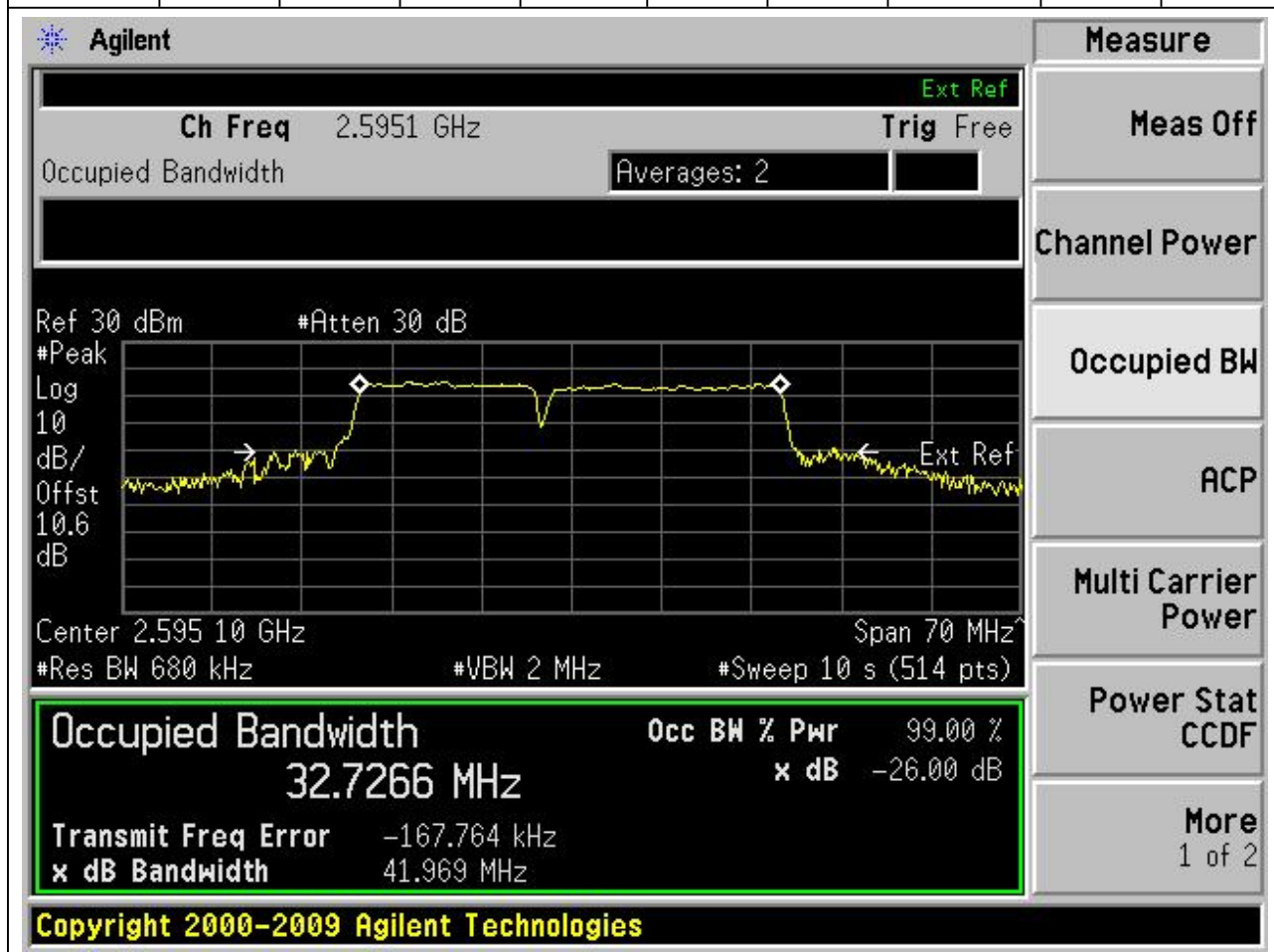
2.12. LTE-A Occupied Bandwidth_Part22-24-27(Channel:40543|40714, Bandwidth:15|20MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2595.1	99	26	0.68	Peak	10.55	32.73	41.97	35	Pass



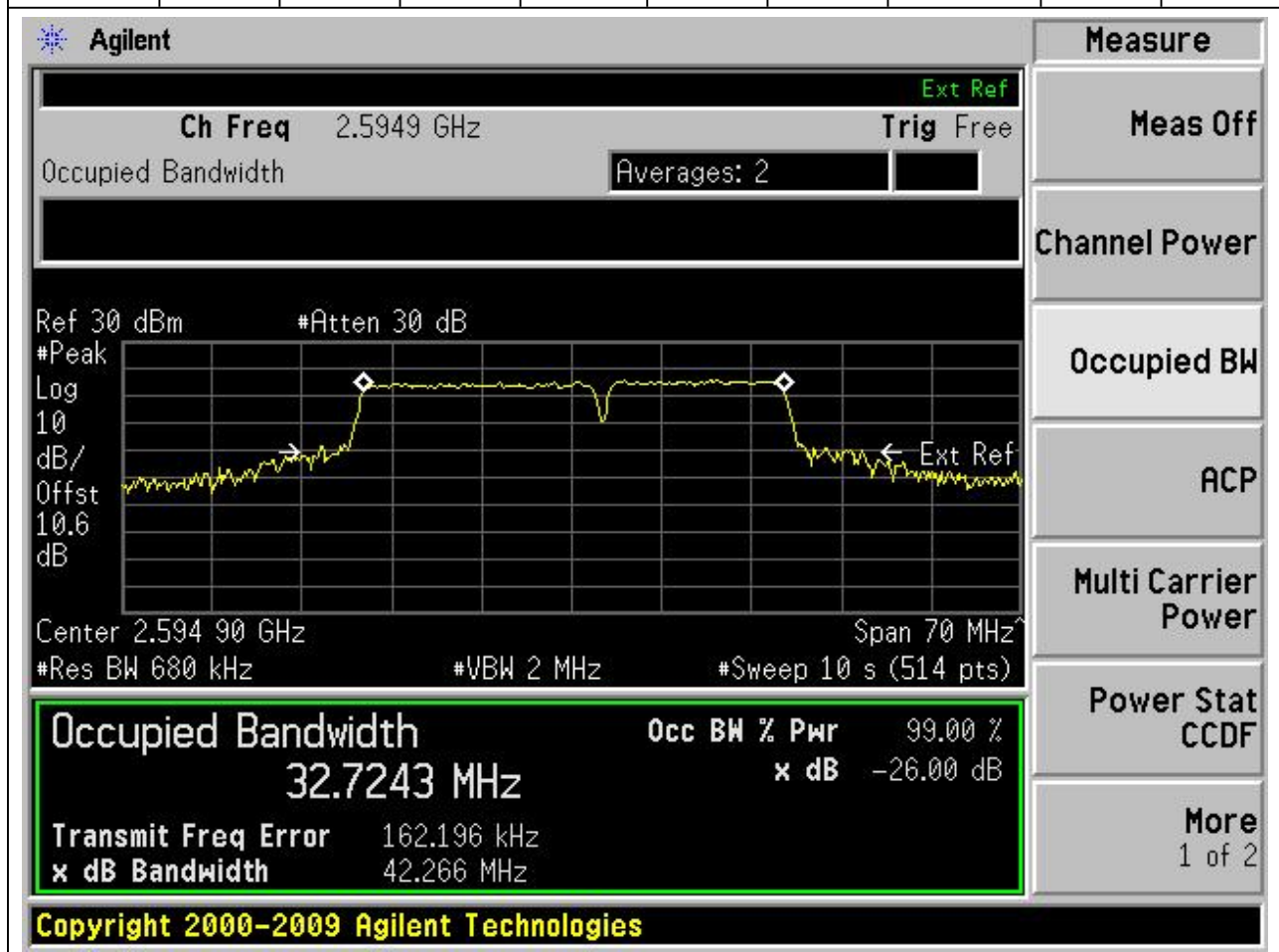
2.13. LTE-A Occupied Bandwidth_Part22-24-27(Channel:40566|40737, Bandwidth:20|15MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2594.9	99	26	0.68	Peak	10.55	32.72	42.27	35	Pass



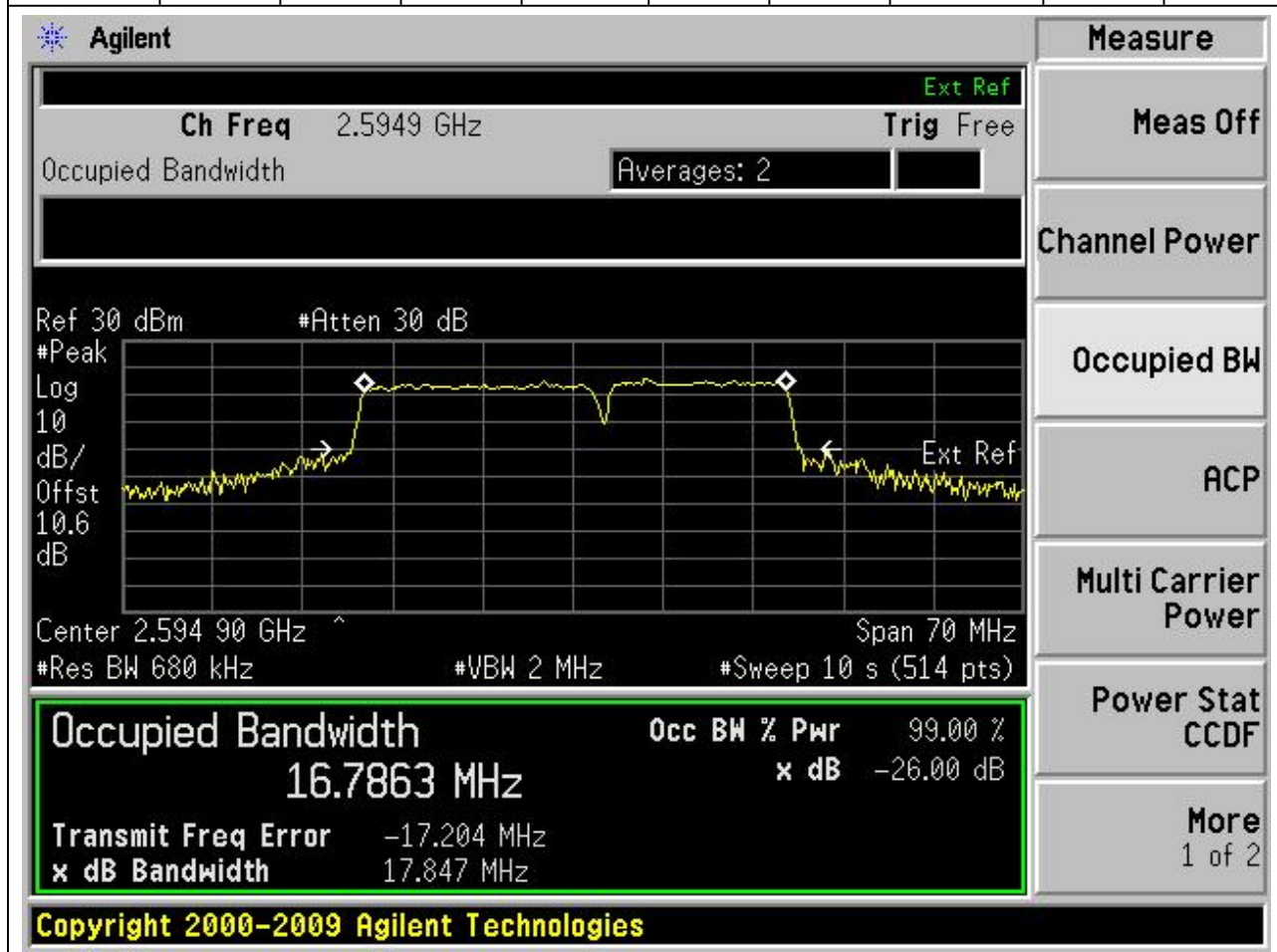
2.14. LTE-A Occupied Bandwidth_Part22-24-27(Channel:40566|40737, Bandwidth:20|15MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2594.9	99	26	0.68	Peak	10.55	16.79	17.85	35	Pass



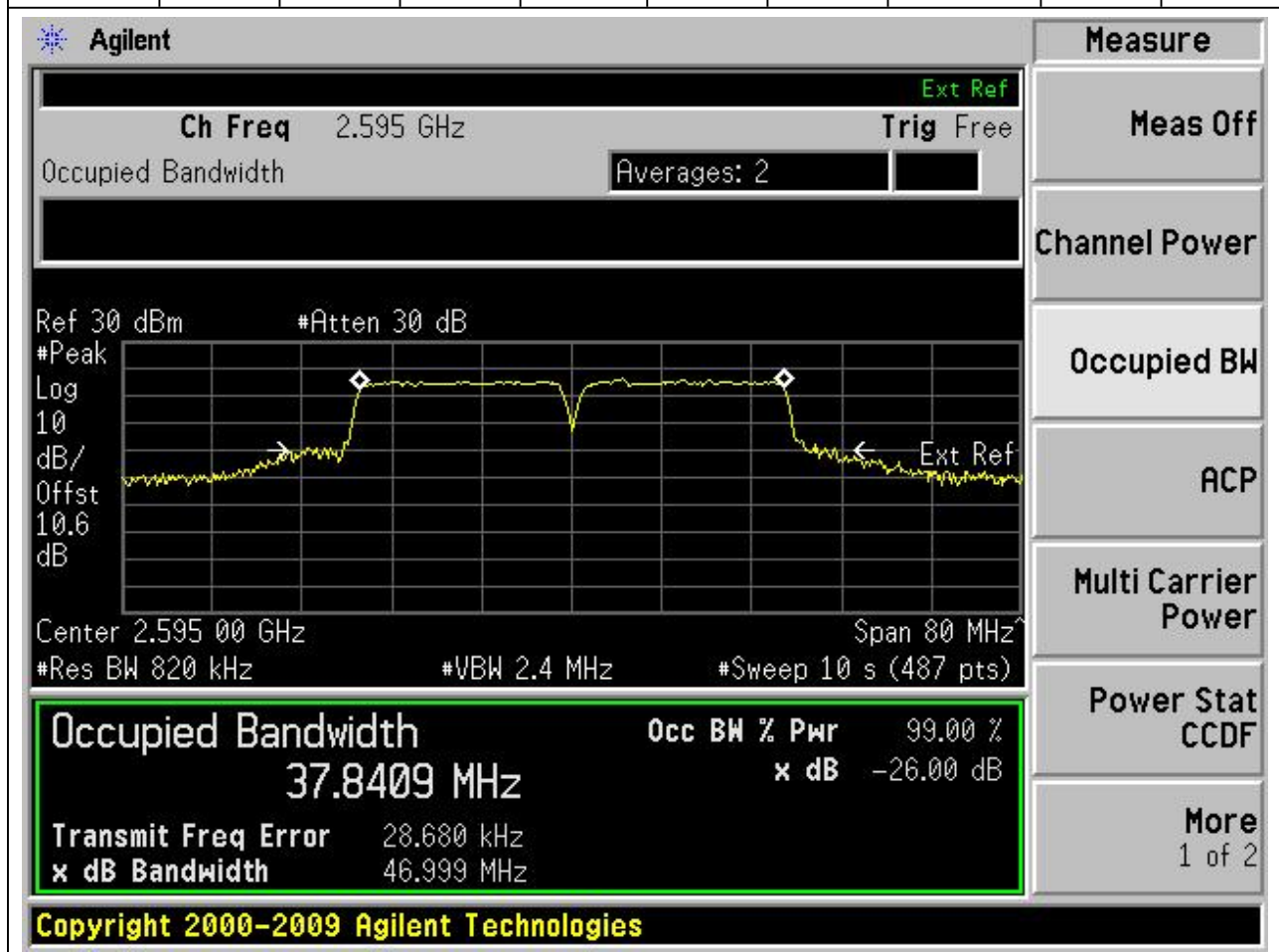
2.15. LTE-A Occupied Bandwidth_Part22-24-27(Channel:40541|40739, Bandwidth:20|20MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2595	99	26	0.82	Peak	10.55	37.84	47	40	Pass



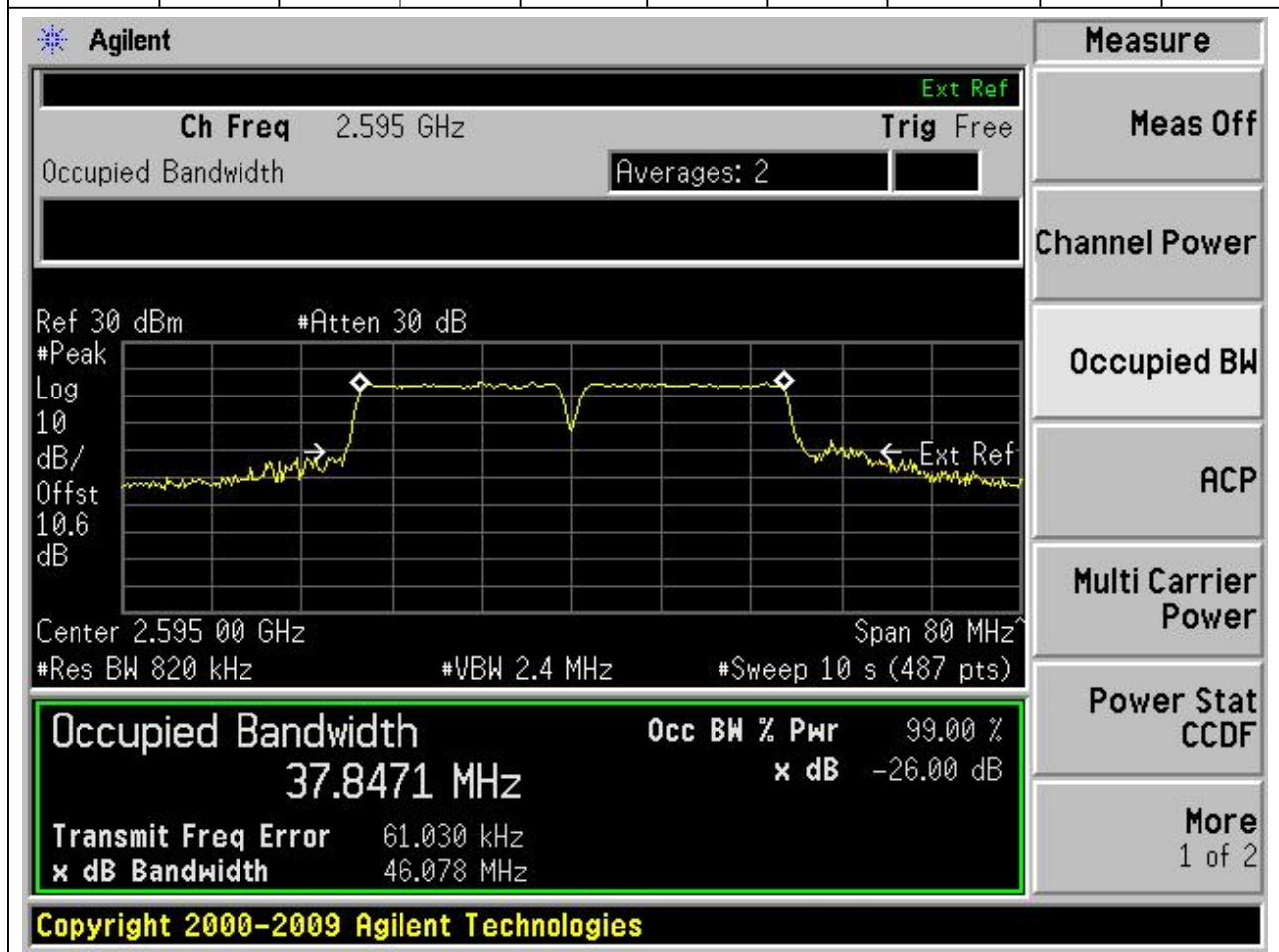
2.16. LTE-A Occupied Bandwidth_Part22-24-27(Channel:40541|40739, Bandwidth:20|20MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2595	99	26	0.82	Peak	10.55	37.85	46.08	40	Pass



3. CA_2C

EUT Sample No.:	
EUT Name:	
EUT Manufacturer:	
EUT Model:	
EUT Serial Number:	
EUT Hardware Version:	
EUT Software Version:	
Low Temperature(LT):	-10 °C
Normal Temperature(NT):	+25 °C
High Temperature(HT):	+55 °C
Low Voltage(LV):	3.6 V
Normal Voltage(NV):	3.8 V
High Voltage(HV):	4.2 V

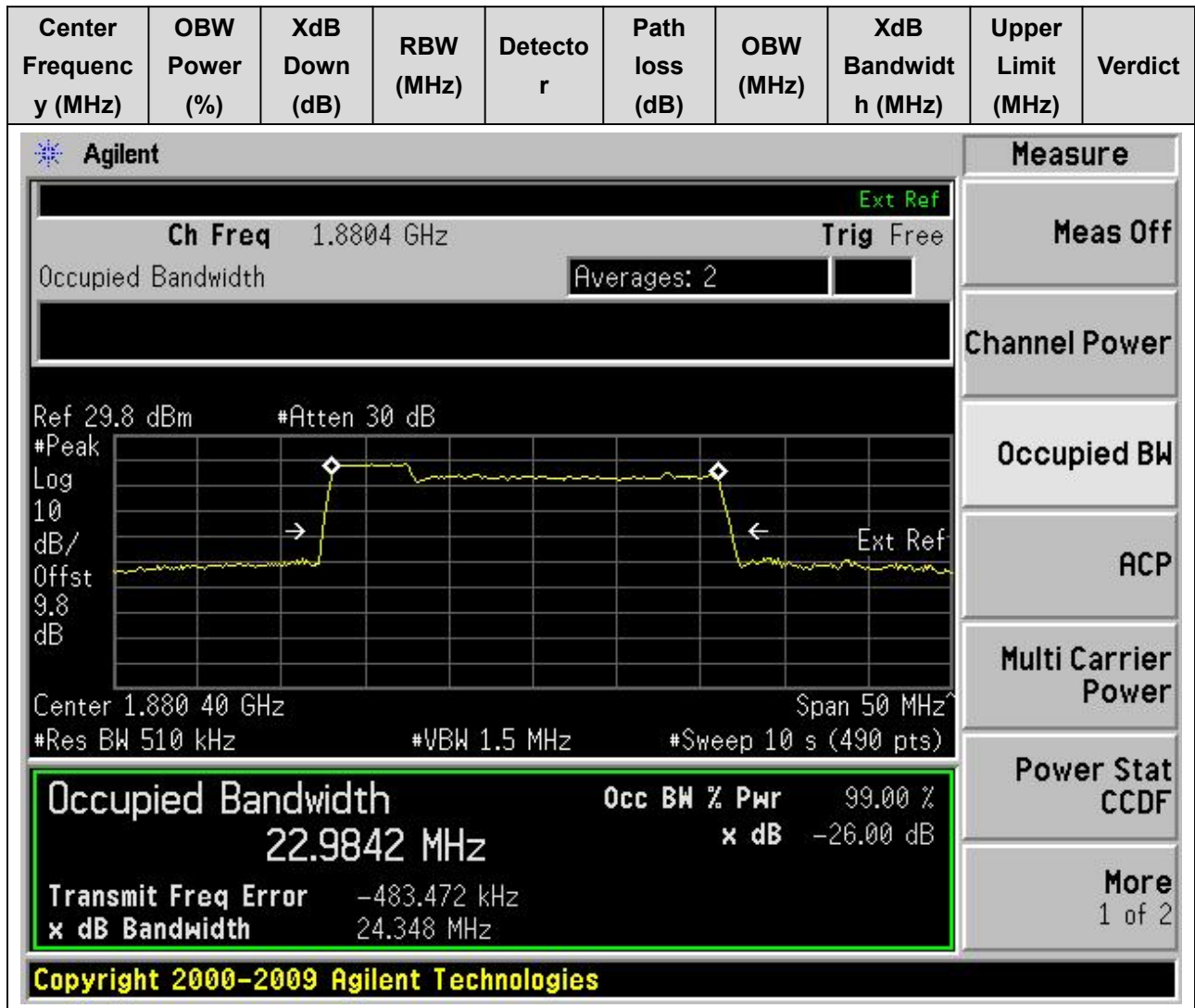
3.1. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18808|18925, Bandwidth:5|20MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1880.4	99	26	0.51	Peak	9.8	22.98	24.35	25	Pass



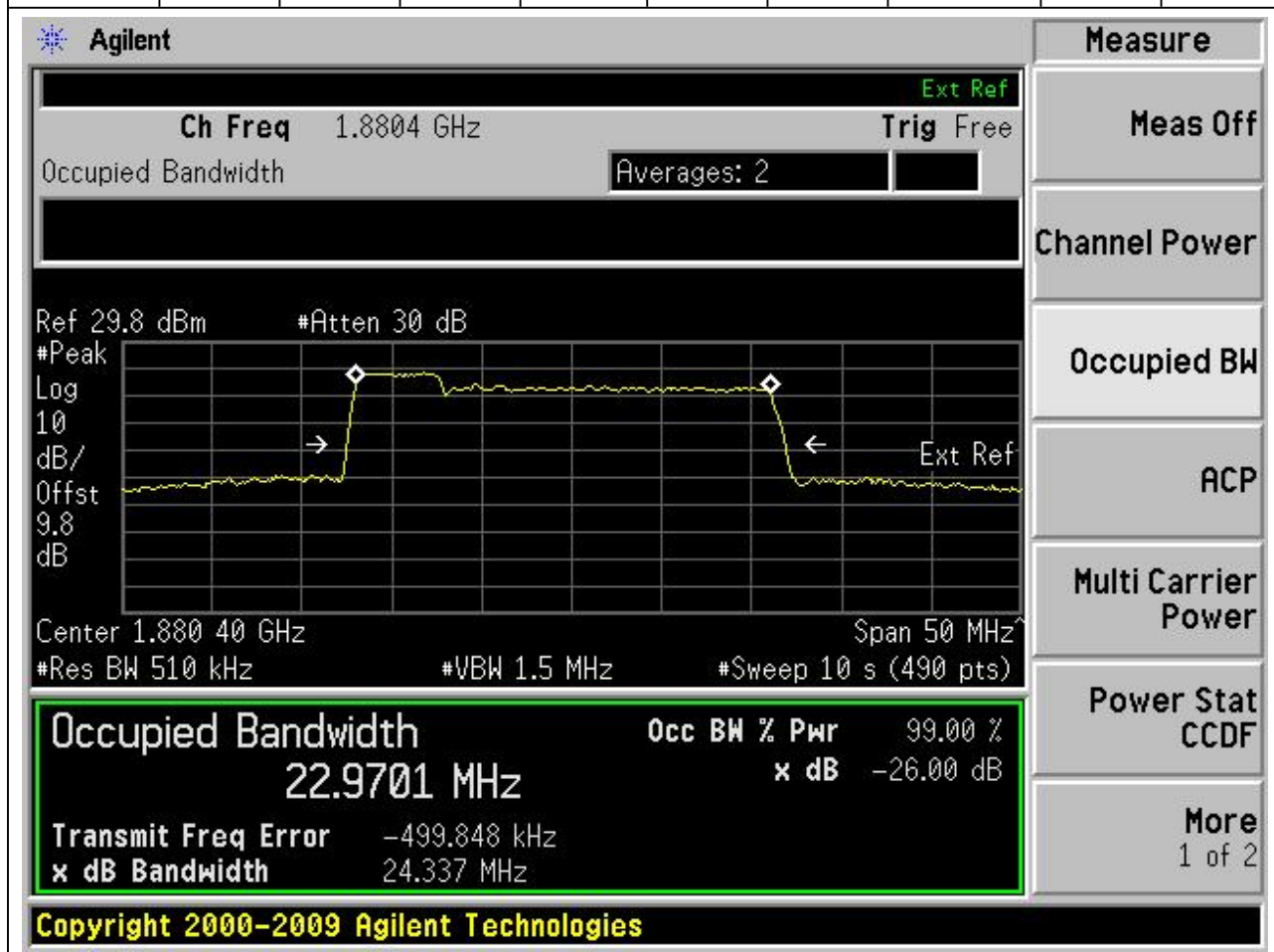
3.2. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18808|18925, Bandwidth:5|20MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1880.4	99	26	0.51	Peak	9.8	22.97	24.34	25	Pass



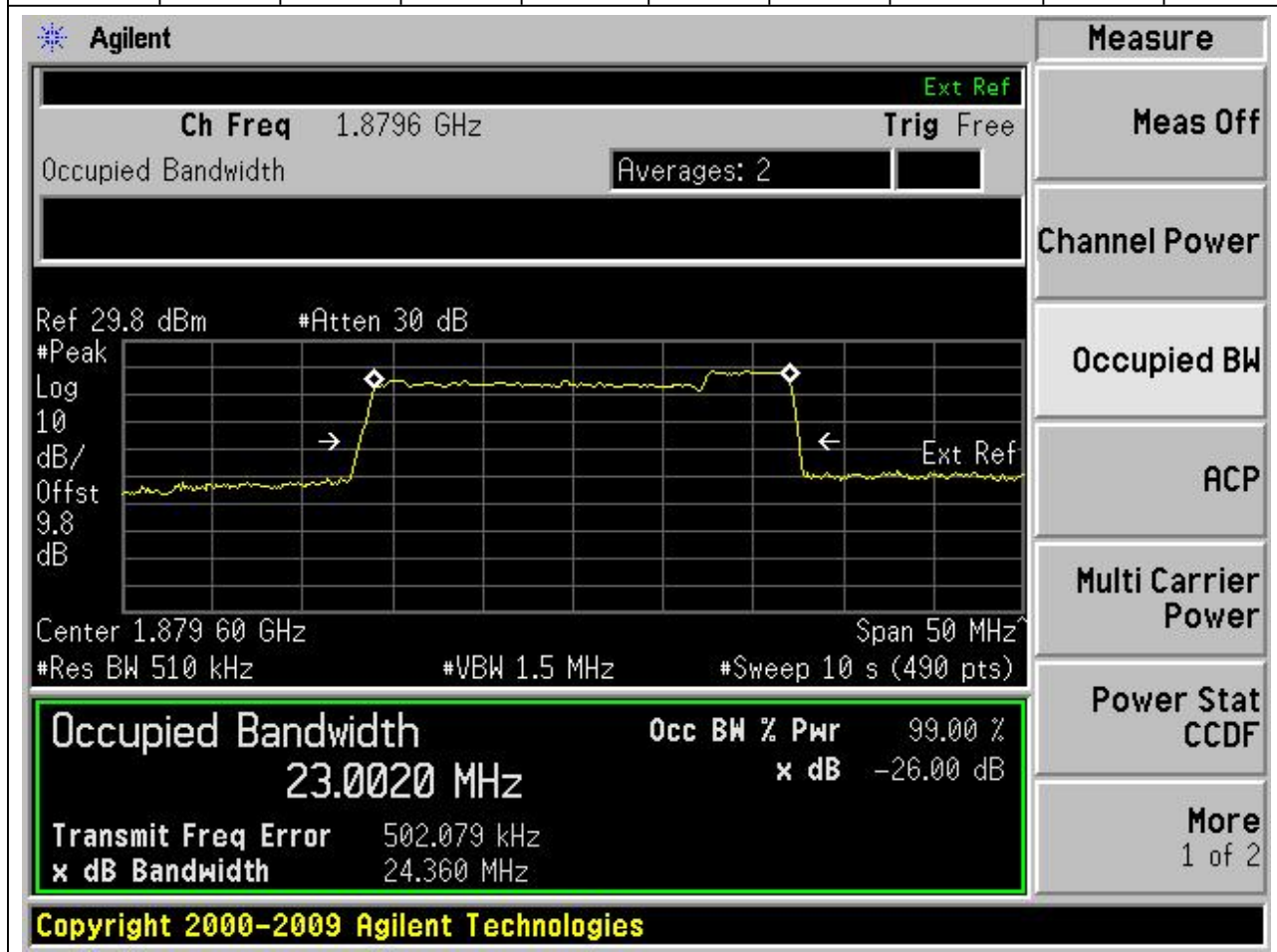
3.3. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18875|18992, Bandwidth:20|5MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1879.6	99	26	0.51	Peak	9.8	23	24.36	25	Pass



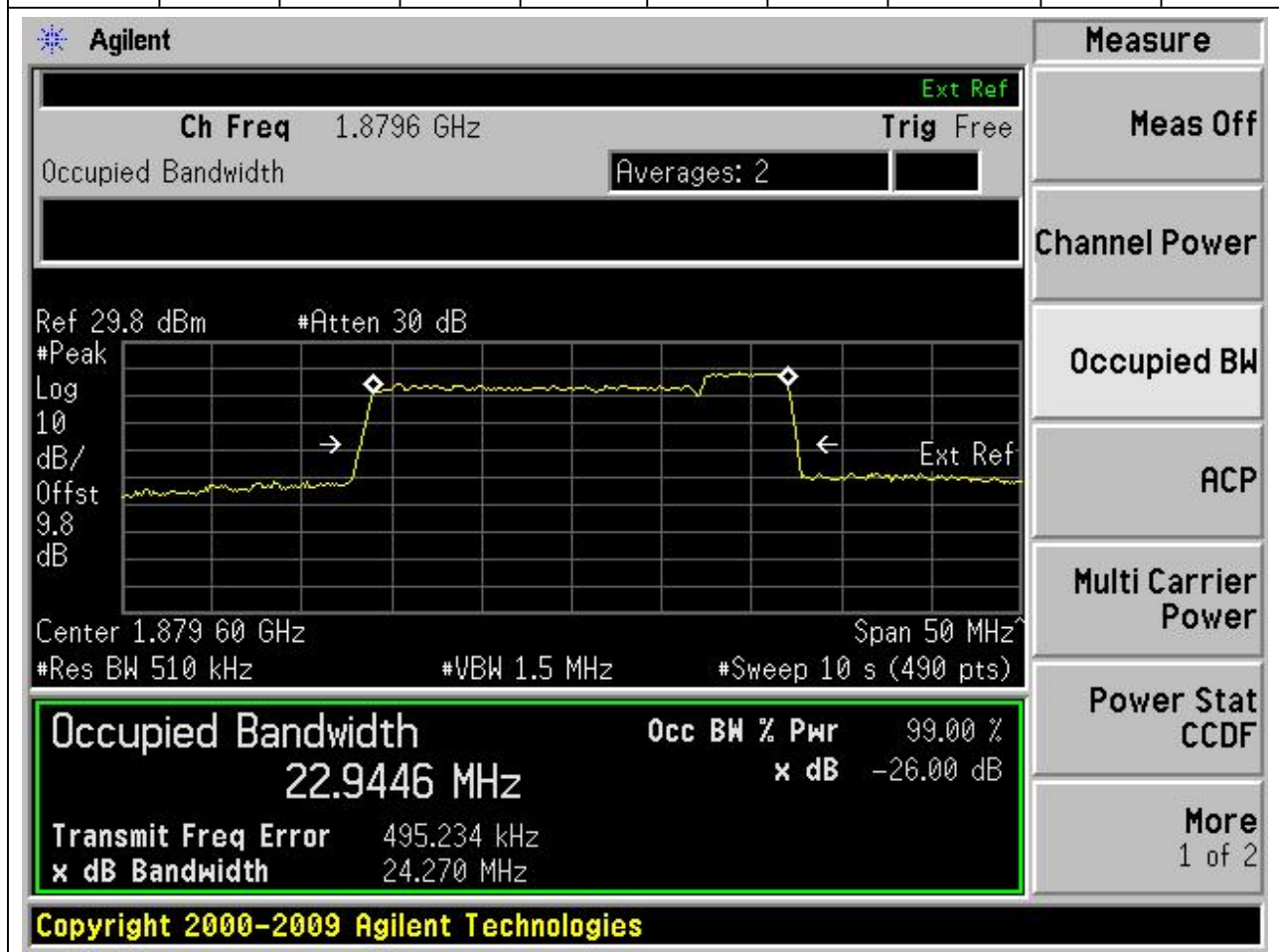
3.4. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18875|18992, Bandwidth:20|5MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1879.6	99	26	0.51	Peak	9.8	22.94	24.27	25	Pass



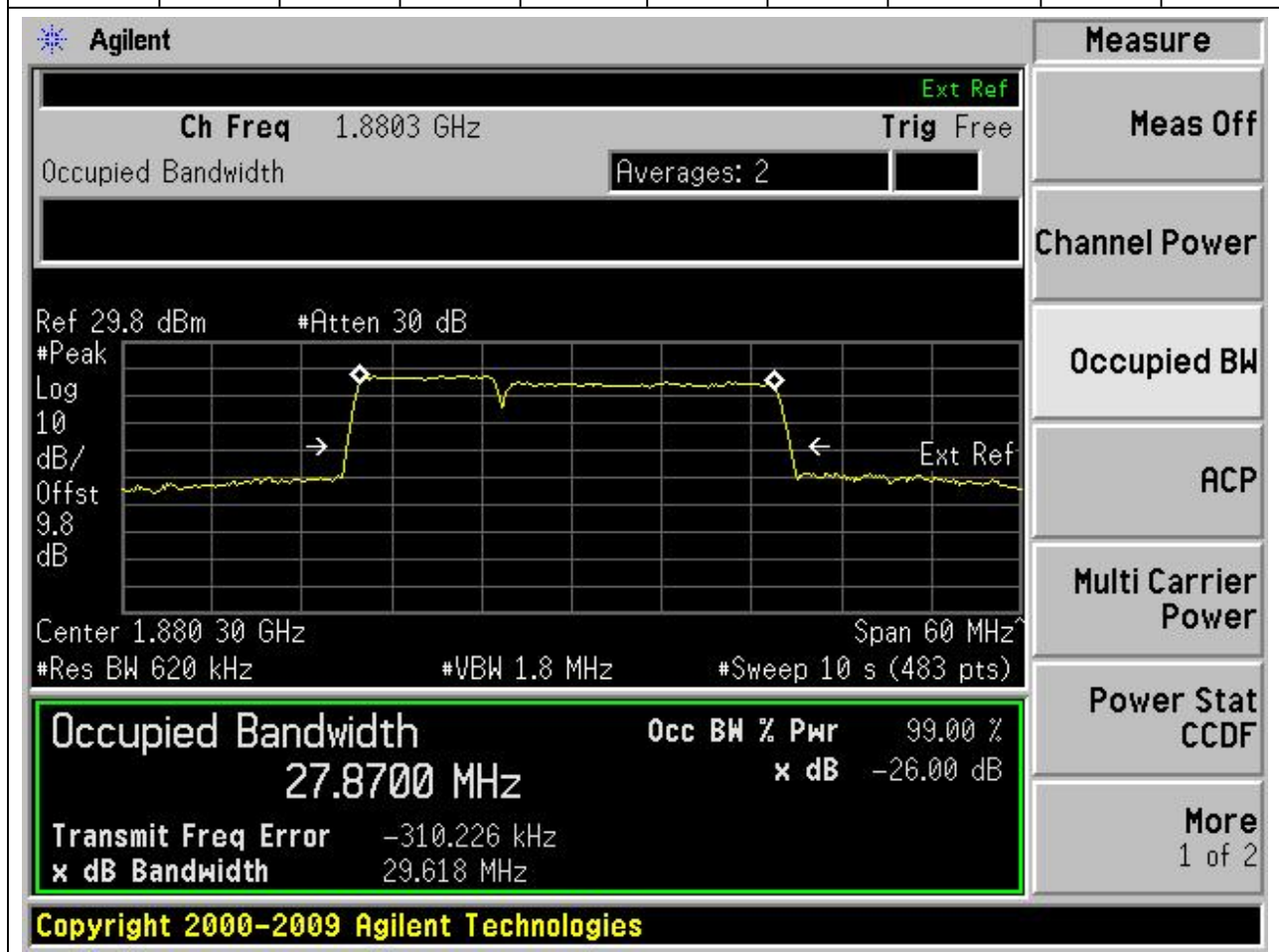
3.5. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18806|18950, Bandwidth:10|20MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1880.3	99	26	0.62	Peak	9.8	27.87	29.62	30	Pass



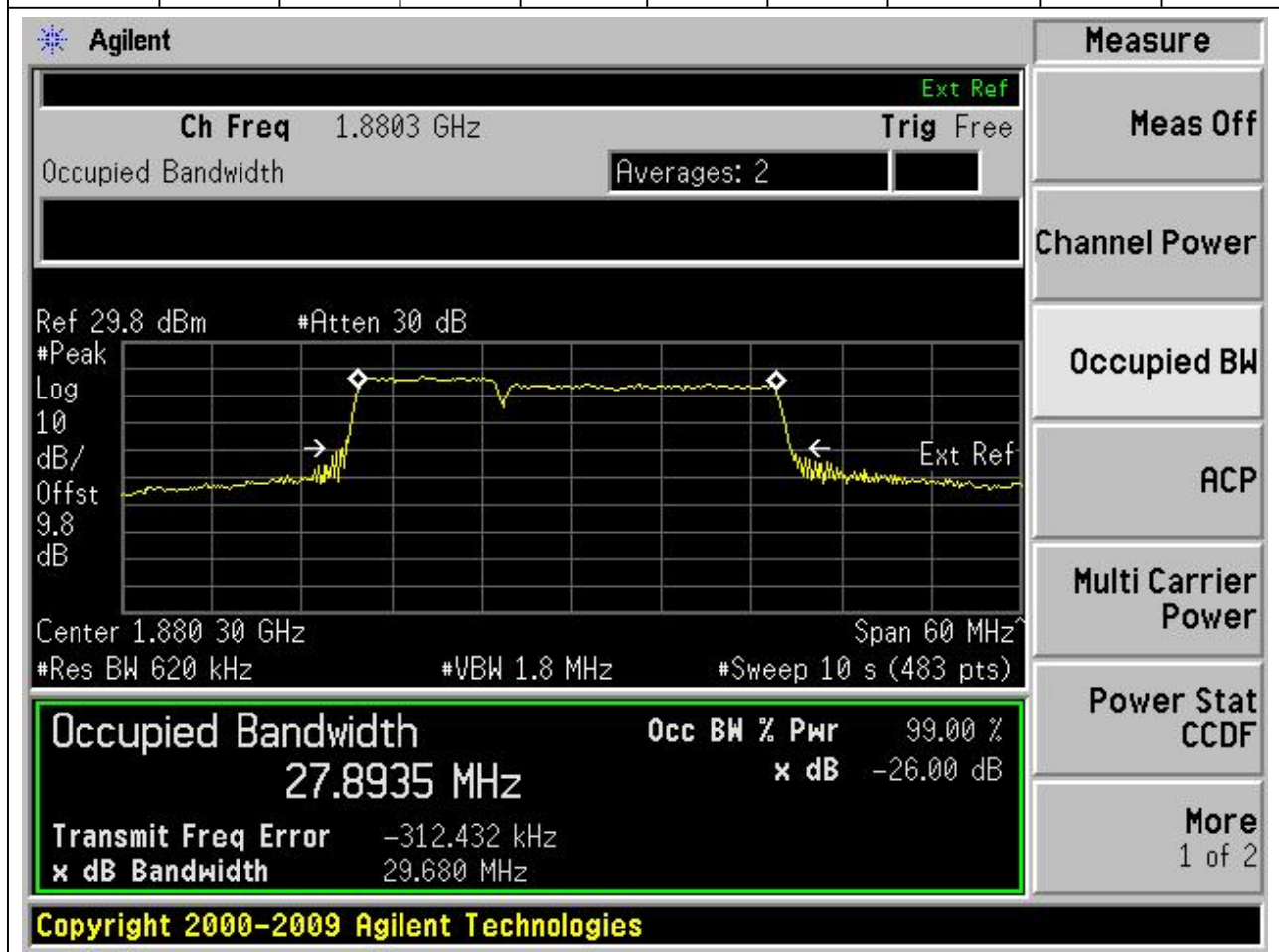
3.6. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18806|18950, Bandwidth:10|20MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1880.3	99	26	0.62	Peak	9.8	27.89	29.68	30	Pass



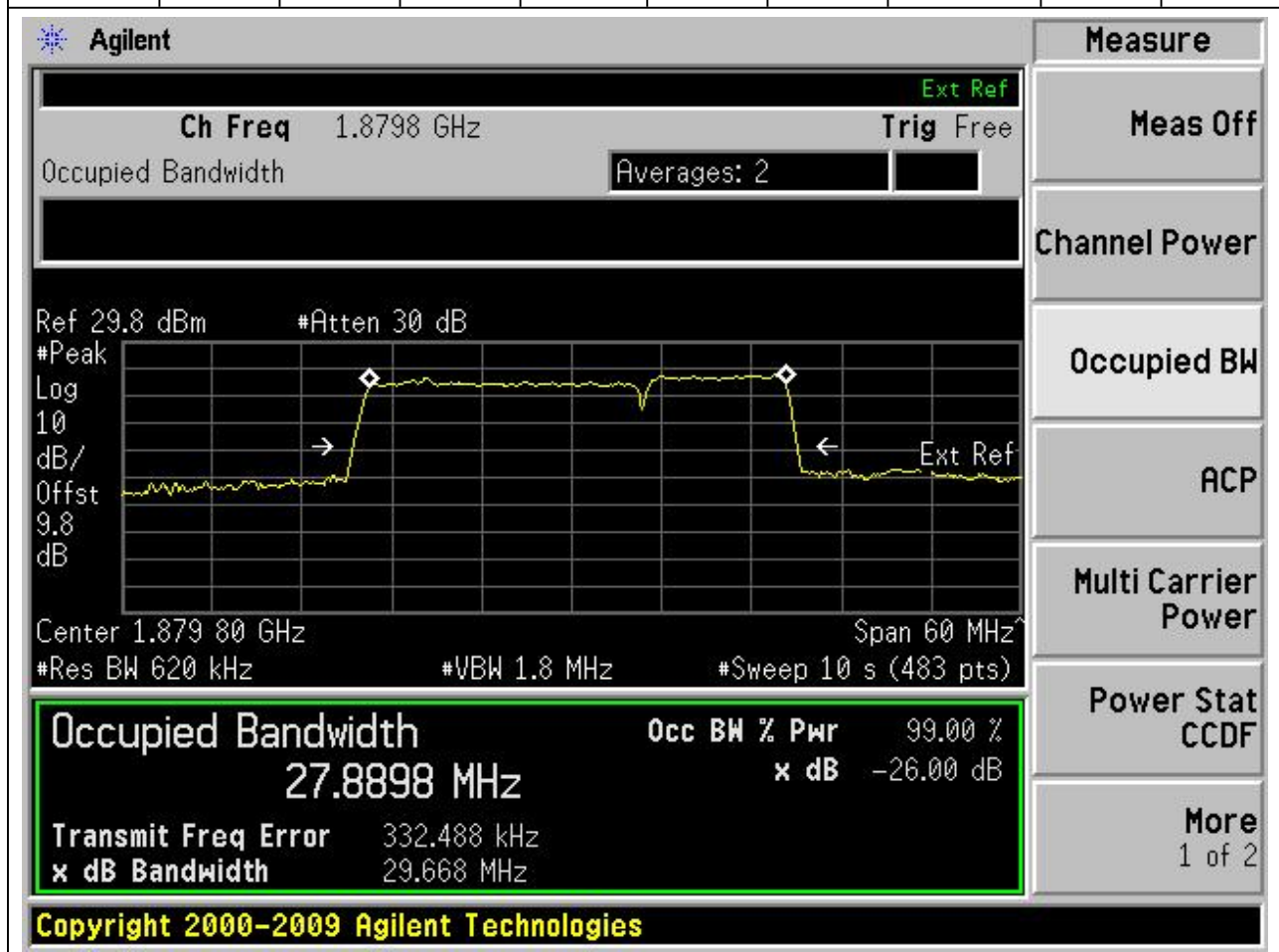
3.7. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18851|18995, Bandwidth:20|10MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1879.8	99	26	0.62	Peak	9.8	27.89	29.67	30	Pass



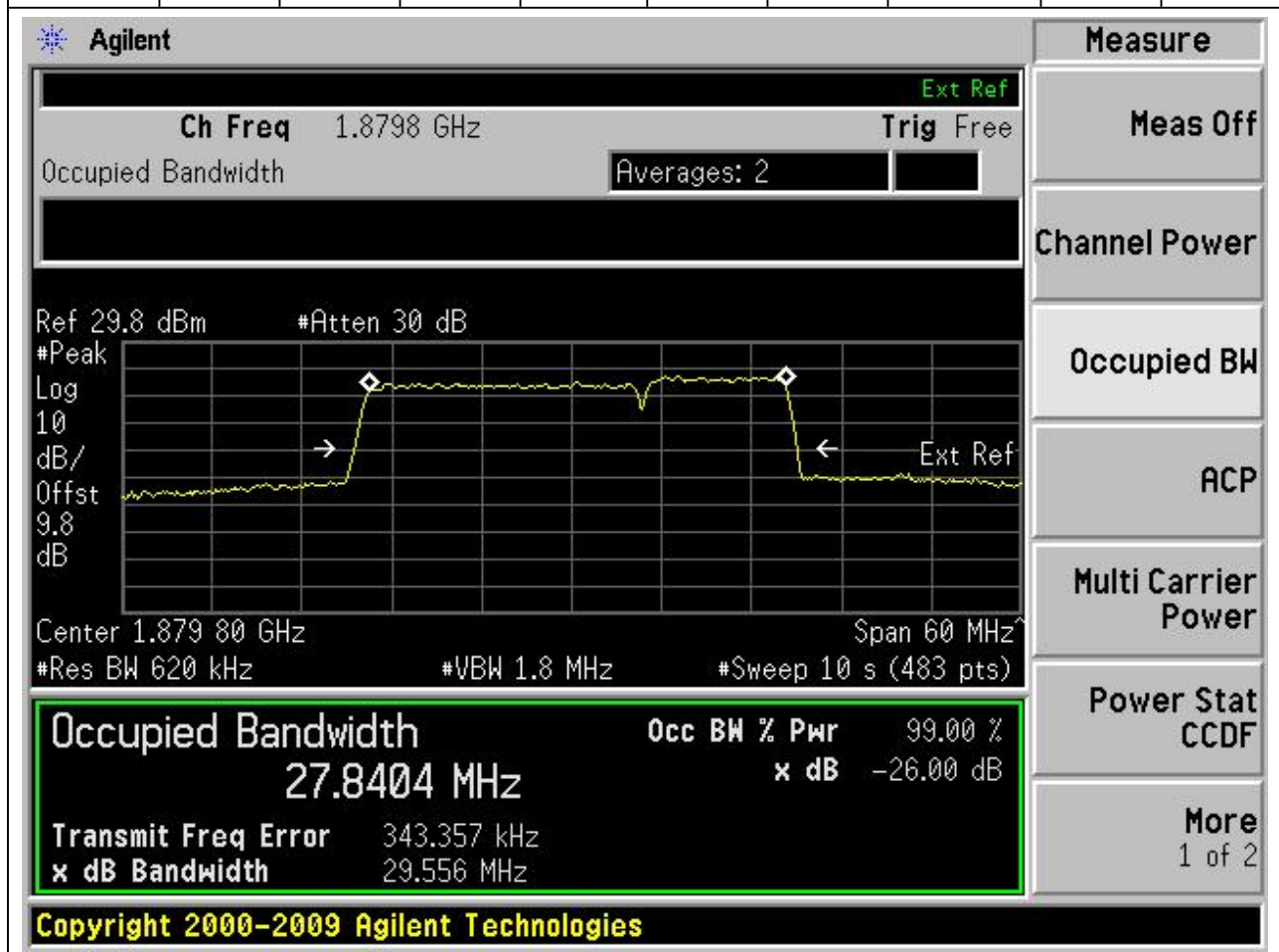
3.8. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18851|18995, Bandwidth:20|10MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1879.8	99	26	0.62	Peak	9.8	27.84	29.56	30	Pass



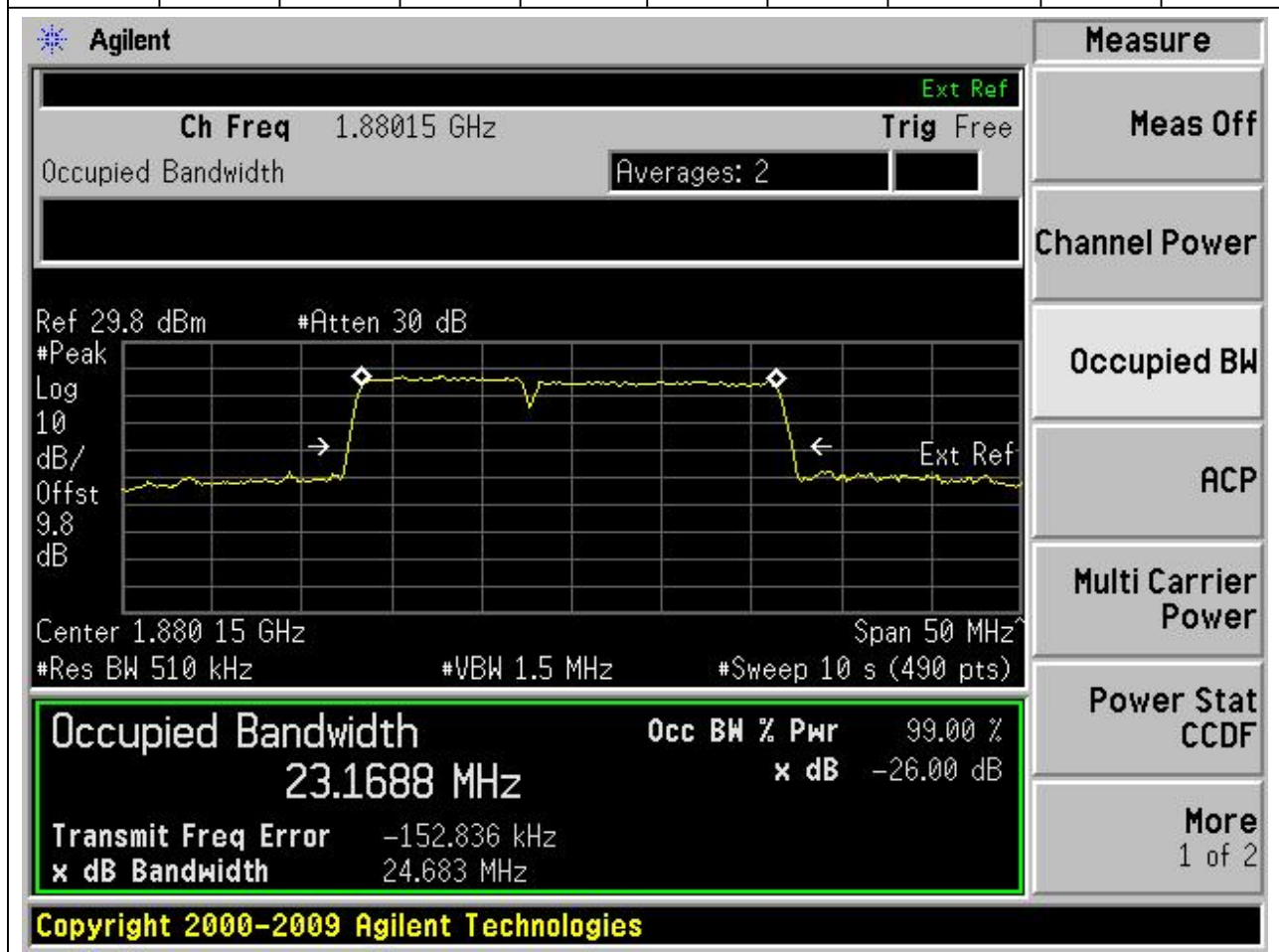
3.9. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18829|18949, Bandwidth:10|15MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1880.15	99	26	0.51	Peak	9.8	23.17	24.68	25	Pass



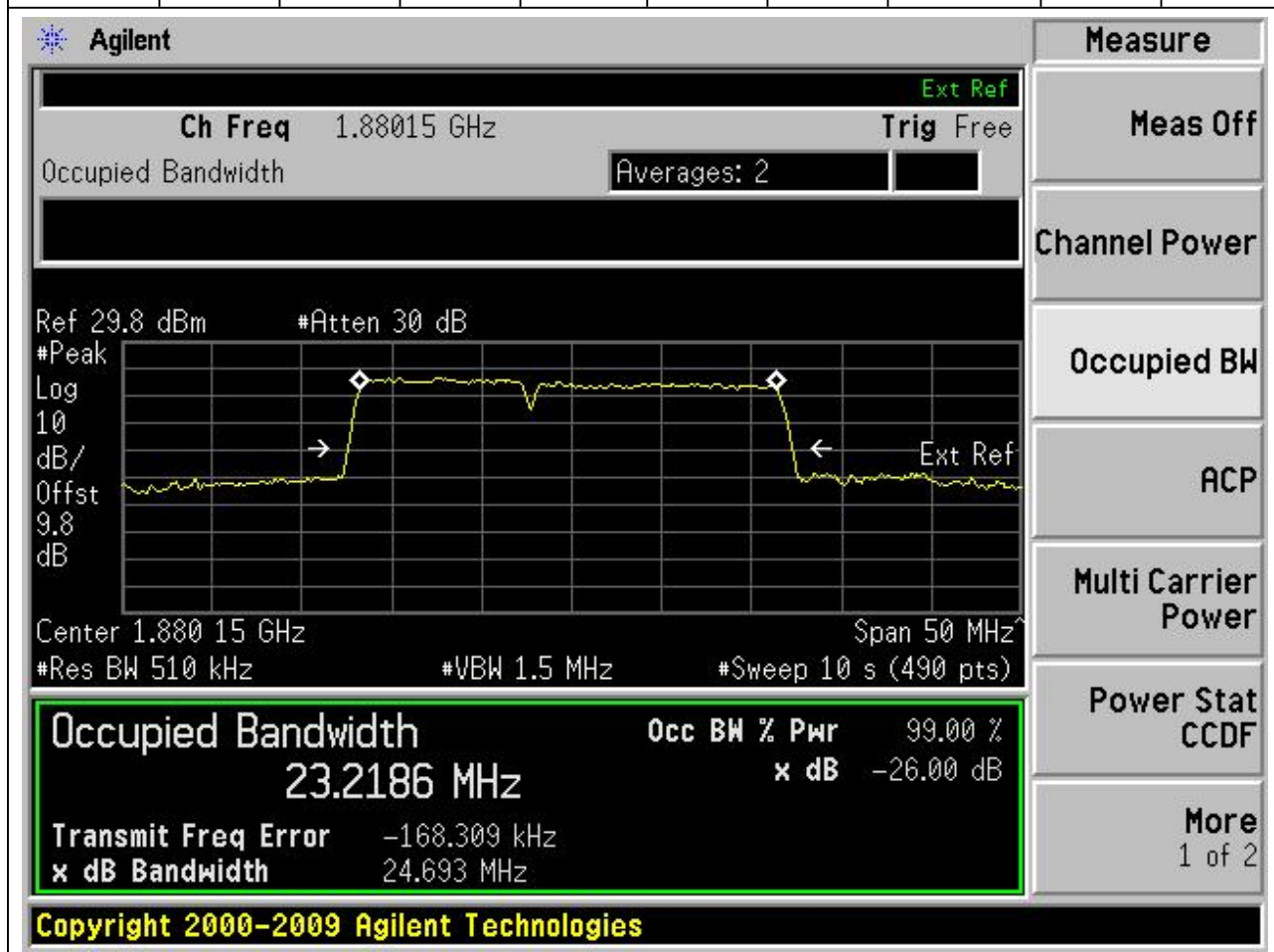
3.10. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18829|18949, Bandwidth:10|15MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1880.15	99	26	0.51	Peak	9.8	23.22	24.69	25	Pass



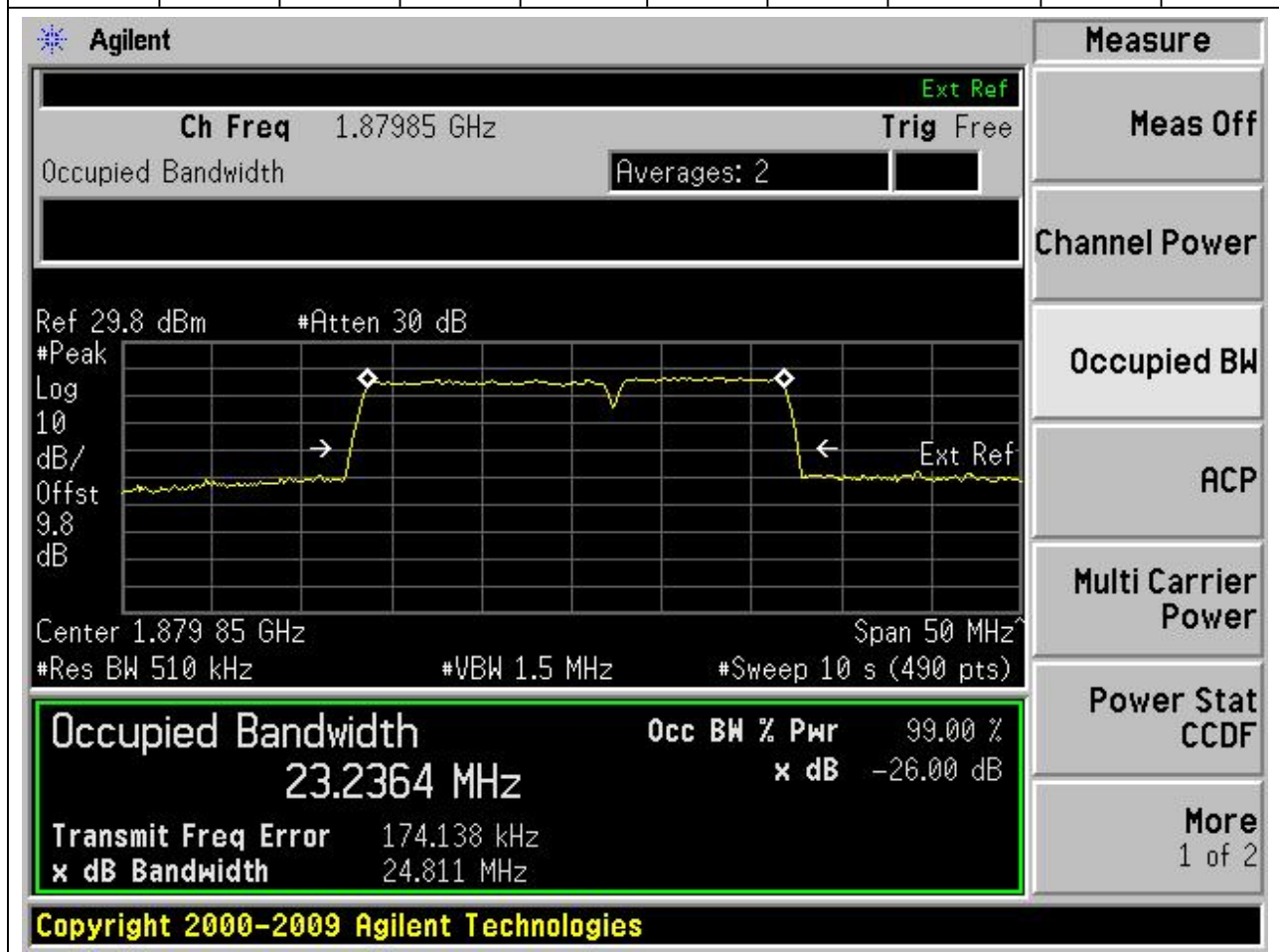
3.11. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18851|18971, Bandwidth:15|10MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1879.85	99	26	0.51	Peak	9.8	23.24	24.81	25	Pass



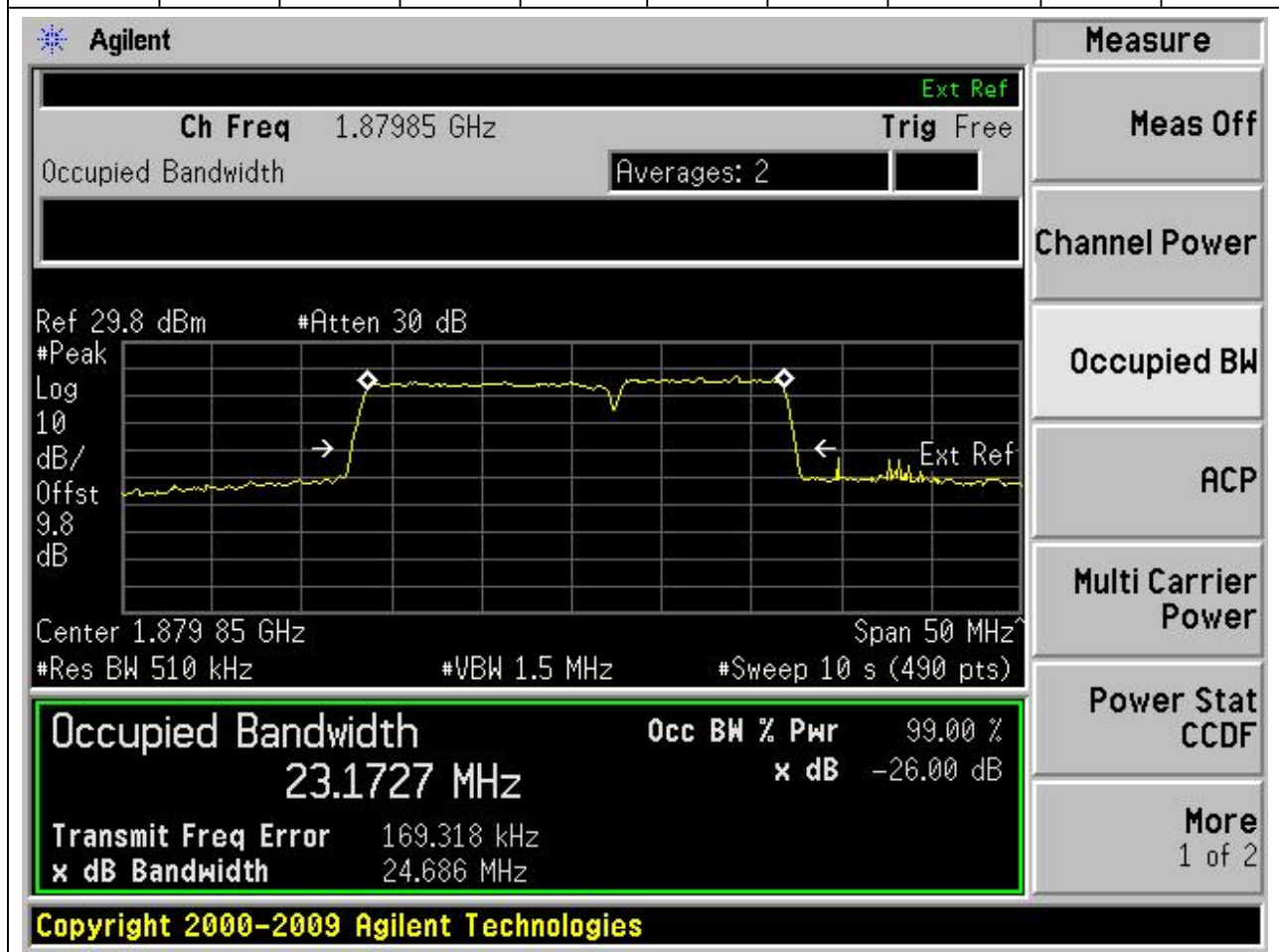
3.12. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18851|18971, Bandwidth:15|10MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1879.85	99	26	0.51	Peak	9.8	23.17	24.69	25	Pass



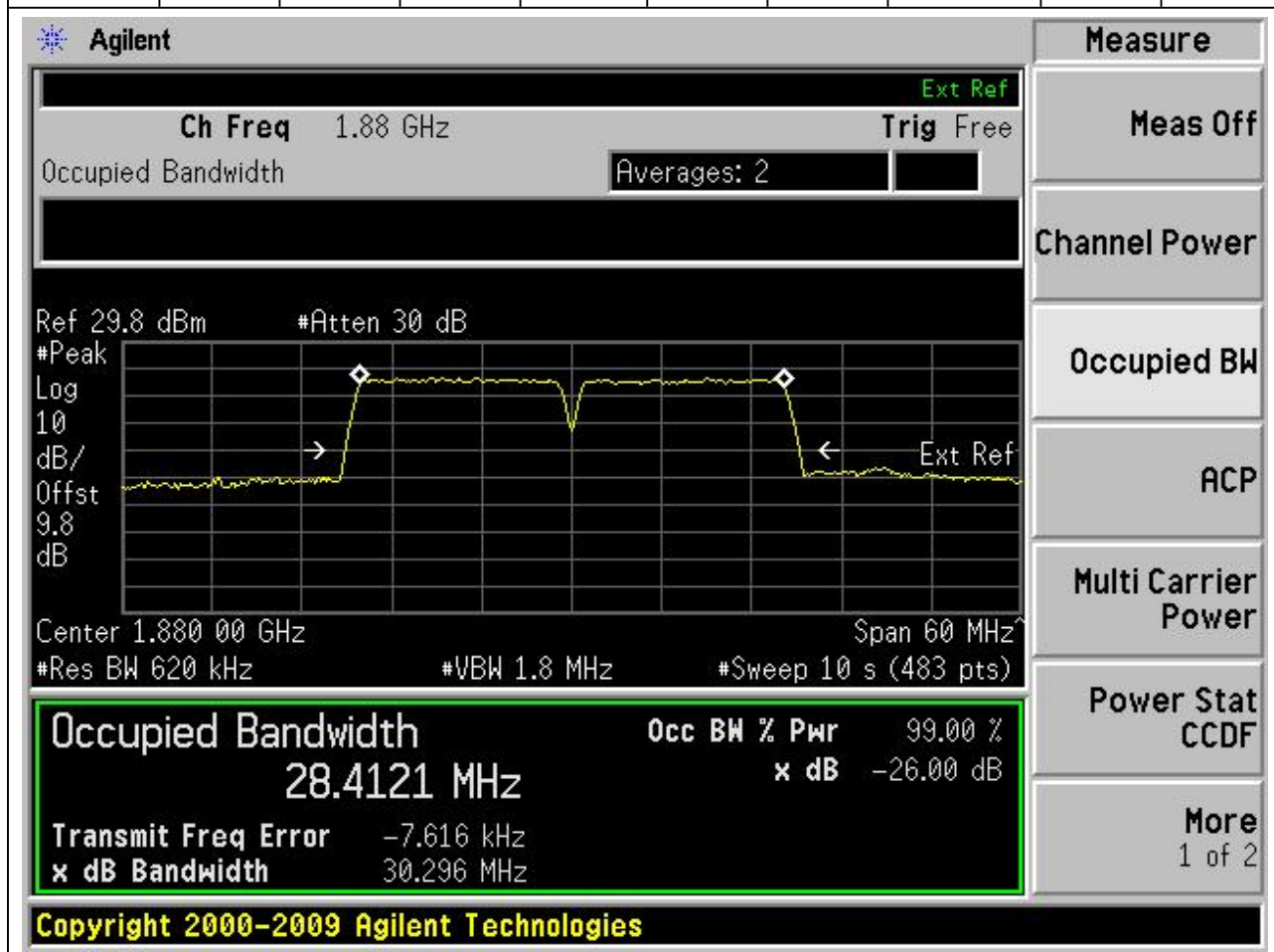
3.13. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18825|18975, Bandwidth:15|15MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1880	99	26	0.62	Peak	9.8	28.41	30.3	30	Pass



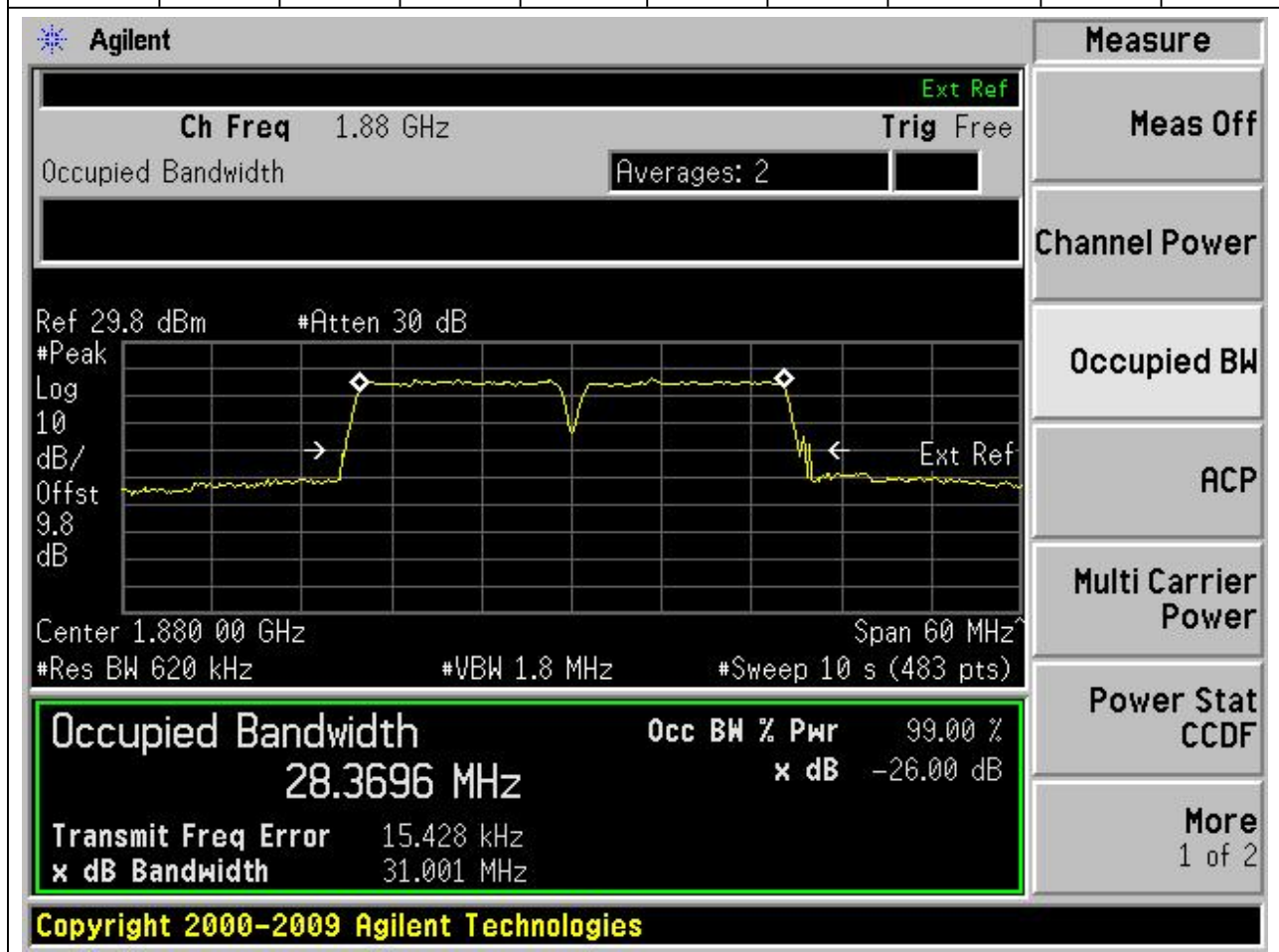
3.14. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18825|18975, Bandwidth:15|15MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1880	99	26	0.62	Peak	9.8	28.37	31	30	Pass



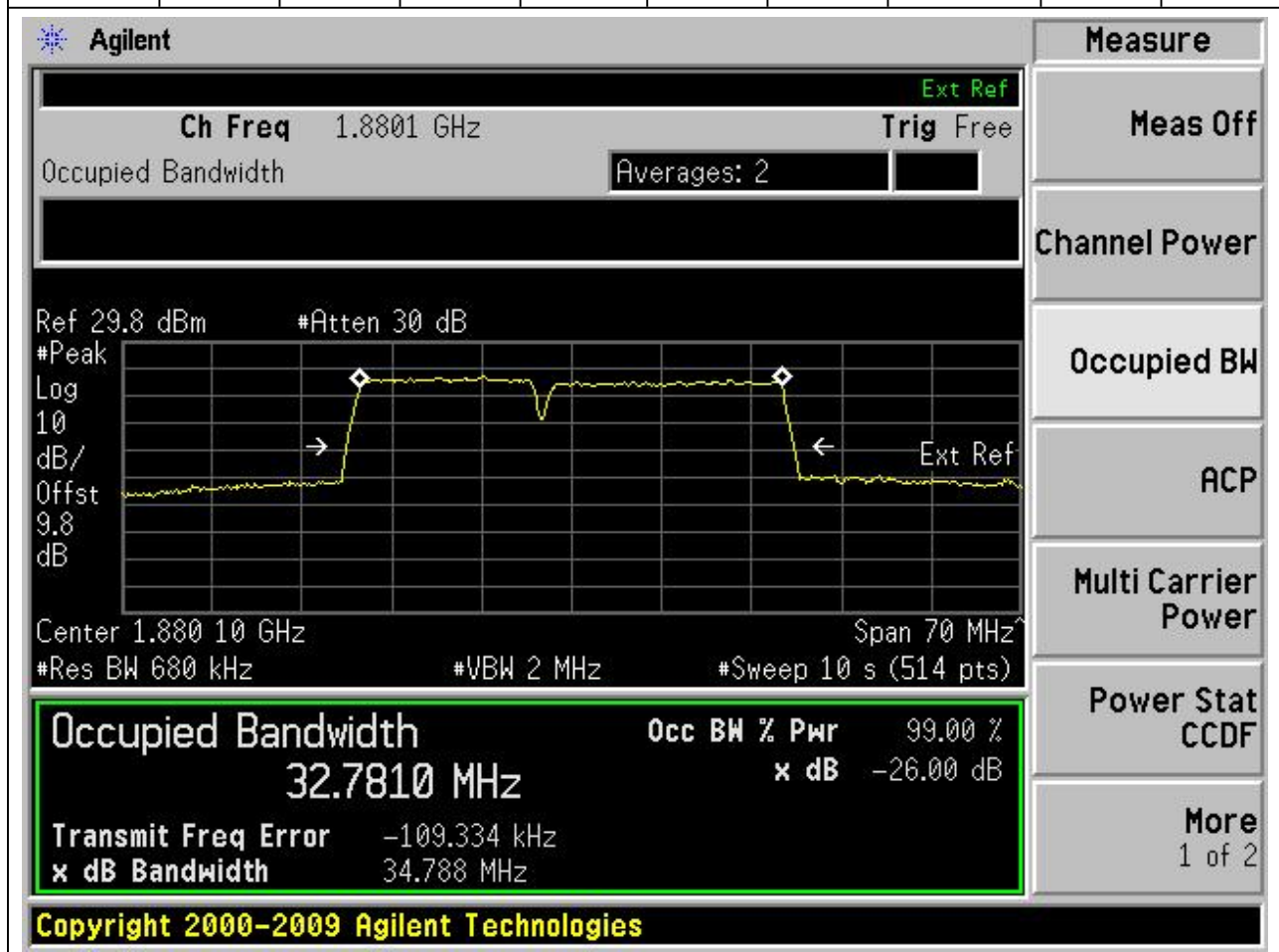
3.15. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18803|18974, Bandwidth:15|20MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1880.1	99	26	0.68	Peak	9.8	32.78	34.79	35	Pass



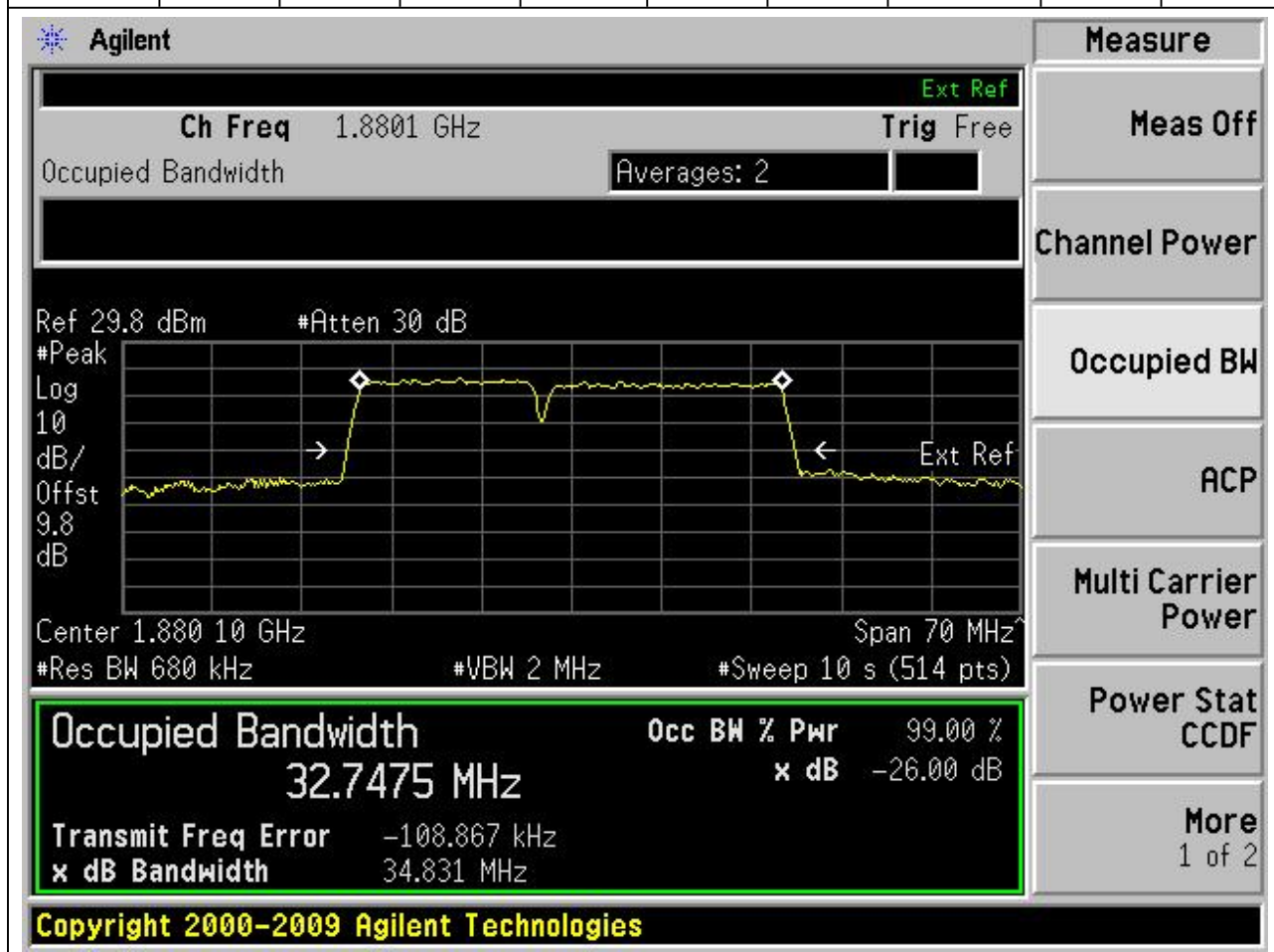
3.16. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18803|18974, Bandwidth:15|20MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1880.1	99	26	0.68	Peak	9.8	32.75	34.83	35	Pass



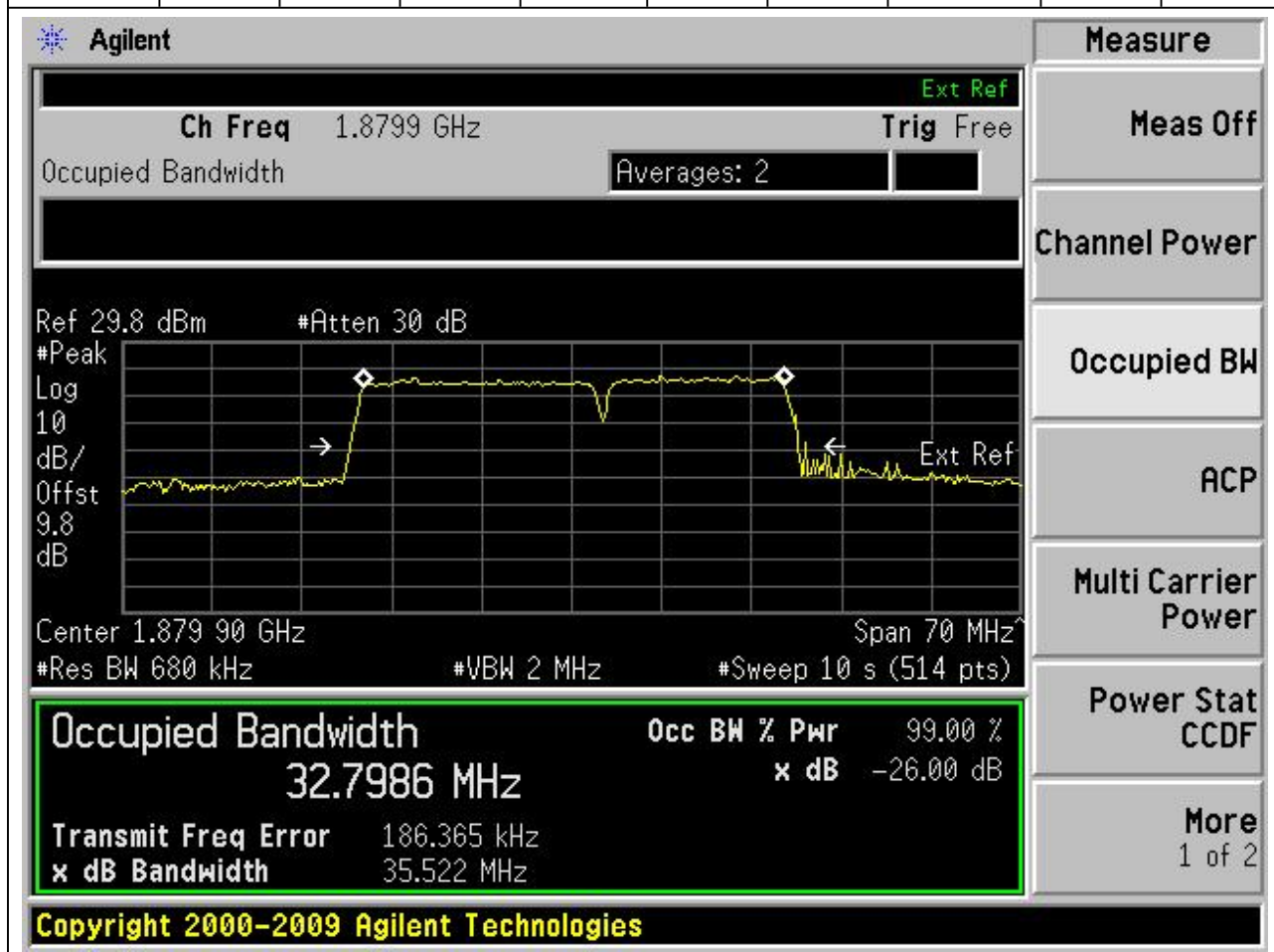
3.17. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18826|18997, Bandwidth:20|15MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1879.9	99	26	0.68	Peak	9.8	32.8	35.52	35	Pass



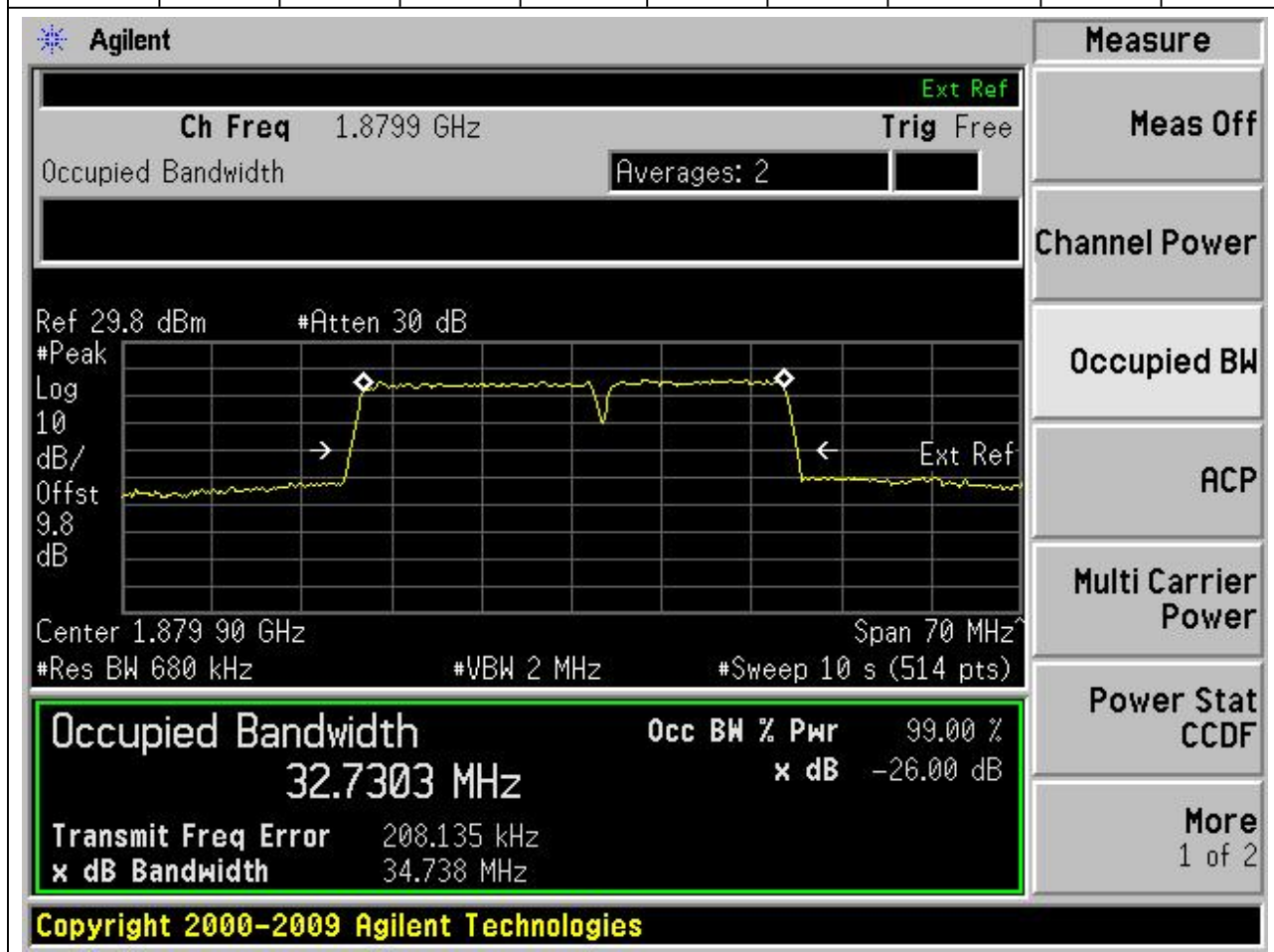
3.18. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18826|18997, Bandwidth:20|15MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1879.9	99	26	0.68	Peak	9.8	32.73	34.74	35	Pass



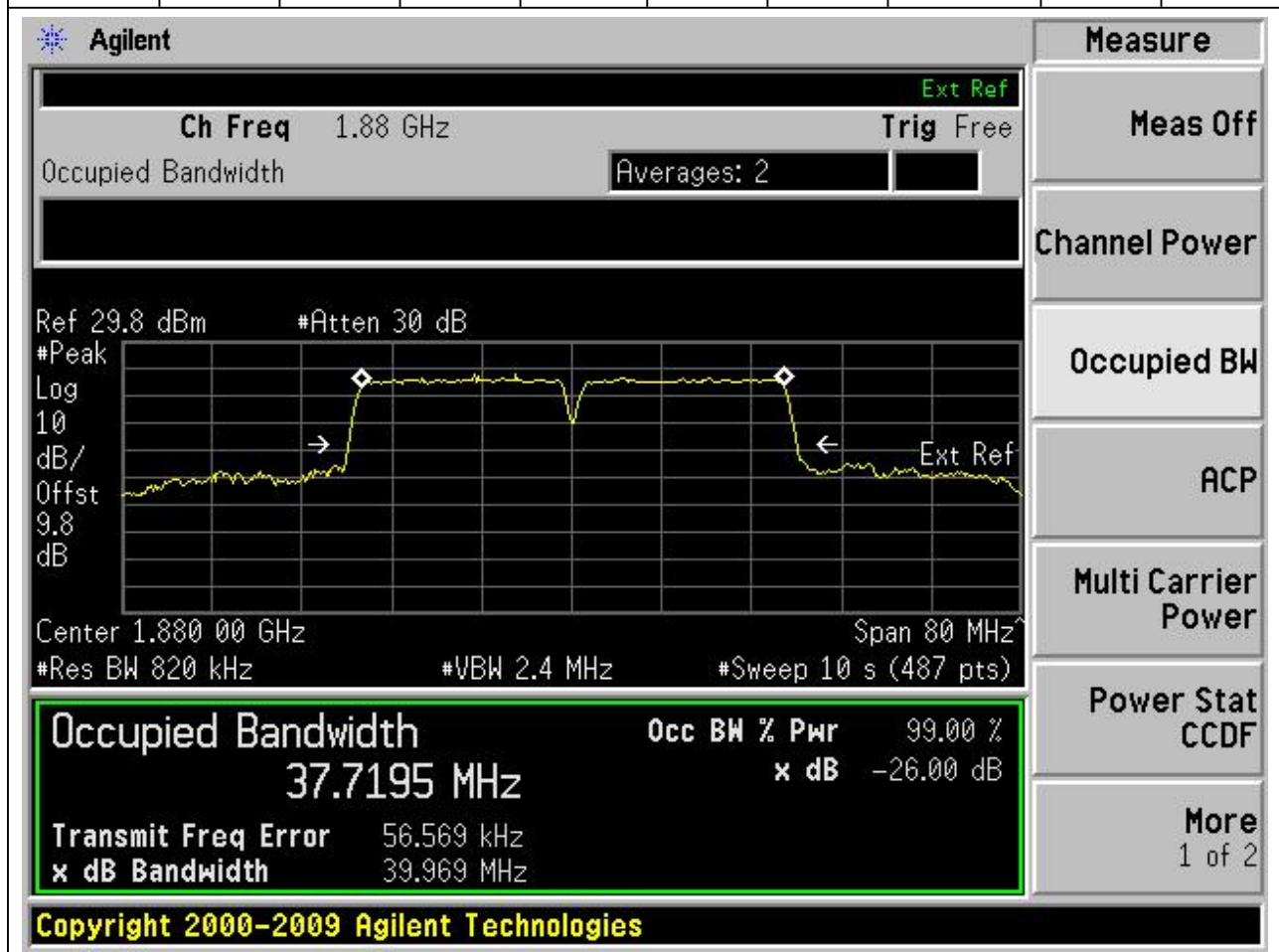
3.19. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18801|18999, Bandwidth:20|20MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1880	99	26	0.82	Peak	9.8	37.72	39.97	40	Pass



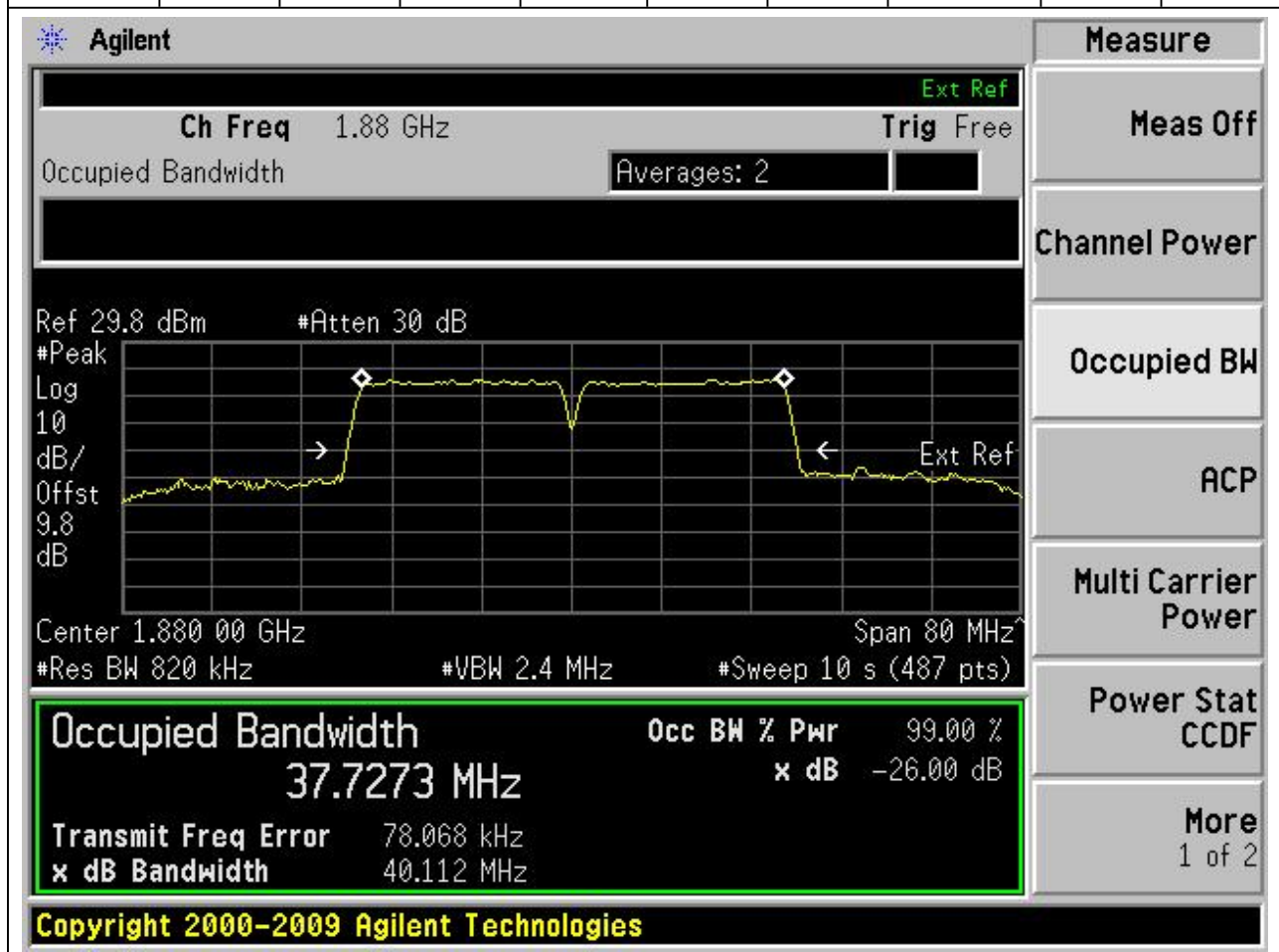
3.20. LTE-A Occupied Bandwidth_Part22-24-27(Channel:18801|18999, Bandwidth:20|20MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
1880	99	26	0.82	Peak	9.8	37.73	40.11	40	Pass



4. CA_5B

EUT Sample No.:	
EUT Name:	
EUT Manufacturer:	
EUT Model:	
EUT Serial Number:	
EUT Hardware Version:	
EUT Software Version:	
Low Temperature(LT):	-10 °C
Normal Temperature(NT):	+25 °C
High Temperature(HT):	+55 °C
Low Voltage(LV):	3.6 V
Normal Voltage(NV):	3.8 V
High Voltage(HV):	4.2 V

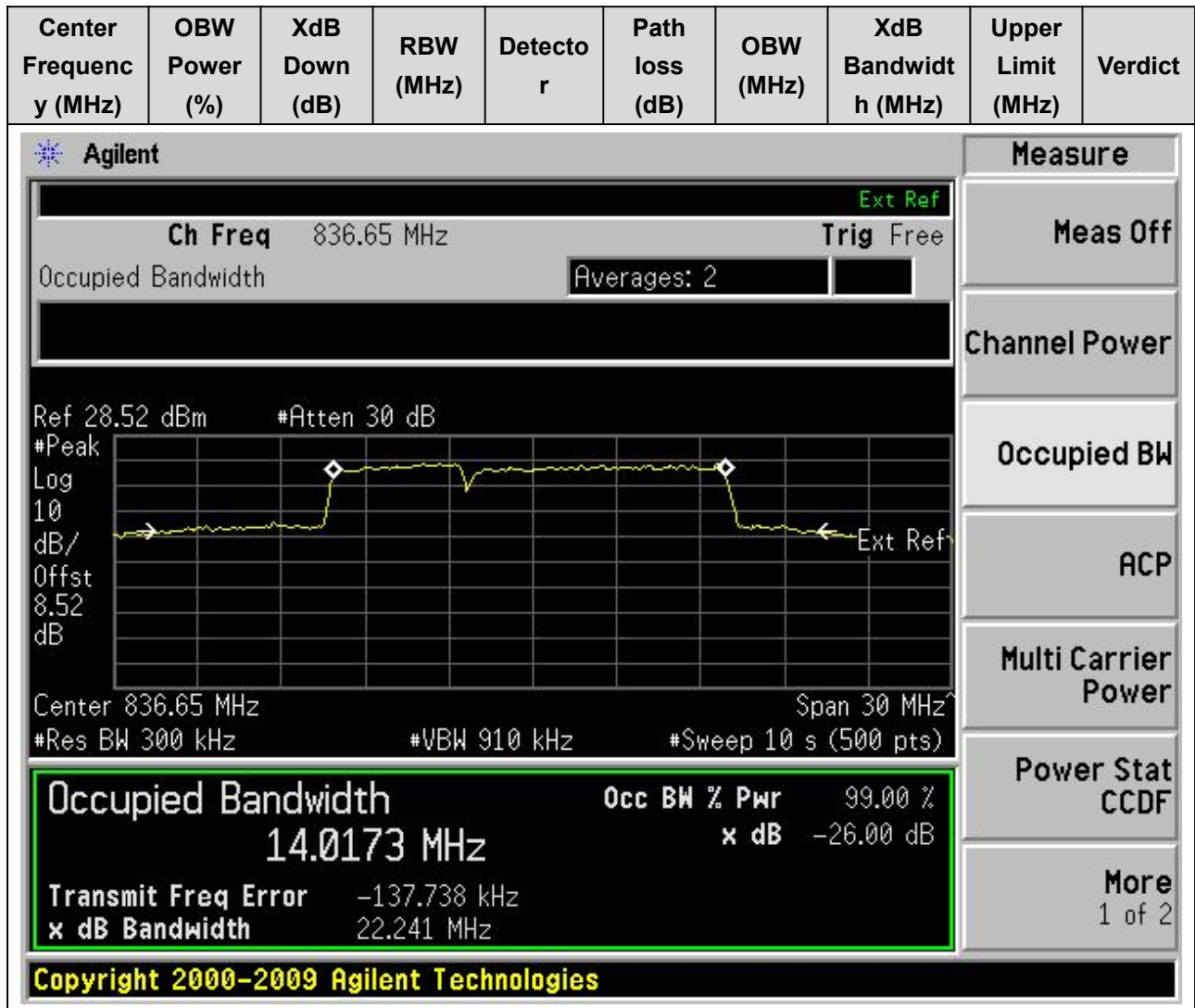
4.1. LTE-A Occupied Bandwidth_Part22-24-27(Channel:20478|20550, Bandwidth:5|10MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
836.65	99	26	0.3	Peak	8.52	14.02	22.24	15	Pass



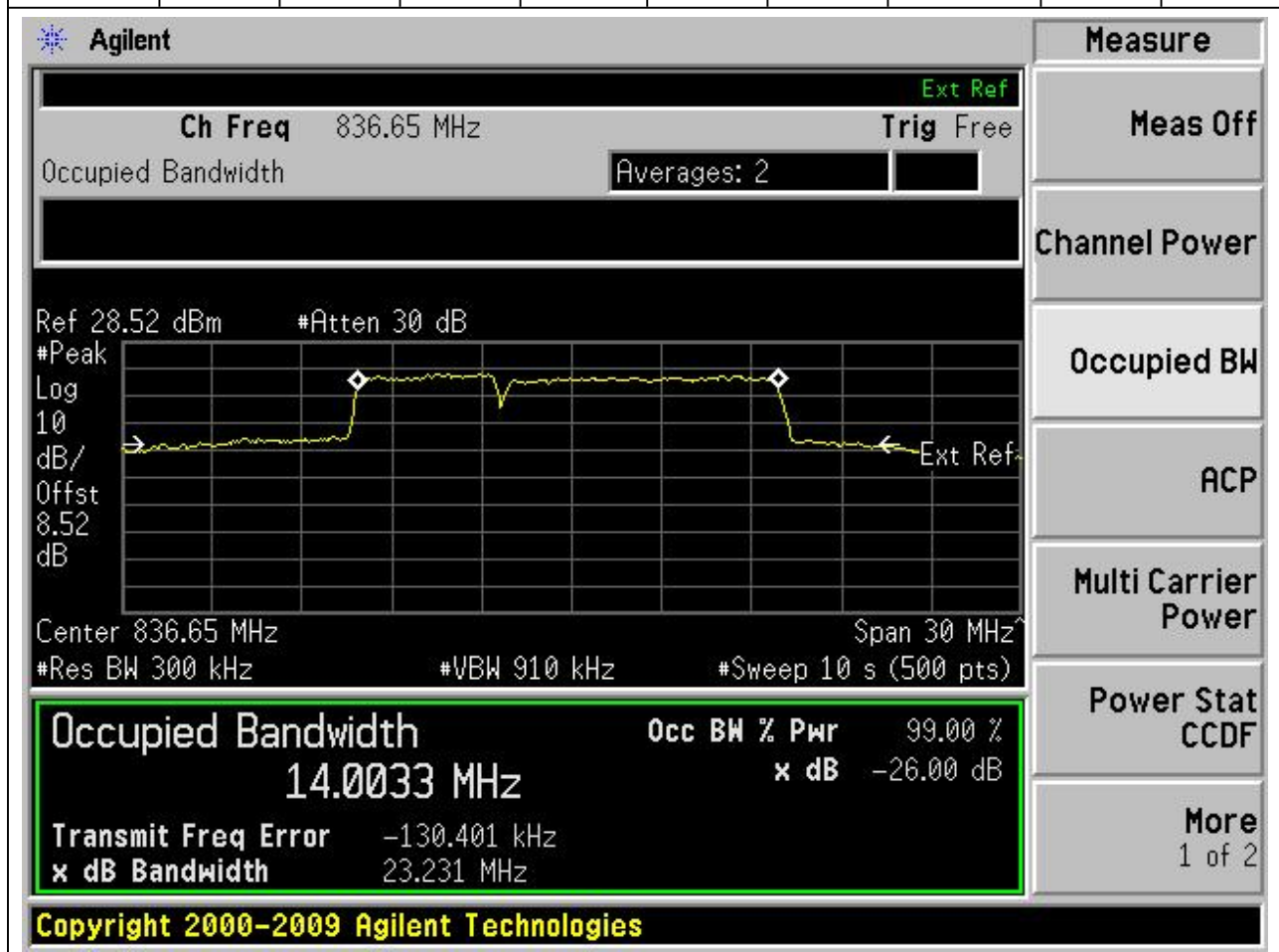
4.2. LTE-A Occupied Bandwidth_Part22-24-27(Channel:20478|20550, Bandwidth:5|10MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
836.65	99	26	0.3	Peak	8.52	14	23.23	15	Pass



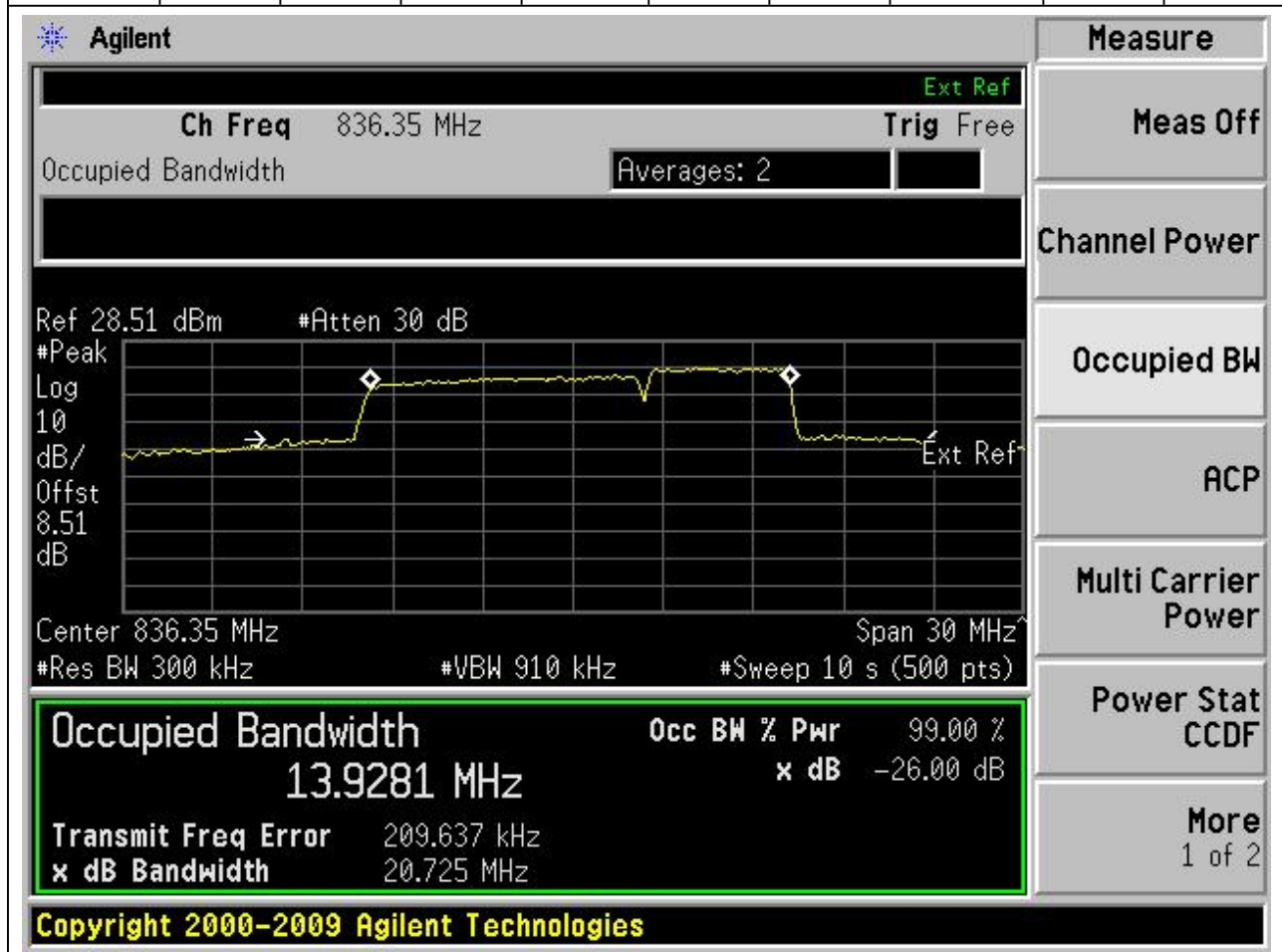
4.3. LTE-A Occupied Bandwidth_Part22-24-27(Channel:20500|20572, Bandwidth:10|5MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
836.35	99	26	0.3	Peak	8.51	13.93	20.72	15	Pass



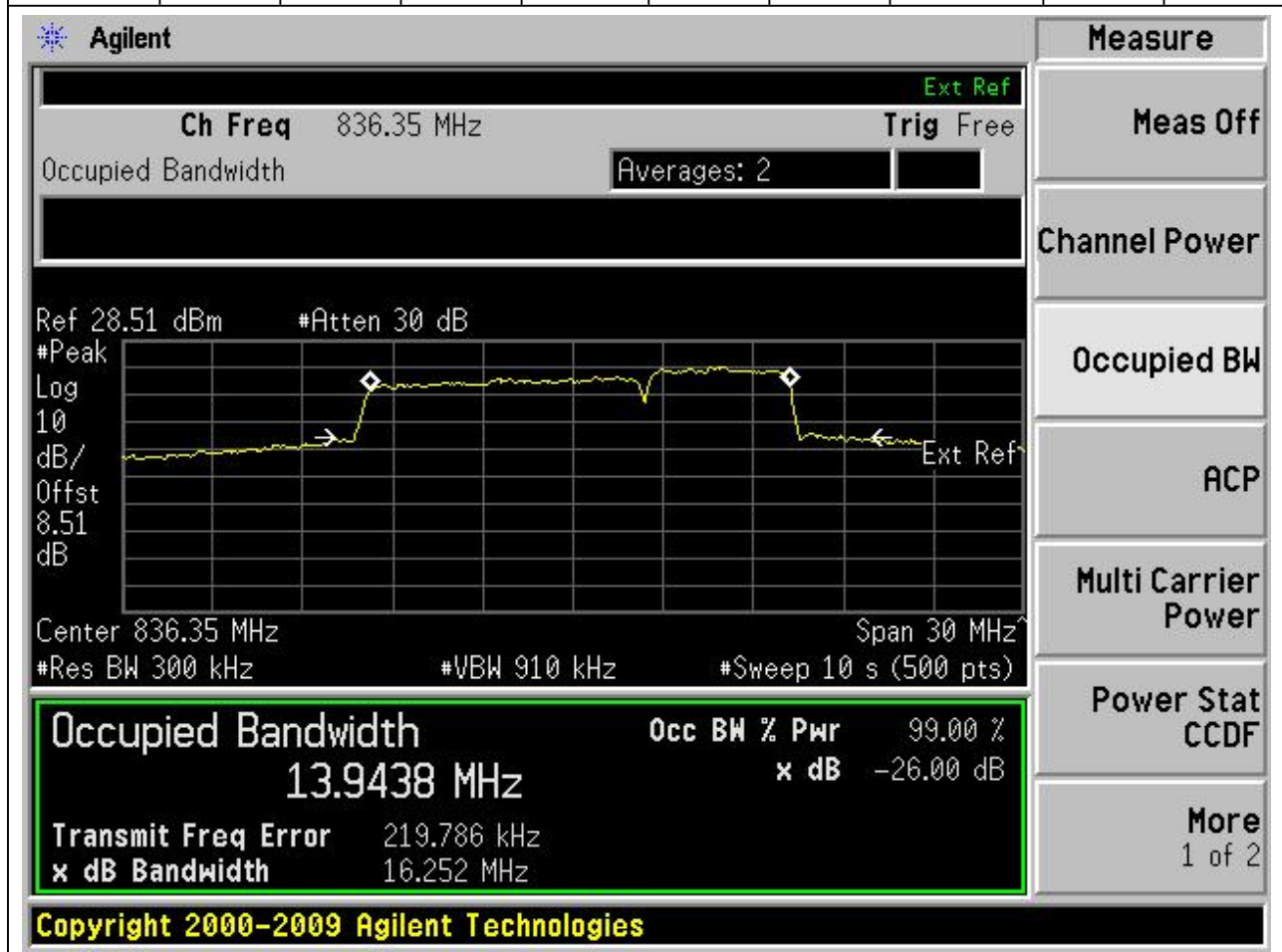
4.4. LTE-A Occupied Bandwidth_Part22-24-27(Channel:20500|20572, Bandwidth:10|5MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
836.35	99	26	0.3	Peak	8.51	13.94	16.25	15	Pass



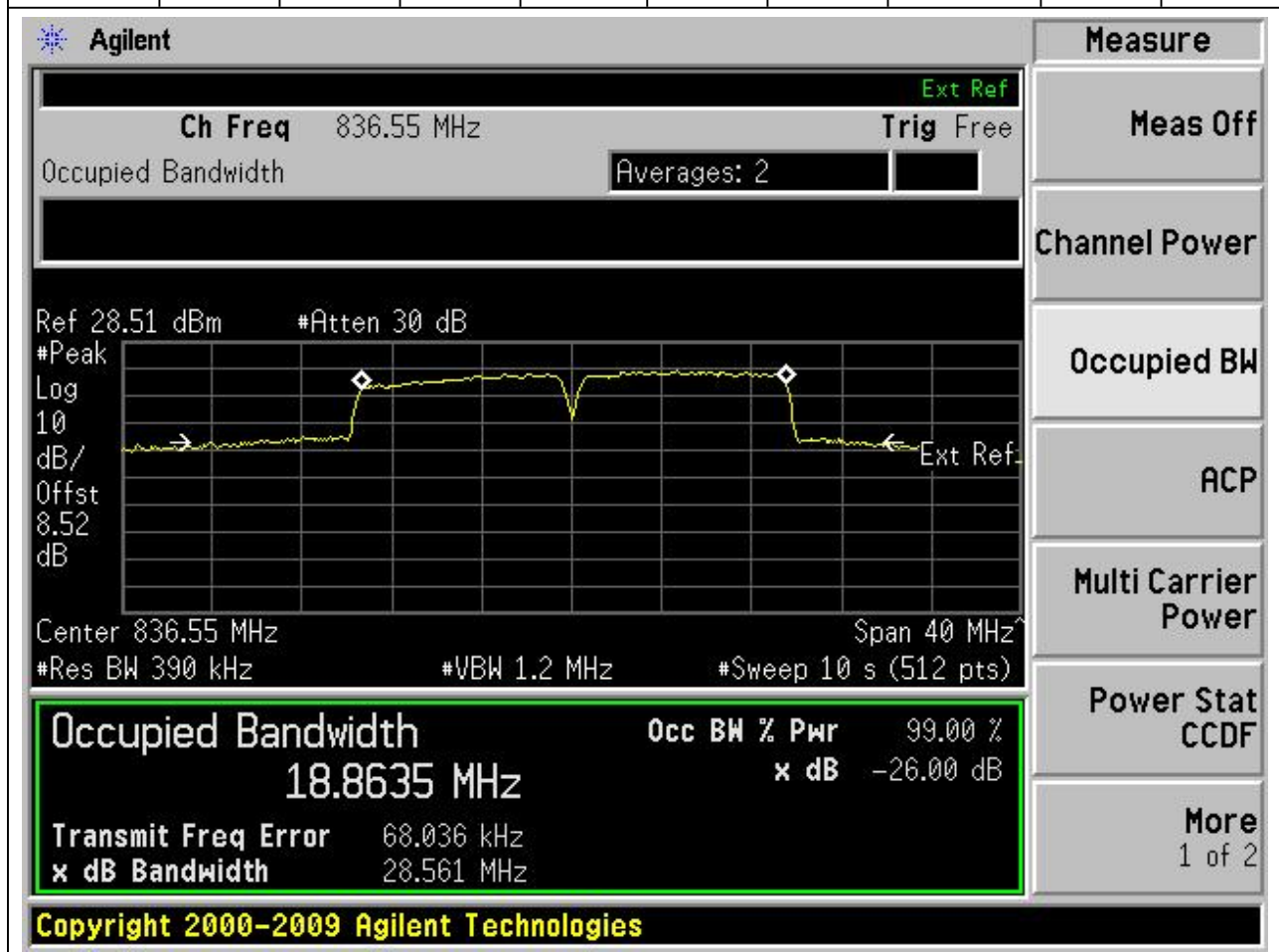
4.5. LTE-A Occupied Bandwidth_Part22-24-27(Channel:20476|20575, Bandwidth:10|10MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
836.55	99	26	0.39	Peak	8.52	18.86	28.56	20	Pass



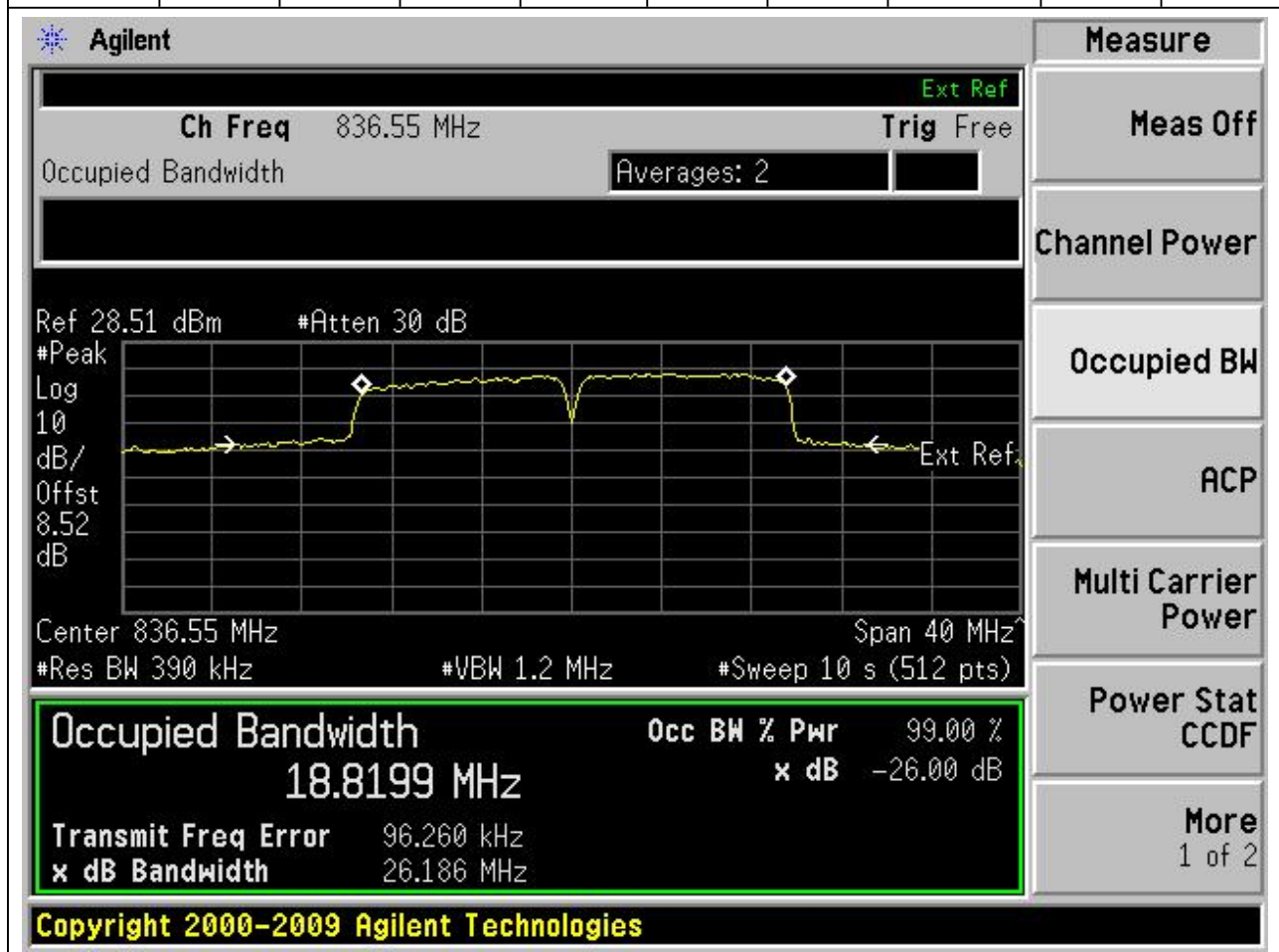
4.6. LTE-A Occupied Bandwidth_Part22-24-27(Channel:20476|20575, Bandwidth:10|10MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
836.55	99	26	0.39	Peak	8.52	18.82	26.19	20	Pass



5. CA_7C

EUT Sample No.:	
EUT Name:	
EUT Manufacturer:	
EUT Model:	
EUT Serial Number:	
EUT Hardware Version:	
EUT Software Version:	
Low Temperature(LT):	-10 °C
Normal Temperature(NT):	+25 °C
High Temperature(HT):	+55 °C
Low Voltage(LV):	3.6 V
Normal Voltage(NV):	3.8 V
High Voltage(HV):	4.2 V

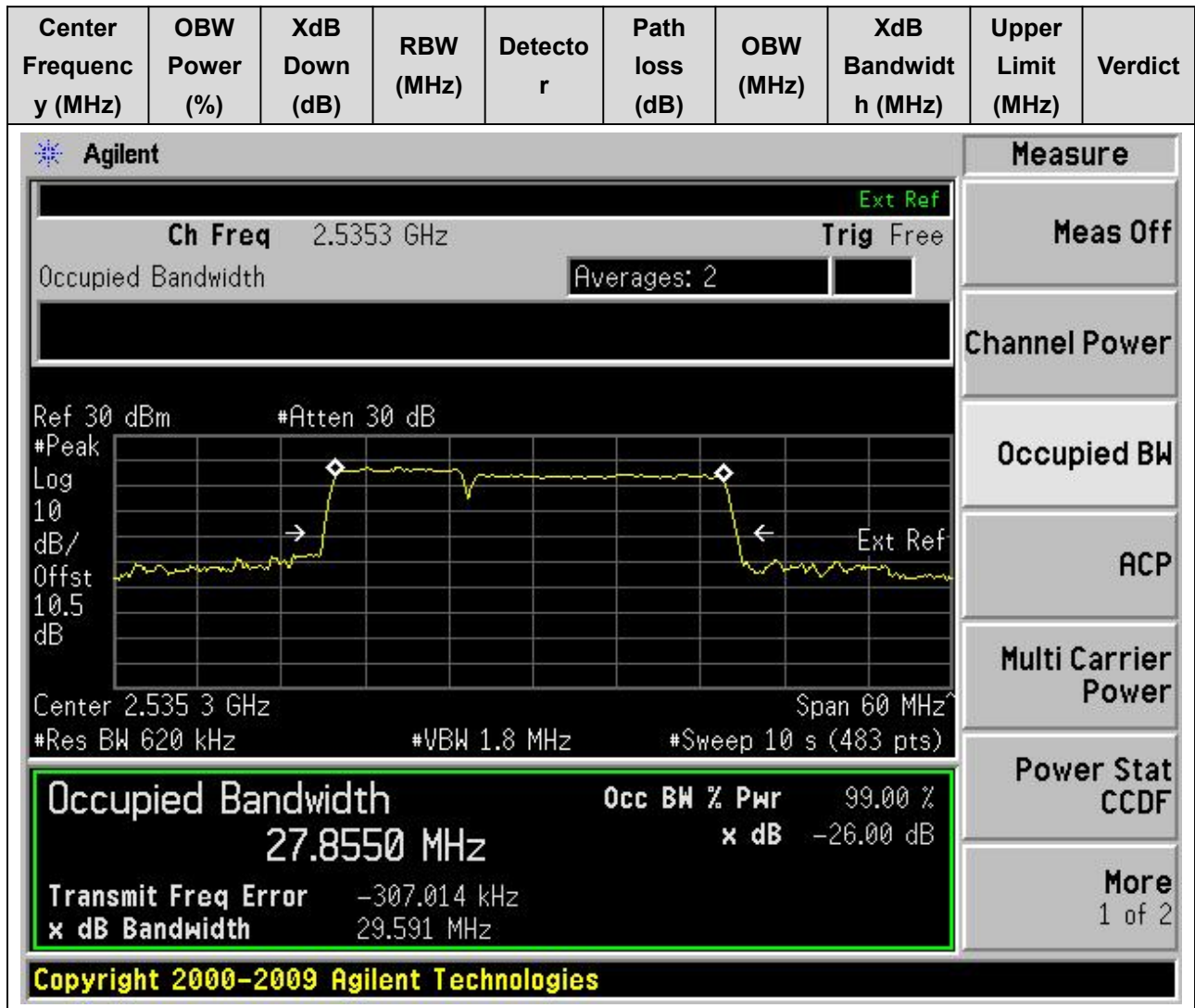
5.1. LTE-A Occupied Bandwidth_Part22-24-27(Channel:21006|21150, Bandwidth:10|20MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2535.3	99	26	0.62	Peak	10.46	27.86	29.59	30	Pass



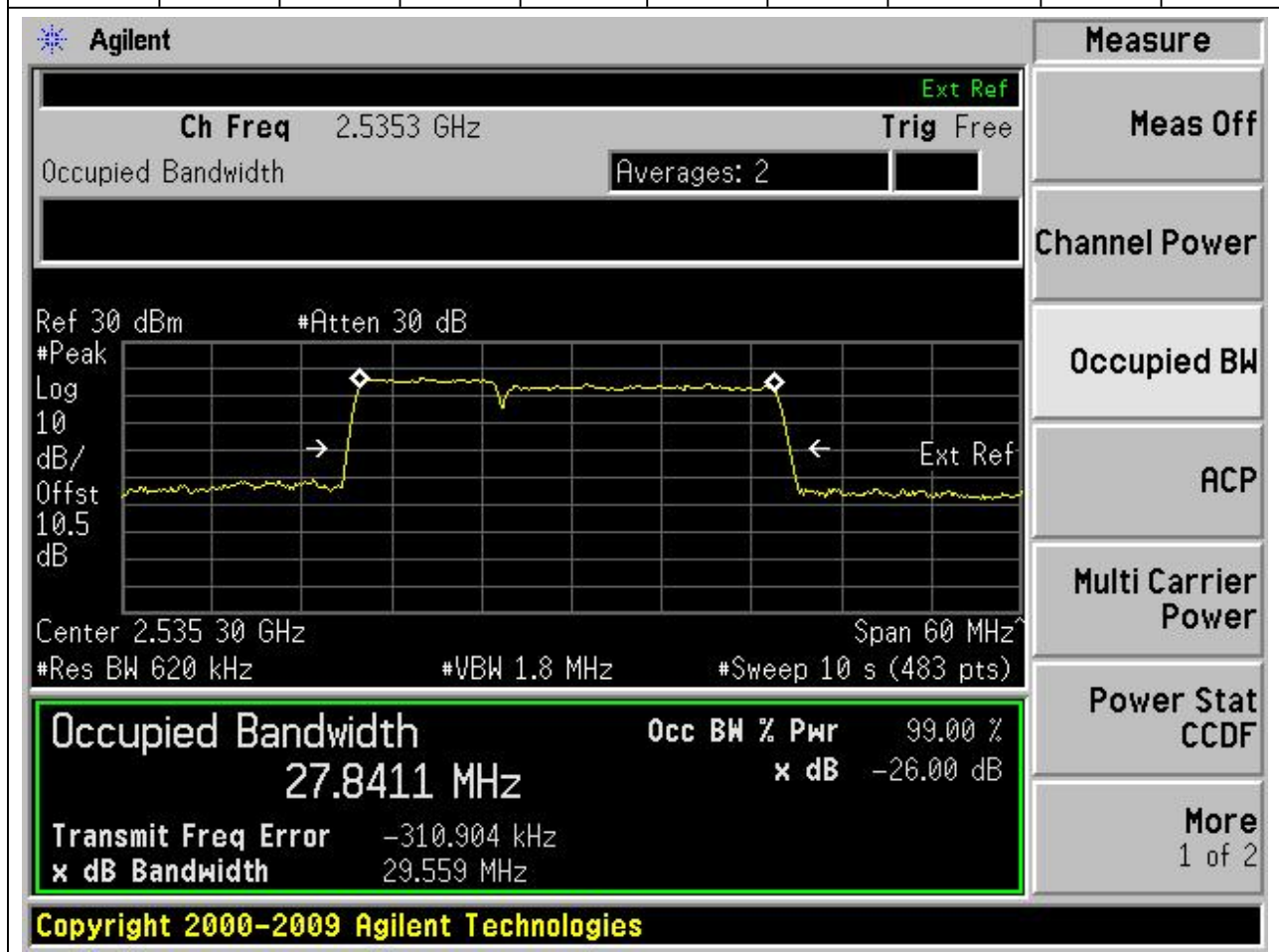
5.2. LTE-A Occupied Bandwidth_Part22-24-27(Channel:21006|21150, Bandwidth:10|20MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2535.3	99	26	0.62	Peak	10.46	27.84	29.56	30	Pass



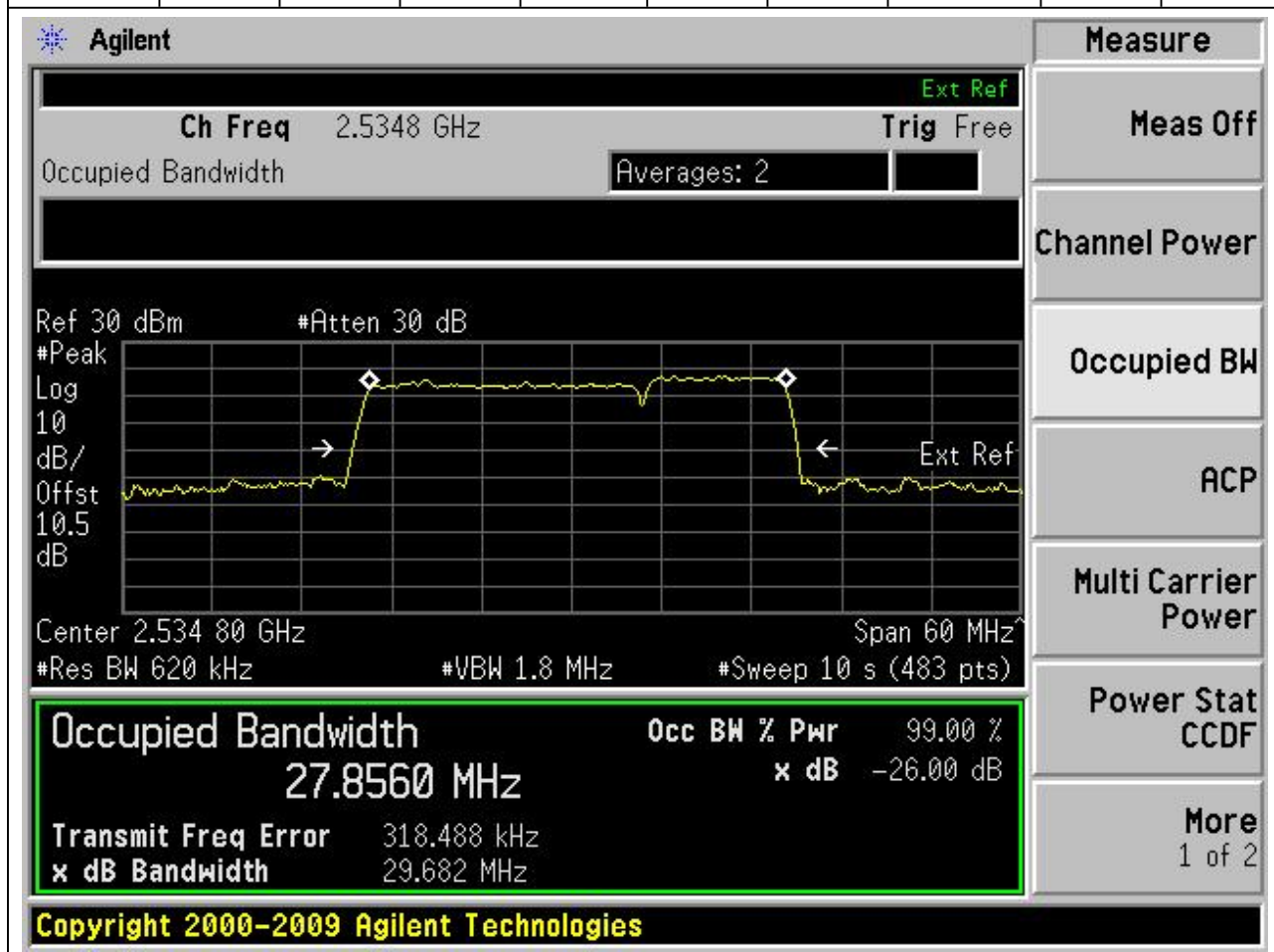
5.3. LTE-A Occupied Bandwidth_Part22-24-27(Channel:21051|21195, Bandwidth:20|10MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2534.8	99	26	0.62	Peak	10.46	27.86	29.68	30	Pass



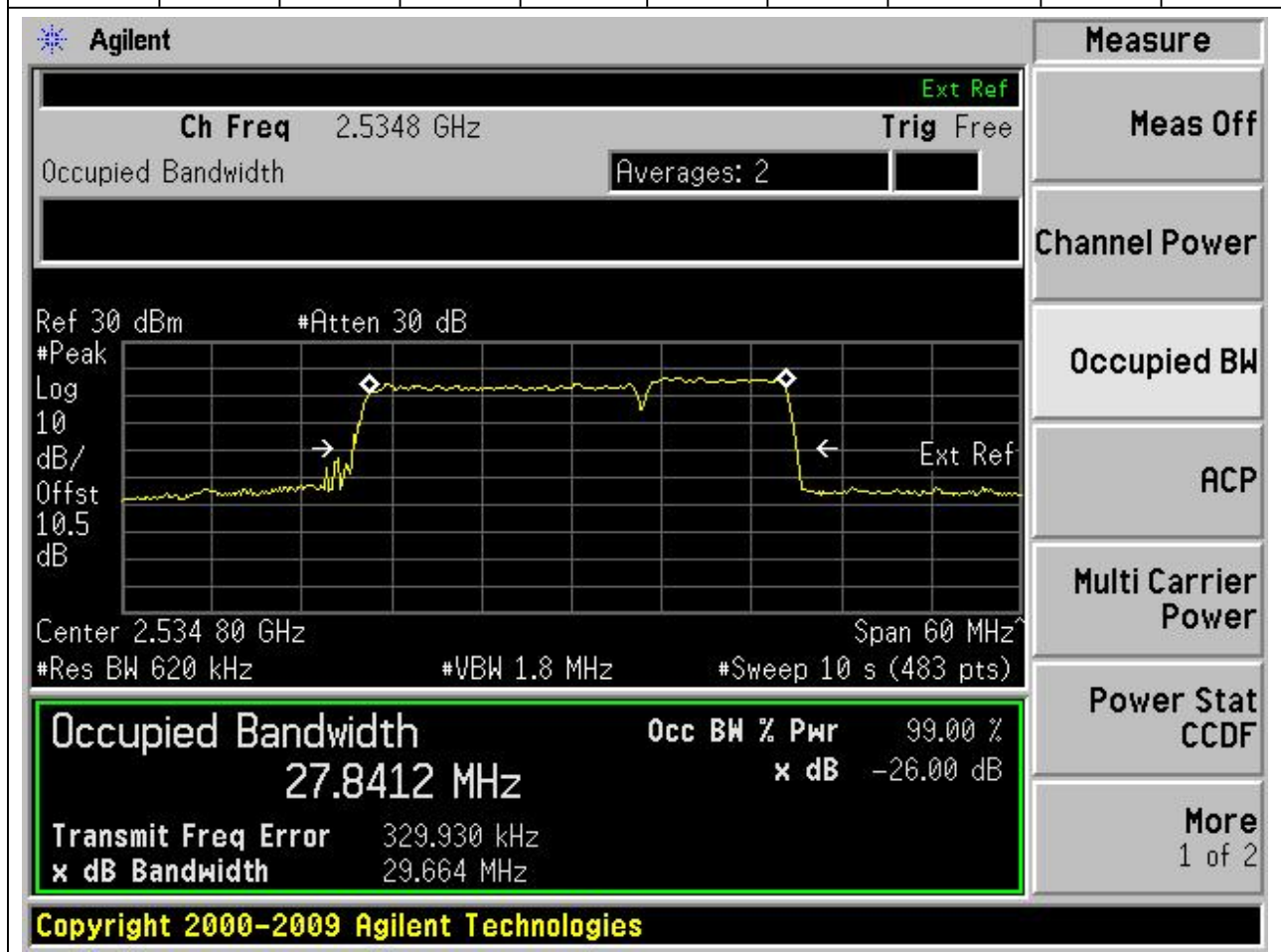
5.4. LTE-A Occupied Bandwidth_Part22-24-27(Channel:21051|21195, Bandwidth:20|10MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2534.8	99	26	0.62	Peak	10.46	27.84	29.66	30	Pass



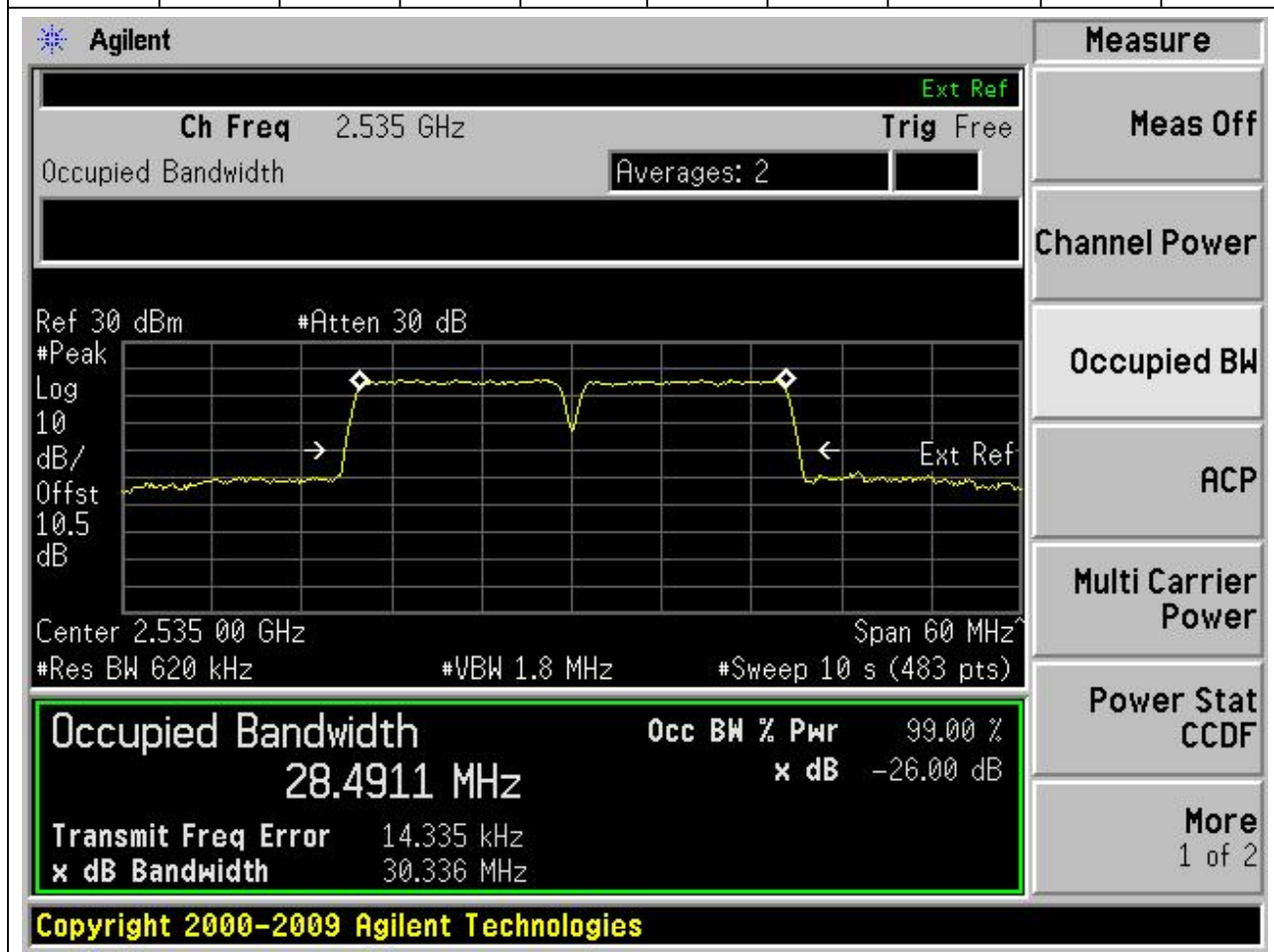
5.5. LTE-A Occupied Bandwidth_Part22-24-27(Channel:21025|21175, Bandwidth:15|15MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2535	99	26	0.62	Peak	10.46	28.49	30.34	30	Pass



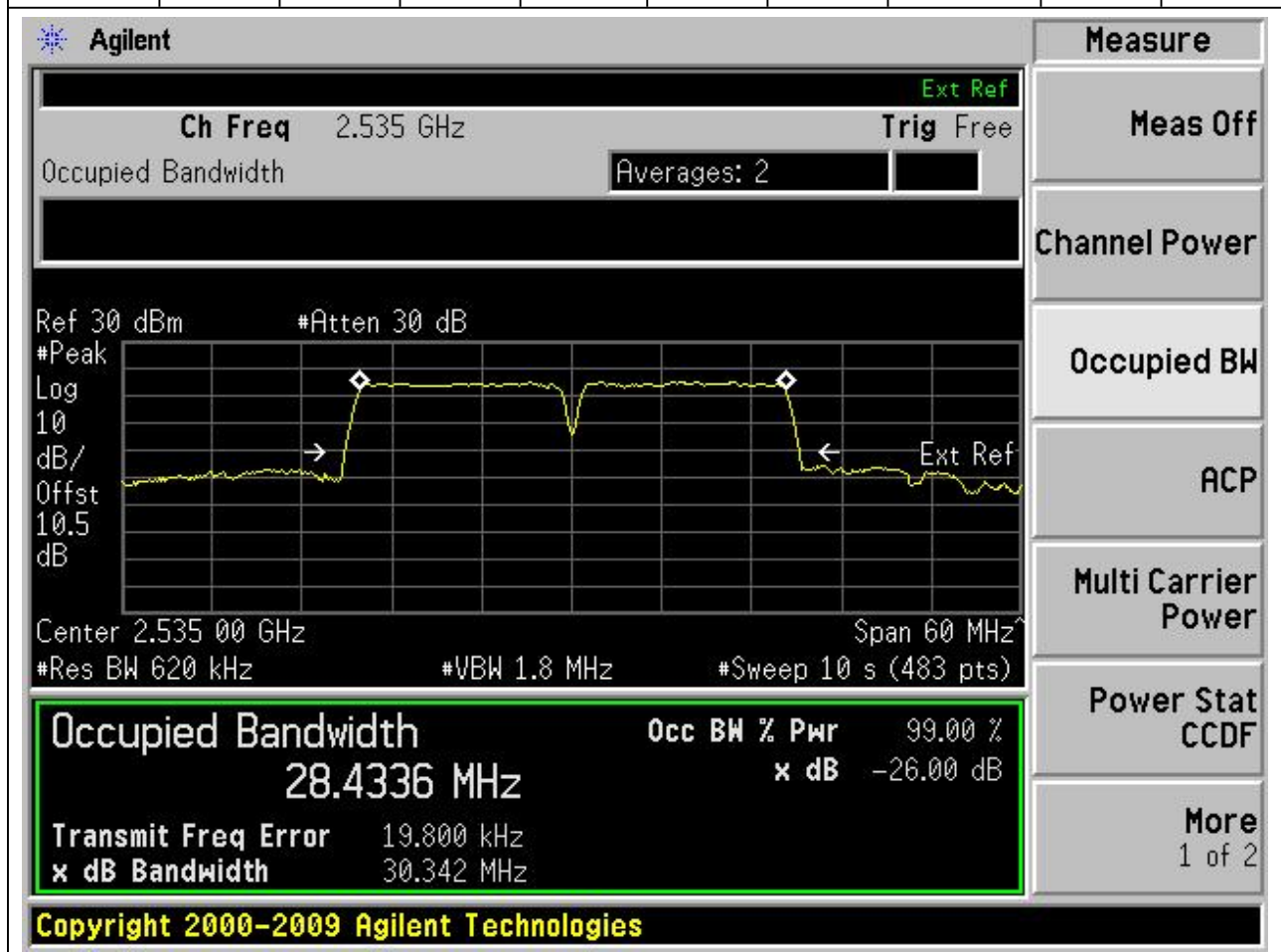
5.6. LTE-A Occupied Bandwidth_Part22-24-27(Channel:21025|21175, Bandwidth:15|15MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2535	99	26	0.62	Peak	10.46	28.43	30.34	30	Pass



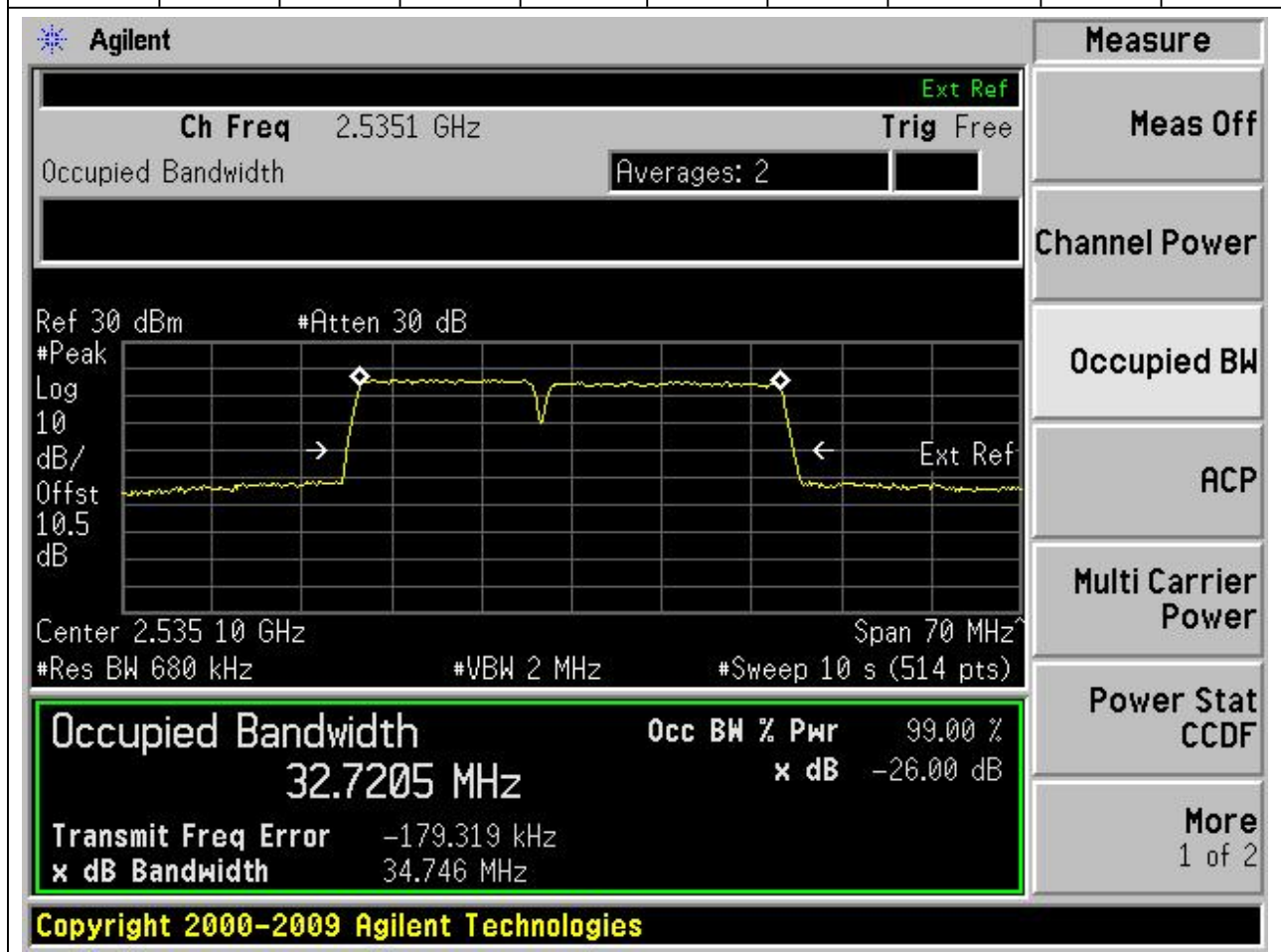
5.7. LTE-A Occupied Bandwidth_Part22-24-27(Channel:21003|21174, Bandwidth:15|20MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2535.1	99	26	0.68	Peak	10.46	32.72	34.75	35	Pass



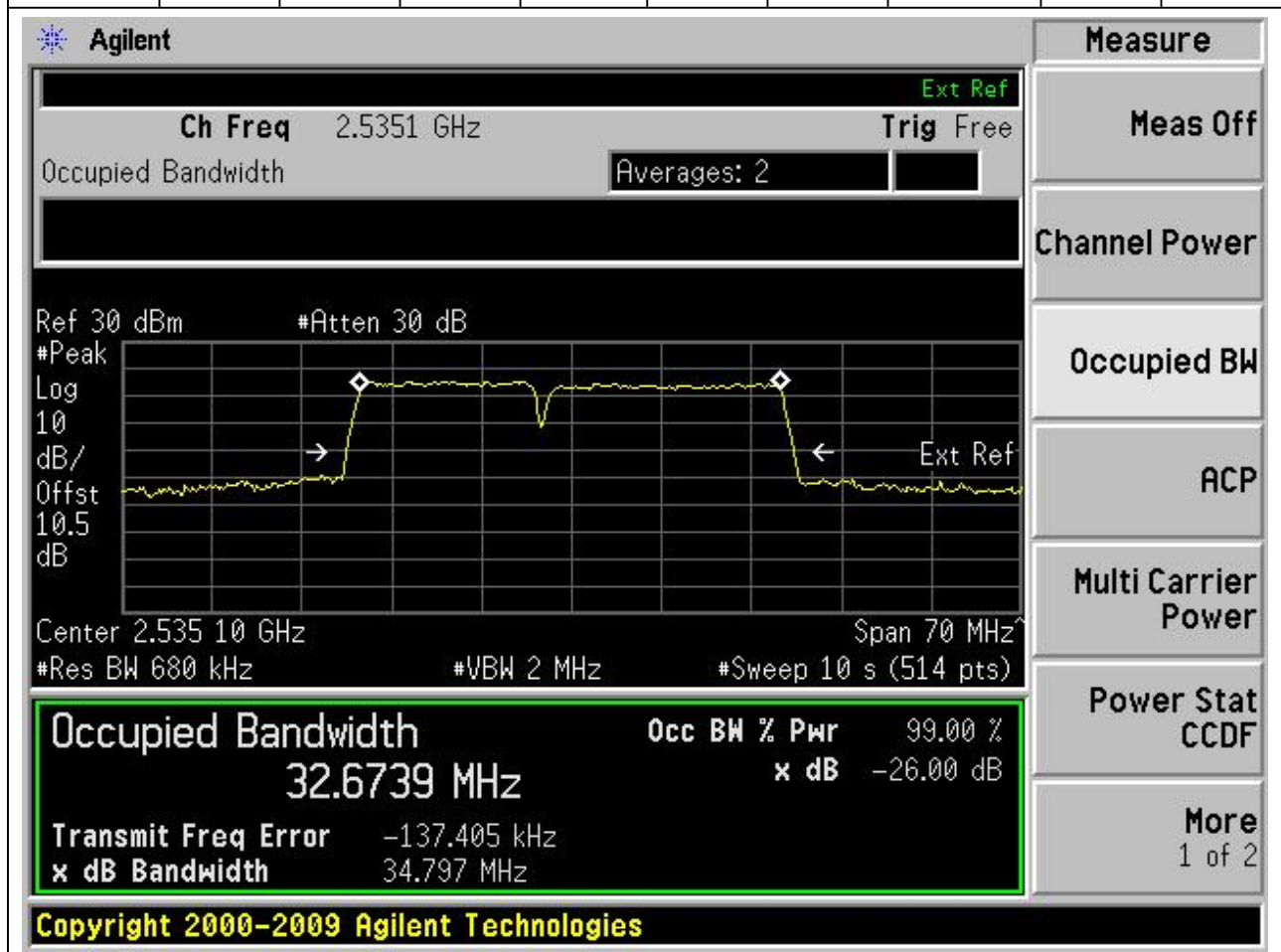
5.8. LTE-A Occupied Bandwidth_Part22-24-27(Channel:21003|21174, Bandwidth:15|20MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2535.1	99	26	0.68	Peak	10.46	32.67	34.8	35	Pass



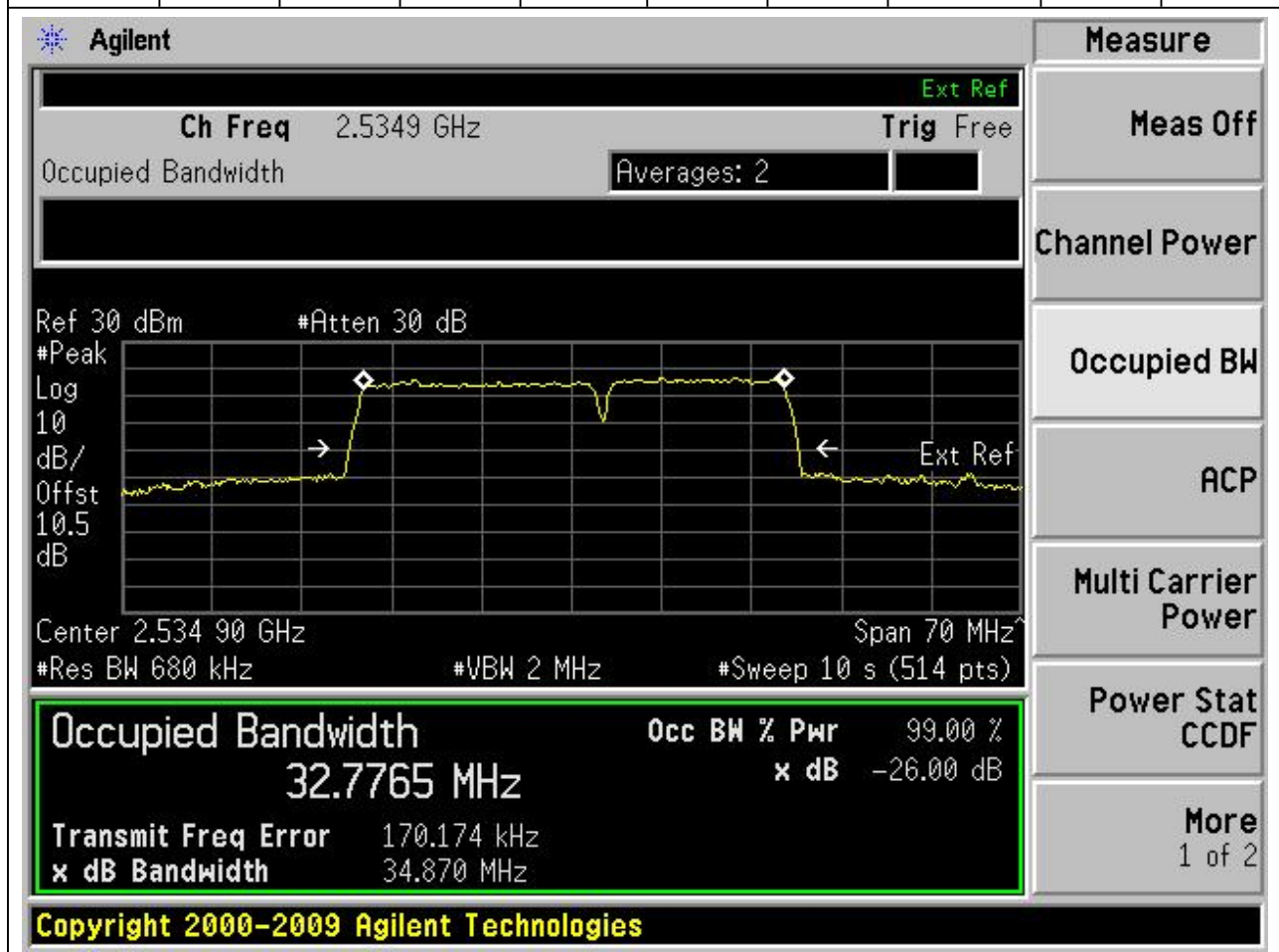
5.9. LTE-A Occupied Bandwidth_Part22-24-27(Channel:21026|21197, Bandwidth:20|15MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2534.9	99	26	0.68	Peak	10.46	32.78	34.87	35	Pass



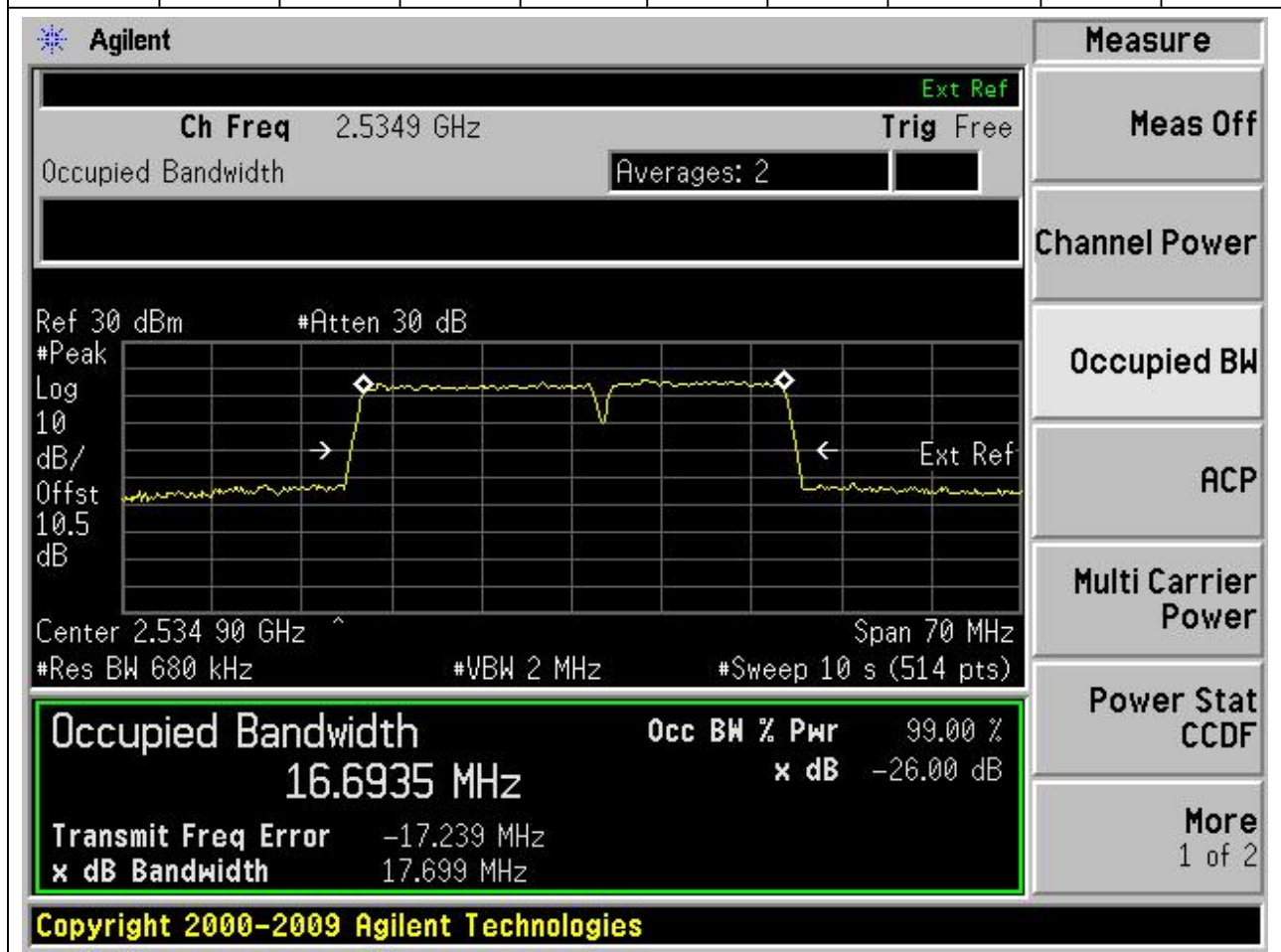
5.10. LTE-A Occupied Bandwidth_Part22-24-27(Channel:21026|21197, Bandwidth:20|15MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2534.9	99	26	0.68	Peak	10.46	16.69	17.7	35	Pass



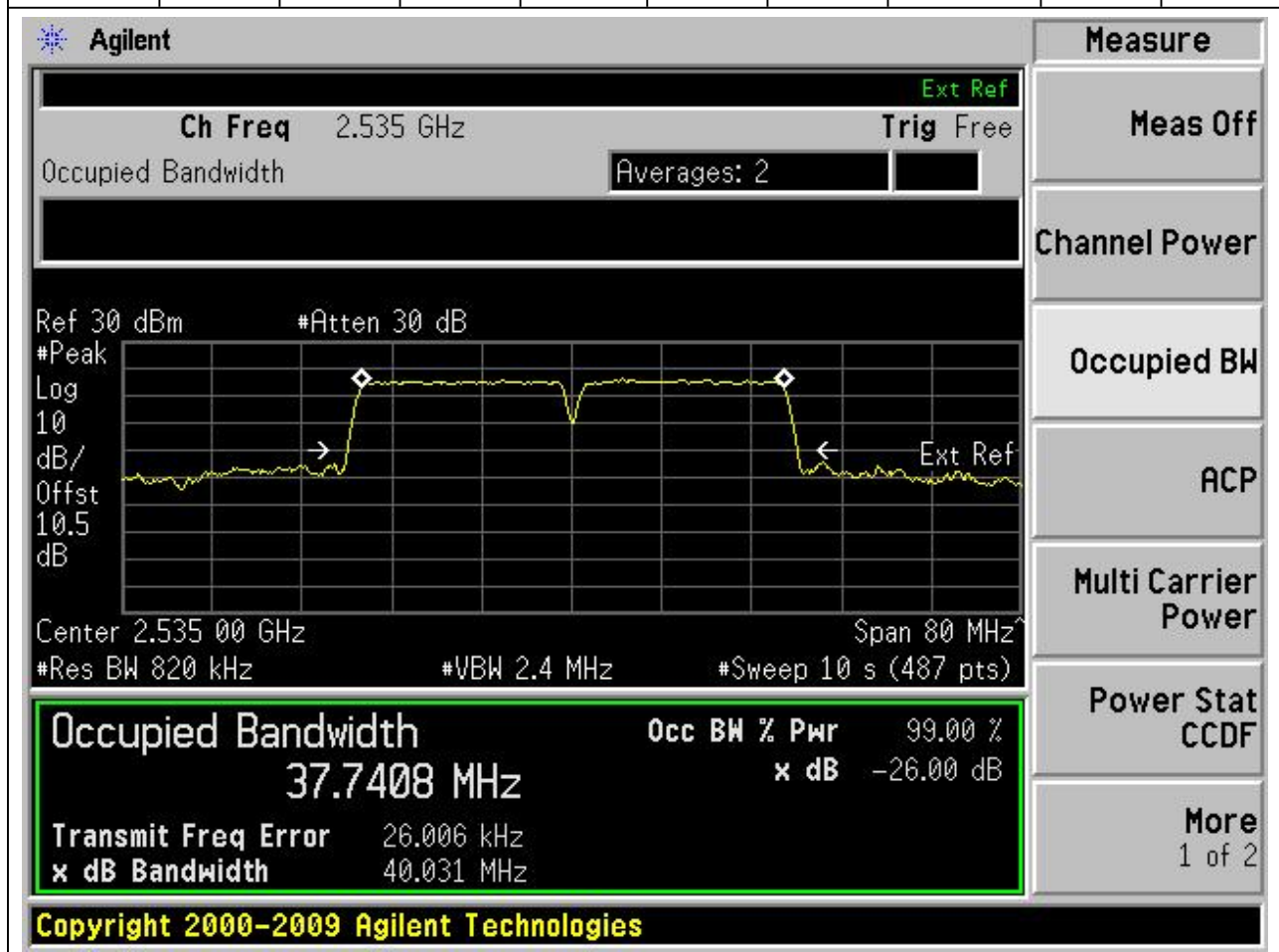
5.11. LTE-A Occupied Bandwidth_Part22-24-27(Channel:21001|21199, Bandwidth:20|20MHz, Modulation:QPSK, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2535	99	26	0.82	Peak	10.46	37.74	40.03	40	Pass



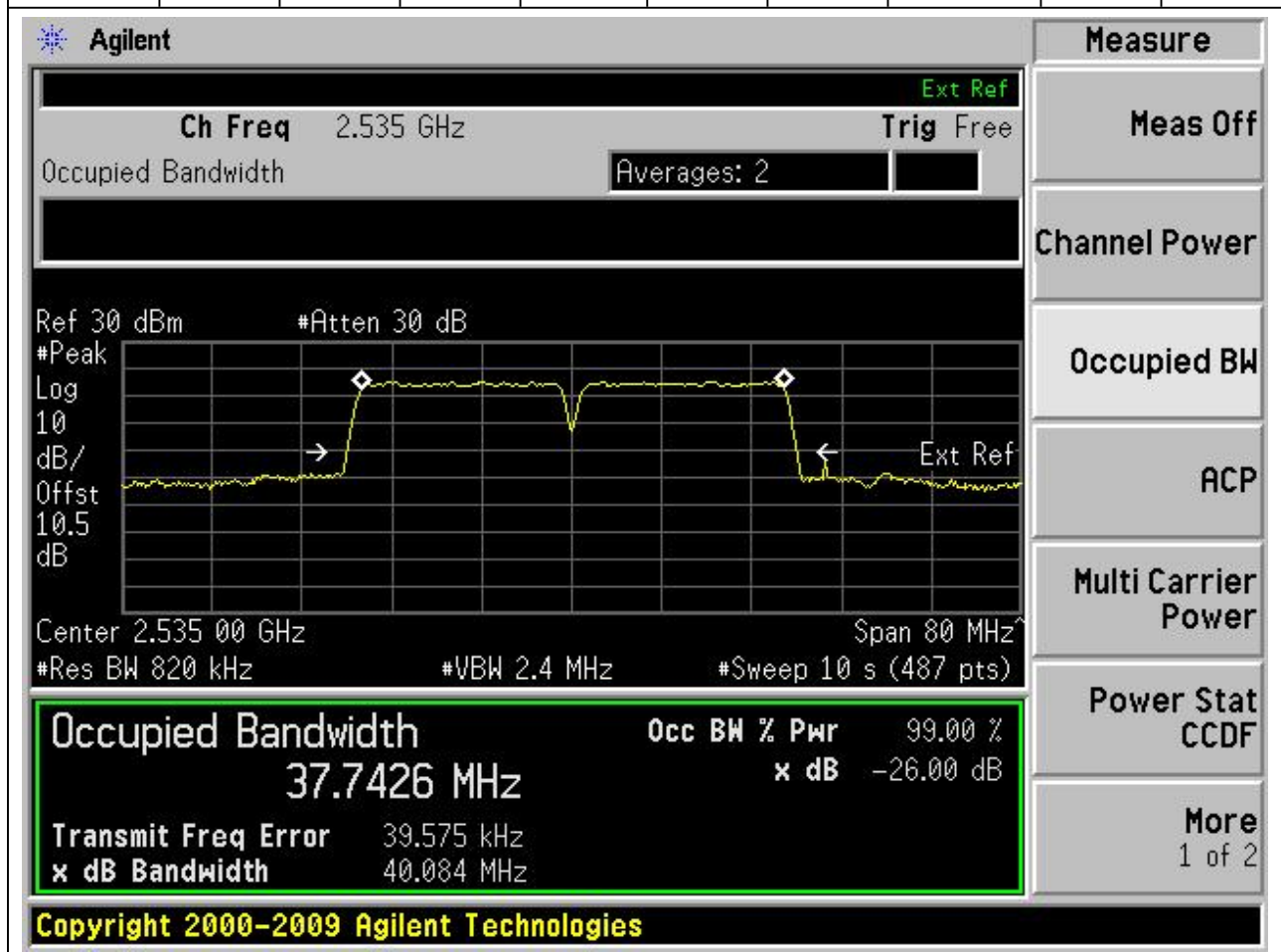
5.12. LTE-A Occupied Bandwidth_Part22-24-27(Channel:21001|21199, Bandwidth:20|20MHz, Modulation:16QAM, RB Number:Full|Full, RB Position:Low|Low)

Operator:

Test time: 2026-02-05

Instrument Type	Instrument Manufacturer	Instrument Model	Instrument Serial Number	Instrument Firmware Version
LTE Tester	Rohde&Schwarz	CMW	1201.0002k50/107917	3.7.110
Spectrum Analyzer	Agilent Technologies	E4440A	MY48250809	A.11.07

Center Frequency (MHz)	OBW Power (%)	XdB Down (dB)	RBW (MHz)	Detector	Path loss (dB)	OBW (MHz)	XdB Bandwidth (MHz)	Upper Limit (MHz)	Verdict
2535	99	26	0.82	Peak	10.46	37.74	40.08	40	Pass



END